

REPORT

FIVE-CHANNEL SCANNING RADIOMETER

QUARTERLY REPORTS 17, 18, AND 19

Contract NAS 5-757
For the Period 15 October 1964 to 15 July 1965

5 August 1965

For - National Aeronautics and Space Administration
Goddard Space Flight Center
Aeronomy and Meteorology Division
Greenbelt, Maryland 20771

GPO PRICE \$ _____

CFSTI PRICE(S) \$ _____

Hard copy (HC) 3.00

Microfiche (MF) .75

FACILITY FORM 602	N66 37324	
	(ACCESSION NUMBER)	(THRU)
	93	6
	(PAGES)	(CODE)
CR-78174	09	
(NASA CR OR TMX OR AD NUMBER)	(CATEGORY)	

ff 653 July 65

SANTA BARBARA RESEARCH CENTER



A Subsidiary of **HUGHES** Aircraft Company

SBRC

SANTA BARBARA RESEARCH CENTER

A Subsidiary of **HUGHES** Aircraft Company

75 CROMAR DRIVE, GOLETA, CALIFORNIA

FIVE-CHANNEL SCANNING RADIOMETER

QUARTERLY REPORTS 17, 18, AND 19

Contract NAS 5-757

For the Period

15 October 1964 to 15 July 1965

5 August 1965

Prepared by



F. R. Malinowski
Project Engineer

Approved by



R. F. Hummer, Head
Systems Engineering

TABLE OF CONTENTS

<u>Section</u>		<u>Page</u>
1	INTRODUCTION	1-1
2	F-5 AND F-6 MRIR FINAL CALIBRATION	2-1
3	F-2 MRIR CHECK-OF-CALIBRATION MEASUREMENTS	3-1
4	ANALYSIS OF F-2 MRIR OFFSET CIRCUITRY BEHAVIOR DURING ORBITAL SIMULATION TESTING AT NASA.	4-1
	Analysis and Results	4-2
	Basis	4-2
	Gain Correction	4-2
	Target Emissivity and Radiation Correction	4-4
	Space Temperature Calibration Point	4-6
5	HIGH-VACUUM, HIGH-TEMPERATURE, UV RADIATION TESTING OF THE 14- TO 16-MICRON FILTER	5-1
6	F-5 MRIR CHECK-OF-CALIBRATION MEASUREMENTS (BEFORE AND AFTER SCAN MIRROR CLEANING)	6-1
7	FAILURE REPORTING	7-1

Section 1
INTRODUCTION

This report covers the 17th, 18th, and 19th quarterly reporting periods, from 15 October 1964 to 15 July 1965, of the Five-Channel Scanning Radiometer Program under Contract NAS 5-757 and NAS 5-3648.

During this reporting period calibration of the F-5 and F-6 MRIR's was completed.

Check-of-calibration measurements were made on the F-2 MRIR after the radiometer had been subjected to orbital simulation testing at NASA. The check-of-calibration data obtained were in good agreement with the final calibration data that had been obtained approximately a year earlier, prior to the shipment of the radiometer to NASA.

An analysis on the behavior of the F-2 MRIR offset circuitry during orbital simulation testing at NASA was made.

High-vacuum, high-temperature, UV radiation testing was completed on a sample 14- to 16-micron filter. No degradation in filter transmission characteristics was detected as a result of this environmental exposure.

Check-of-calibration measurements were made on the F-5 MRIR when the radiometer was returned to SBRC for mirror cleaning. The check-of-calibration measurements were made before and after mirror cleaning.

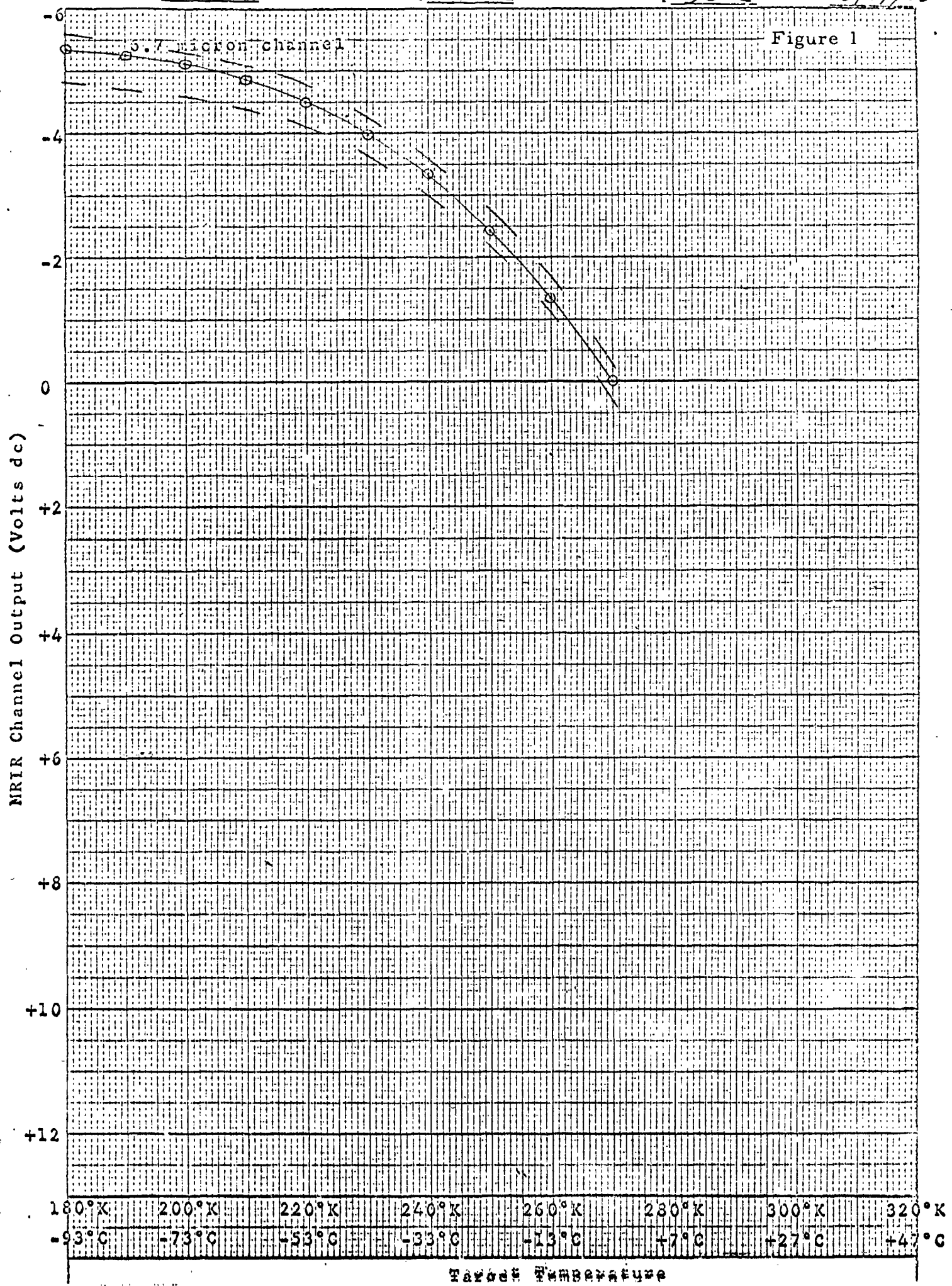
Section 2**F-5 AND F-6 MRIR FINAL CALIBRATION**

The final Primary Integrated Spectral Response (calibration) measurements were performed on the F-5 and F-6 MRIR's. The calibration curves obtained from these measurements for five radiometer temperatures are shown in Figures 1 through 40. The dash lines shown in these figures represent the limits of allowable variation for radiometer temperature variation over a 0°C to 50°C temperature range.

MRIR Calibration Curves (D)

System # F-5 Scanner Temp 50°C Module Temp 50°C Date 3/19/65

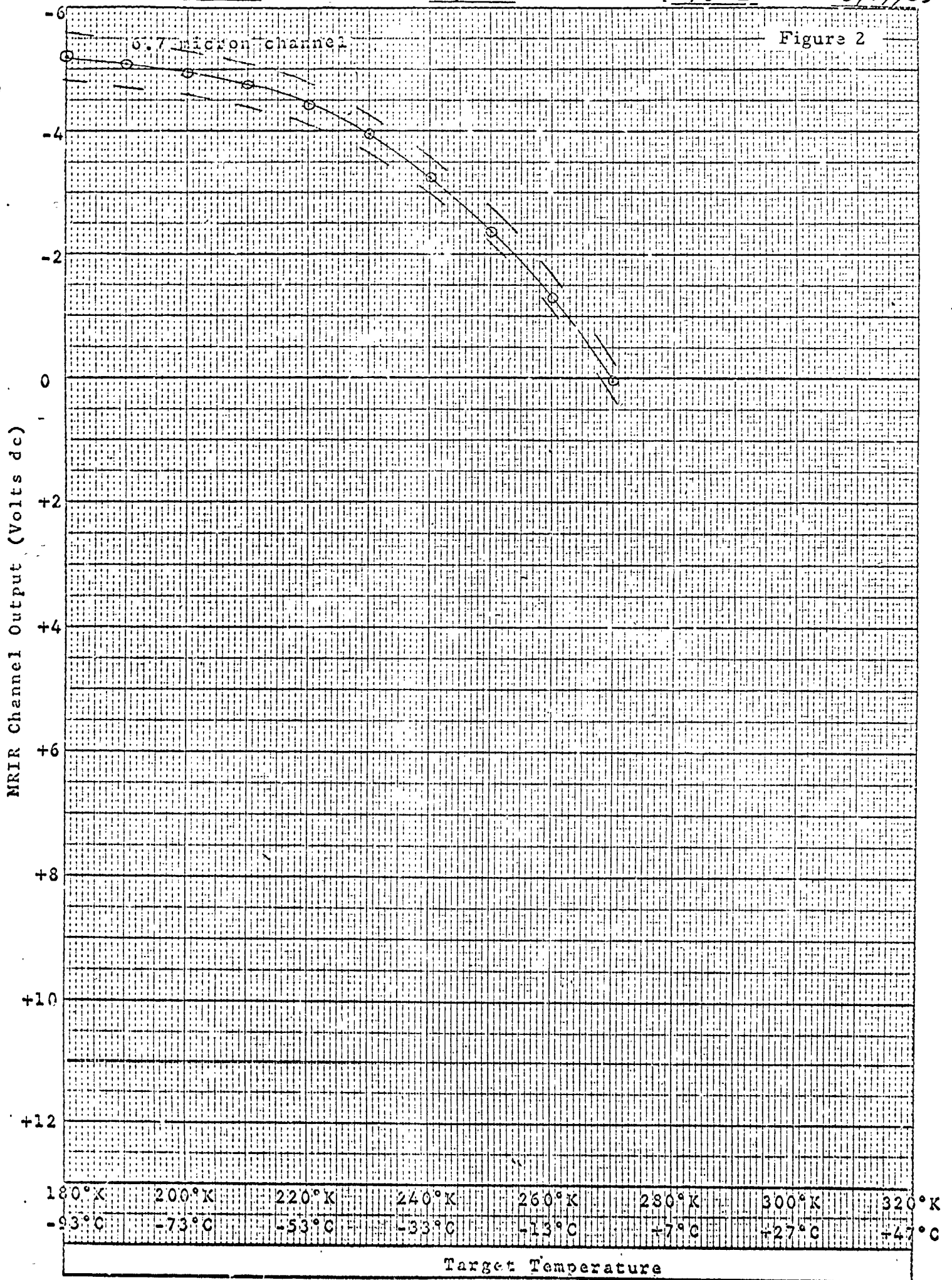
Figure 1



MRIR Calibration Curves (D)

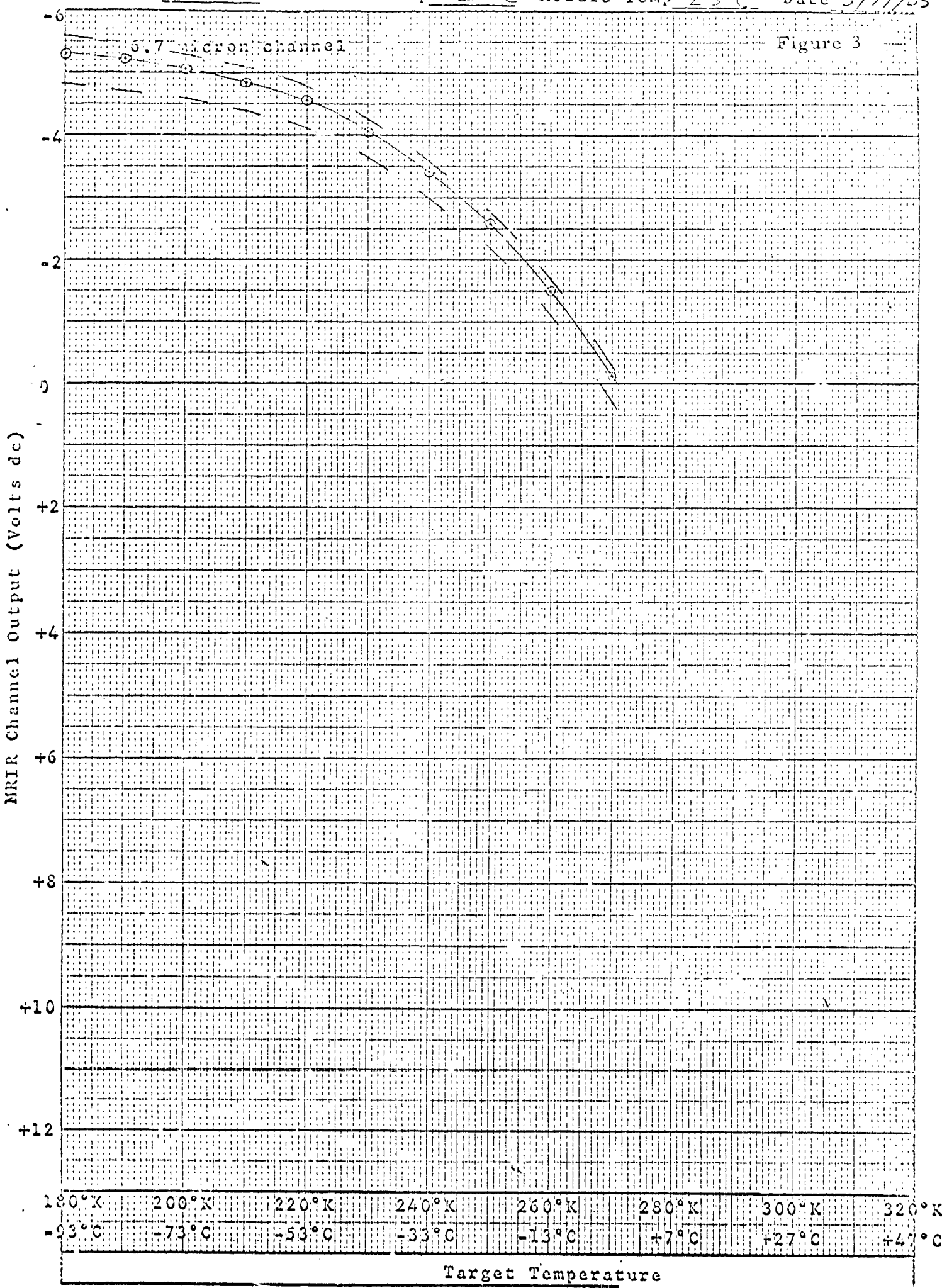
System # F-5 Scanner Temp 40°C Module Temp 40°C Date 3/19/65

Figure 2



REPRODUCED FROM THE ORIGINAL DOCUMENT. THE ORIGINAL DOCUMENT IS THE PROPERTY OF THE U.S. GOVERNMENT AND IS NOT TO BE REPRODUCED OR TRANSMITTED IN ANY FORM OR BY ANY MEANS, ELECTRONIC OR MECHANICAL, INCLUDING PHOTOCOPYING, RECORDING, OR BY ANY INFORMATION STORAGE AND RETRIEVAL SYSTEM.

MRIR Calibration Curves (D) (23)
 System # F-5 Scanner Temp 25°C Module Temp 25°C Date 3/11/65



MADE IN U.S.A.
 N. S. S. 765
 20 X 20 PER INCH

MIRIR Calibration Curves (D)

(28)

System # F-5 Scanner Temp 10°C Module Temp 10°C Date 3/19/65

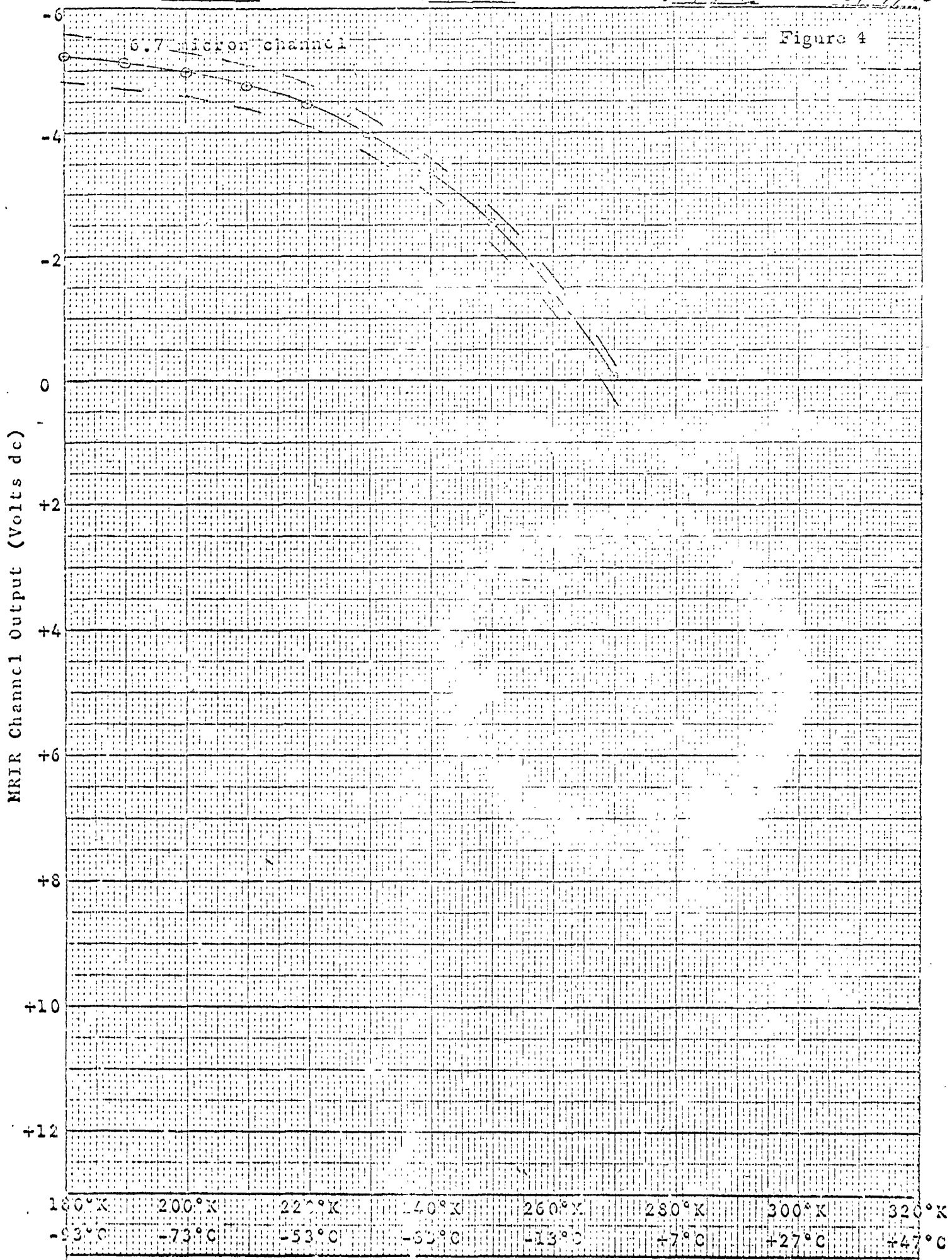
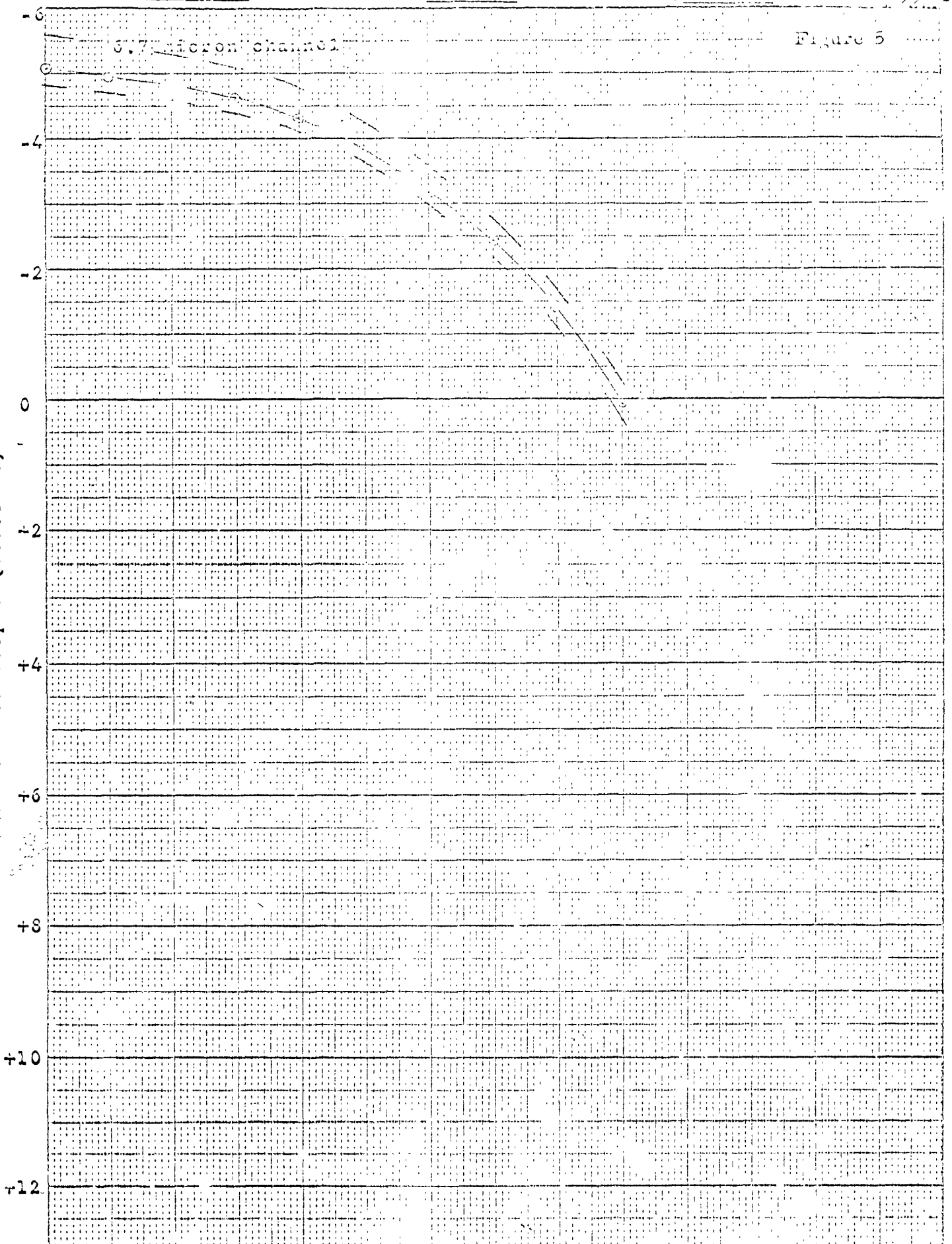


Figure 5

6.7 micron channel

MNR Channel Output (Volts dc)



Target Temperature

20-20 (USE) MNR IN U. S. A.

NRIR Calibration Curves (D)

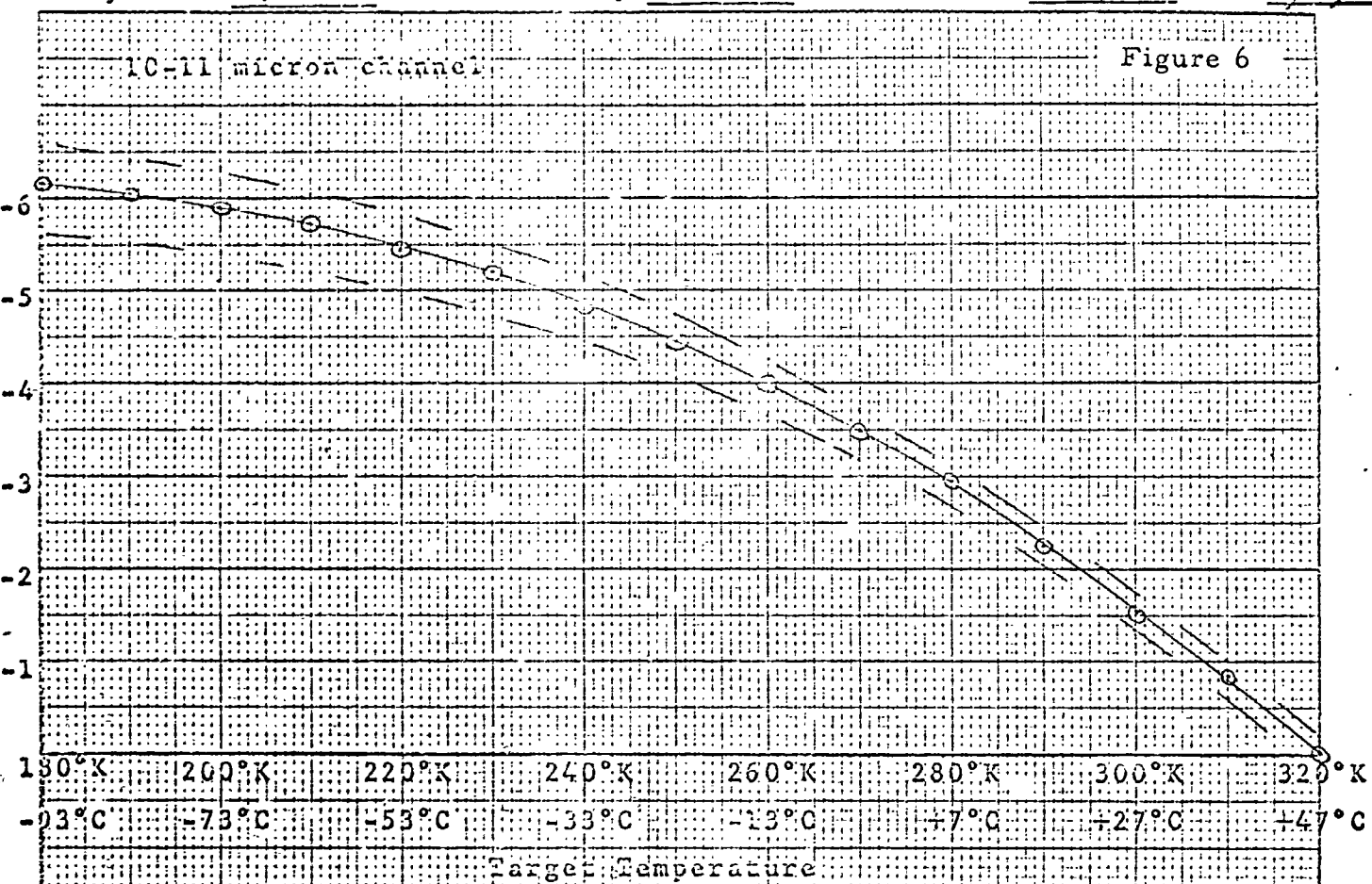
29

System # F-5 Scanner Temp 50°C Module Temp 50°C Date 3/19/65

10-11 micron channel

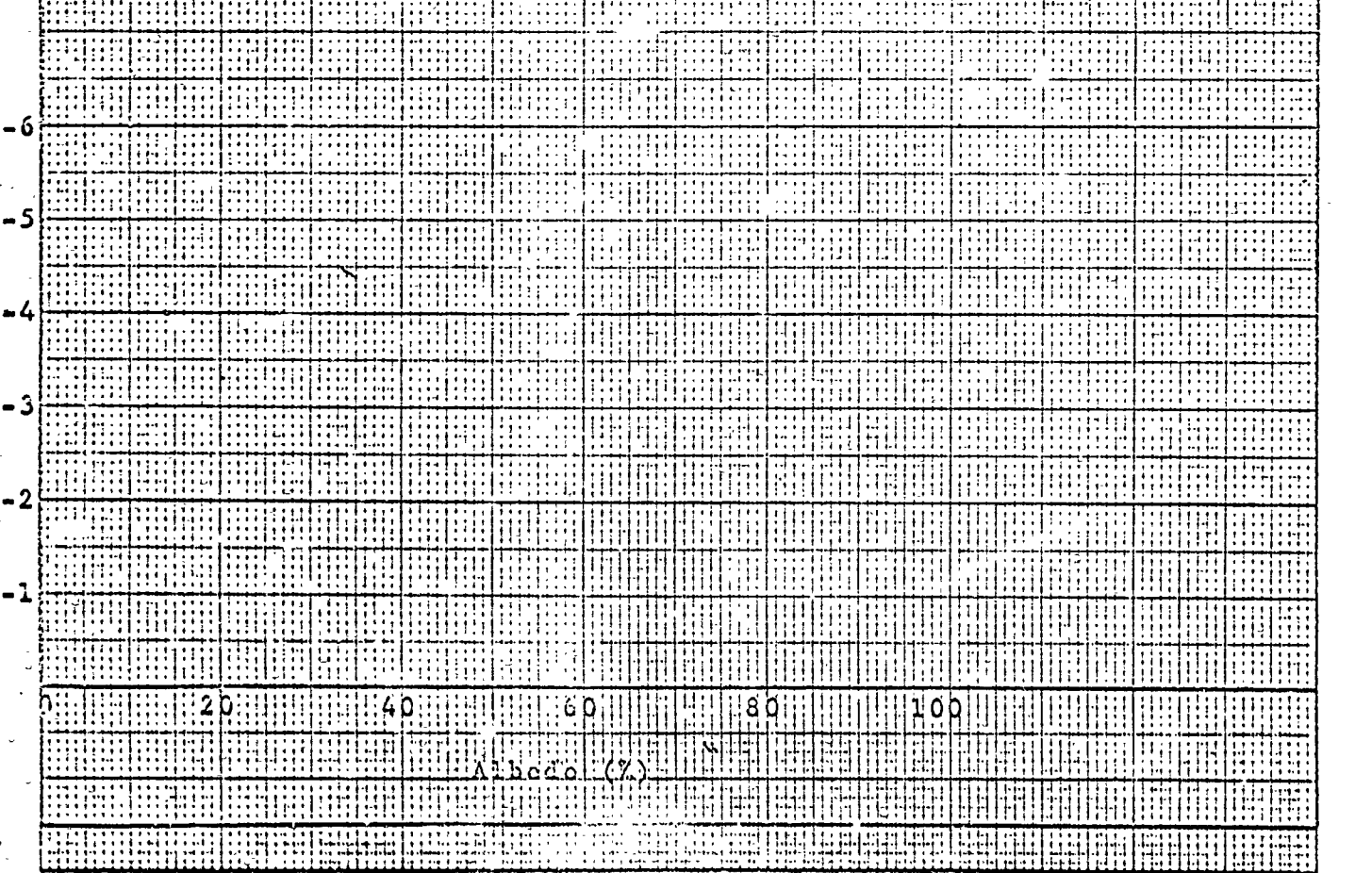
Figure 6

NRIR Channel Output (Volts dc)



0.55-0.85 micron channel

NRIR Channel Output (- Volts dc)

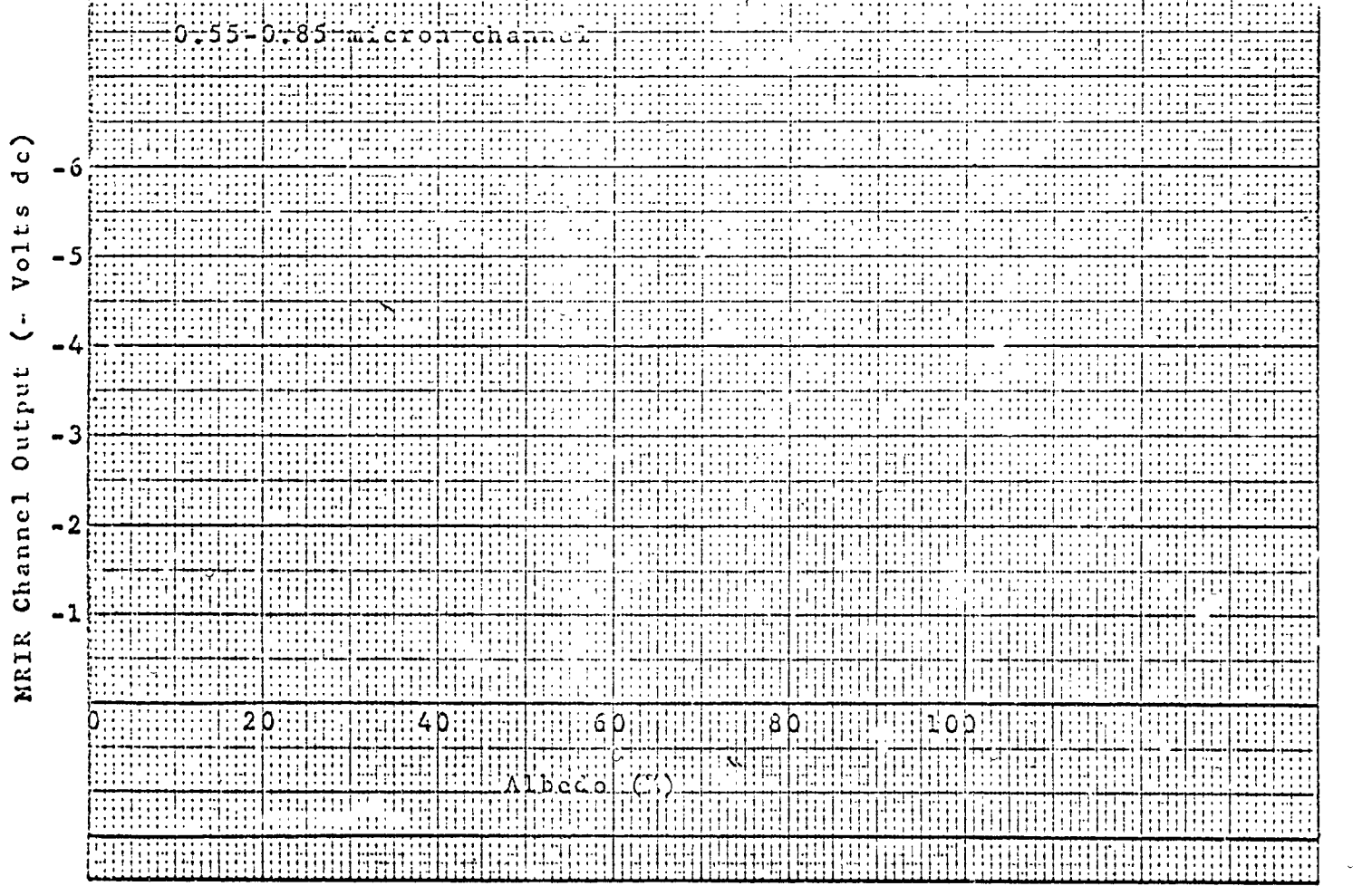
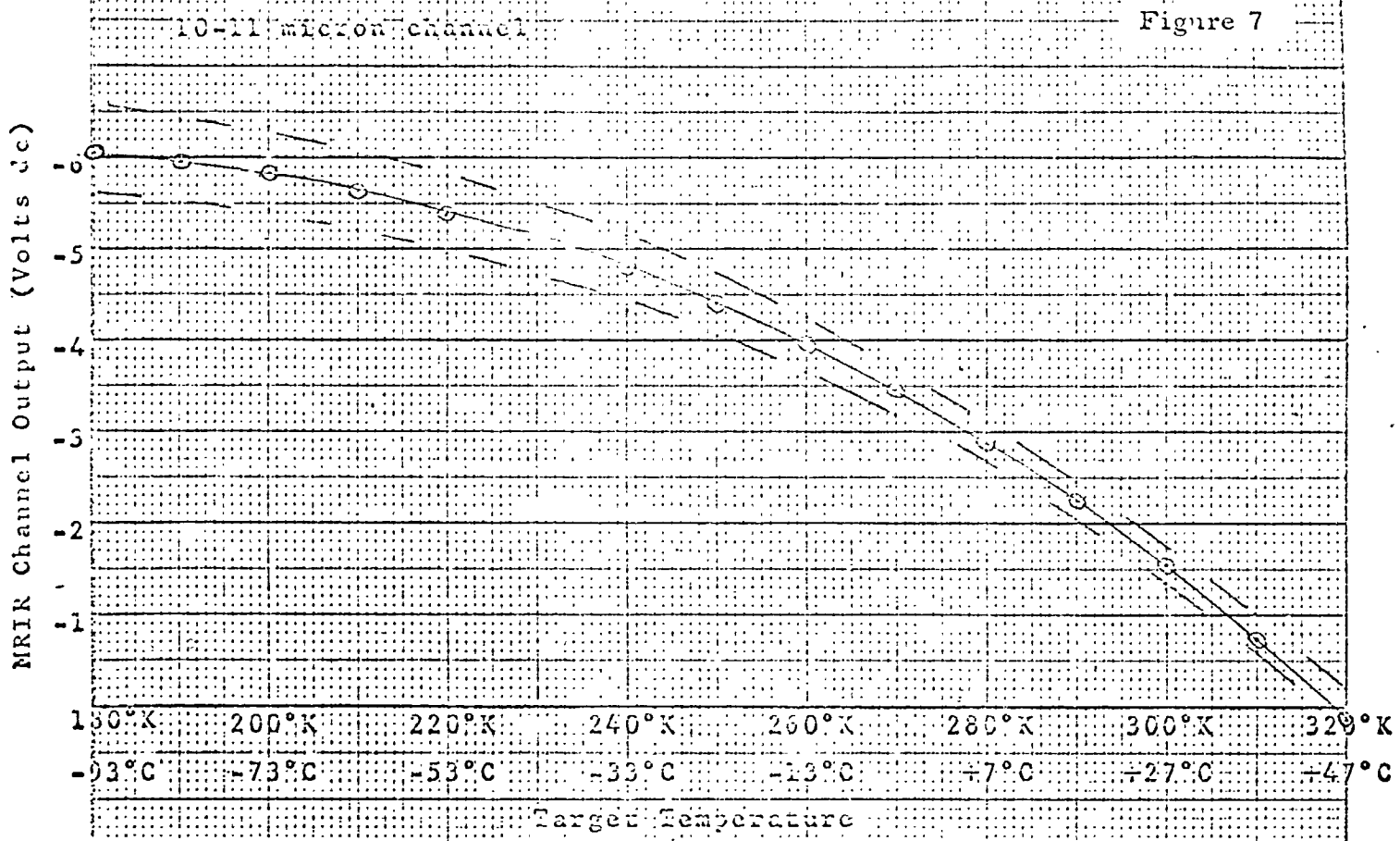


JENNE DILLIGEN CO.
 MADE IN U. S. A.
 MODEL DR-200
 20 X 20 PER INCH

MRIR Calibration Curves (D)

(37)

System # F-5 Scanner Temp 45°C Module Temp 45°C Date 3/19/66

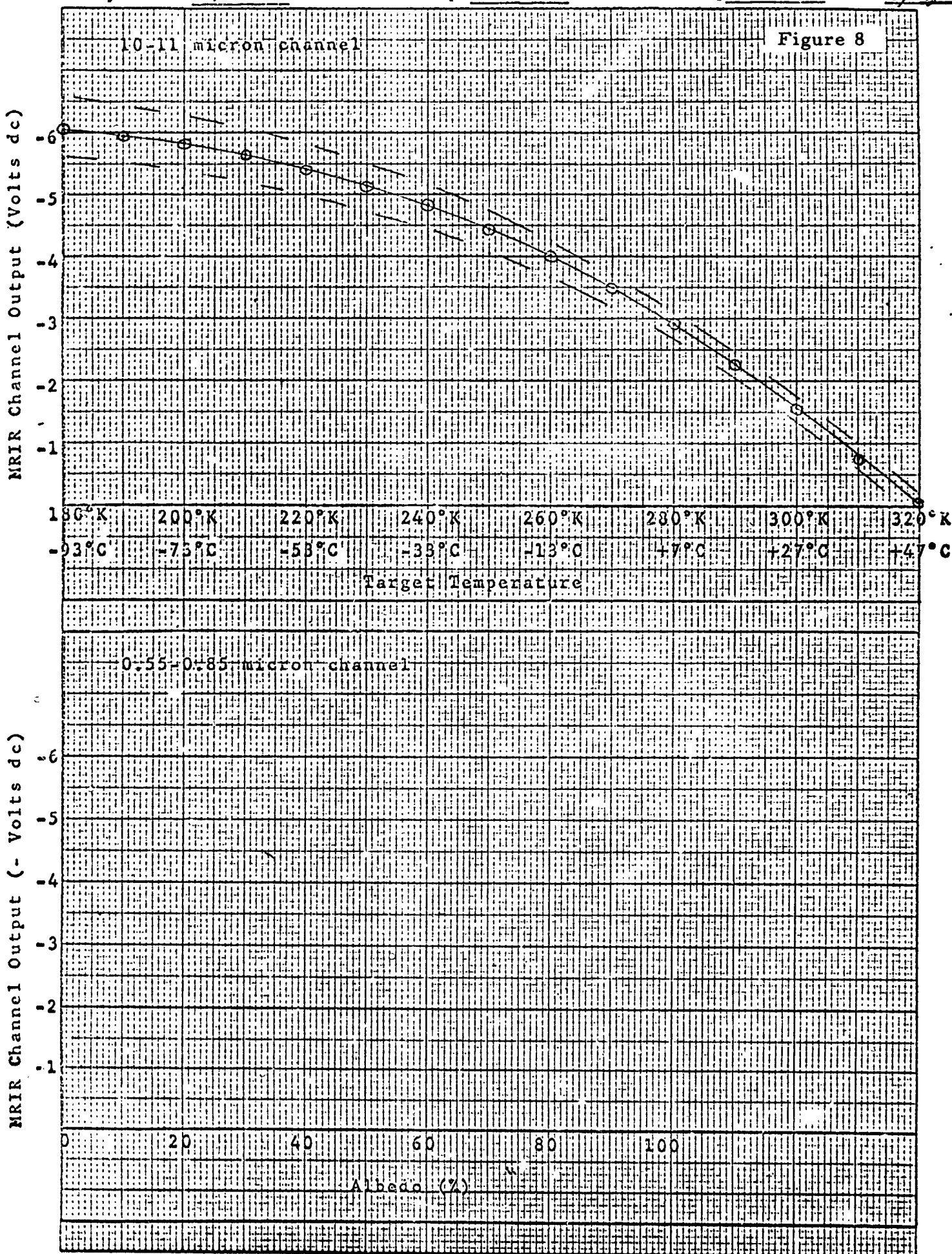


NE D. ENC
 MADE IN U. S. A.
 DR-20
 20 X 20 PER INCH

MRIR Calibration Curves (D)

(2B)

System # F-5 Scanner Temp 25°C Module Temp 25°C Date 3/19/6



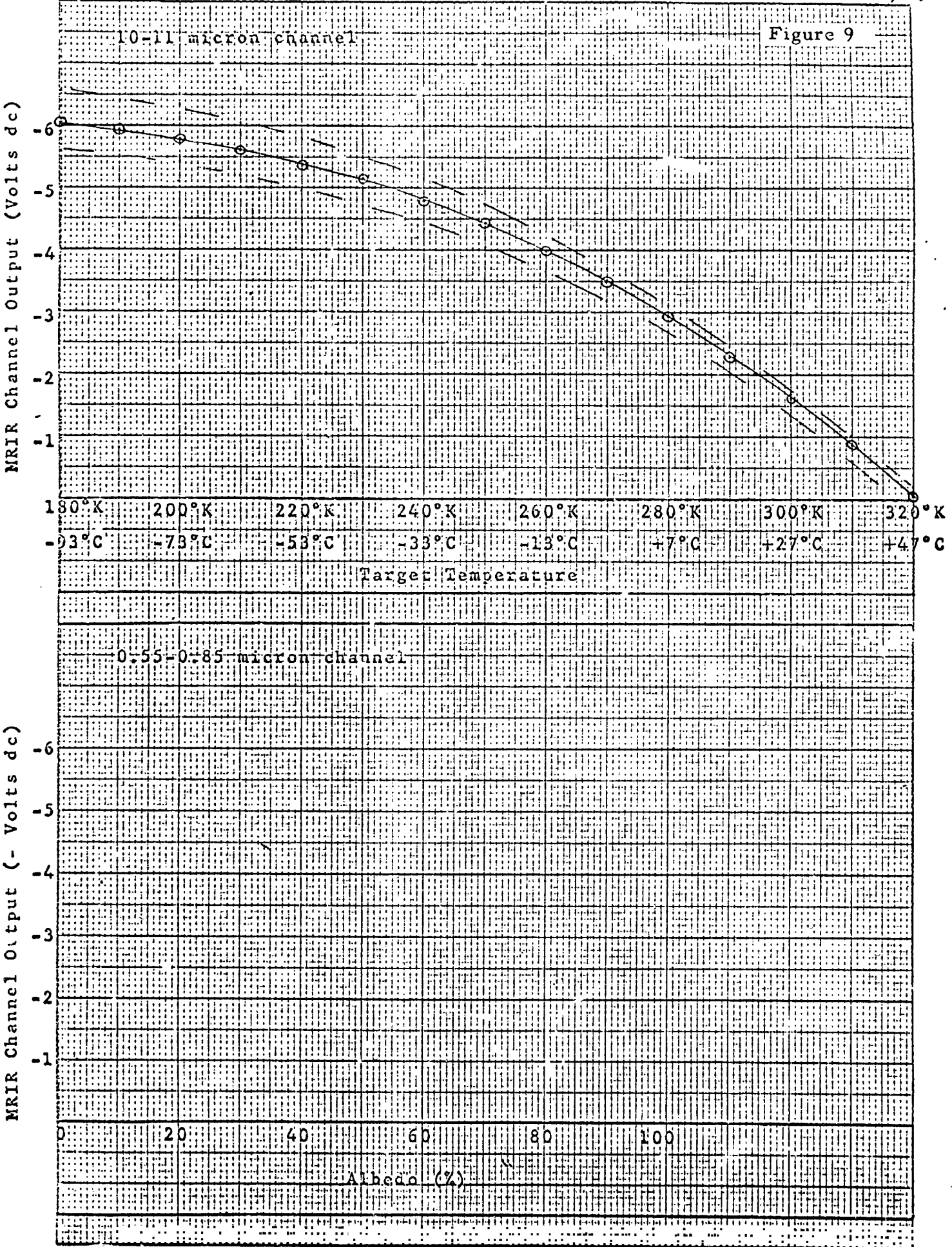
GEORGE D. ... INC.
 MADE IN U. S. A.

NOT FOR ...
 20 X 20 PER INCH

MRIR Calibration Curves (D)

(29)

System # F-5 Scanner Temp 10°C Module Temp 10°C Date 3/19/65

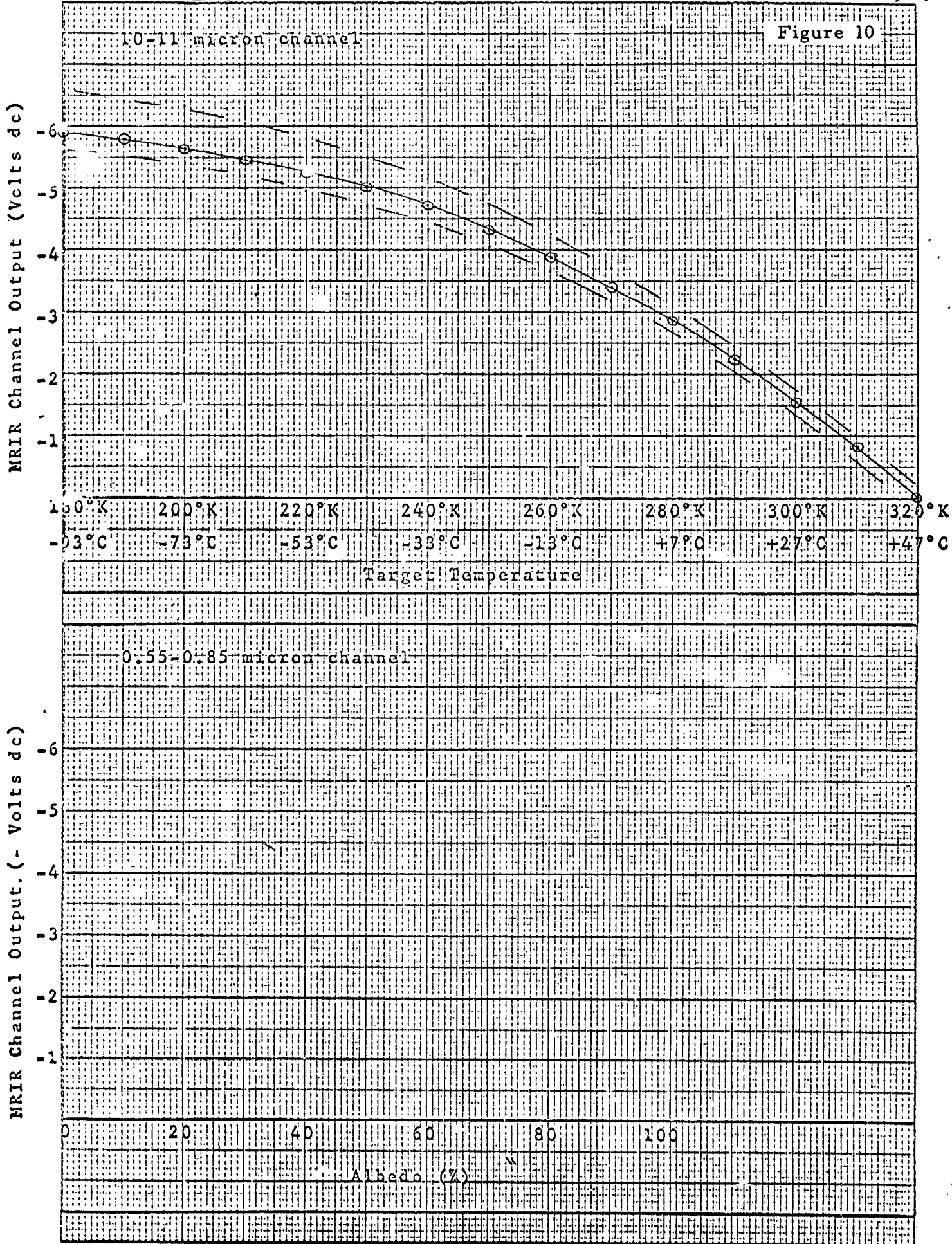


MODEL OF...
 MADE IN U. S. A.

MODEL OF...
 MADE IN U. S. A.

MRIR Calibration Curves (D)

System # F-5 Scanner Temp 0°C Module Temp 0°C Date 3/19/6



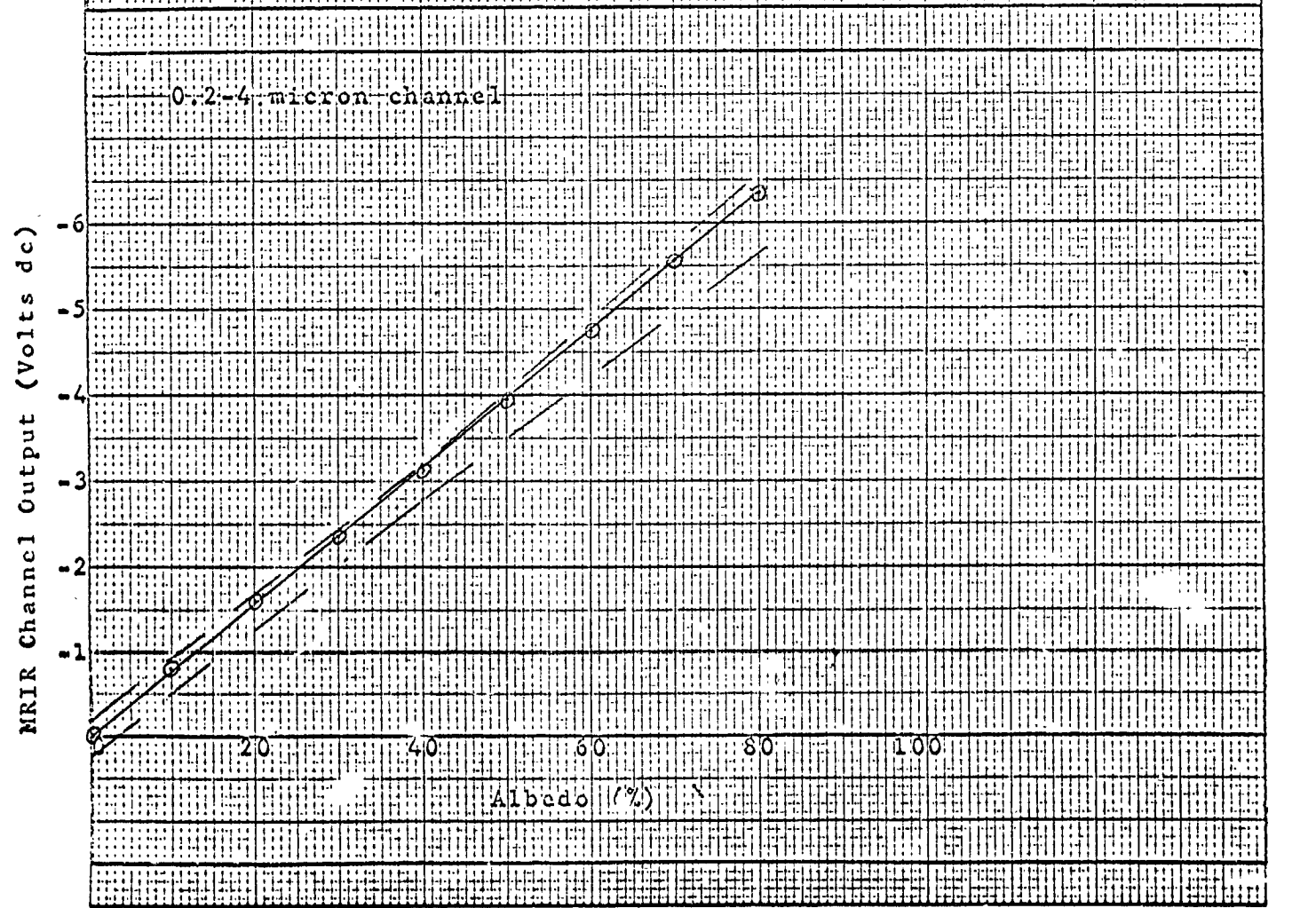
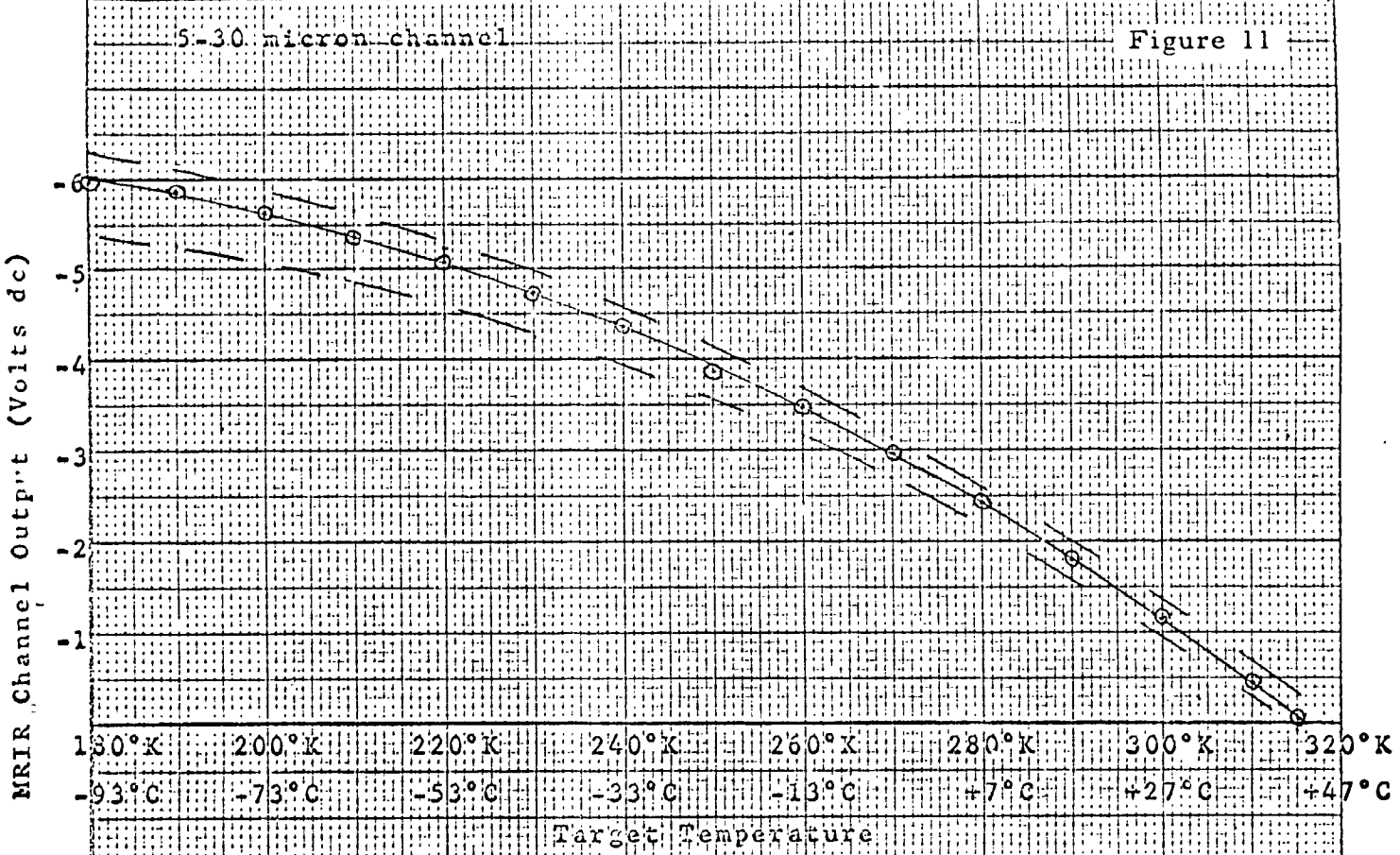
THE DESIGN CENTER
 MADE IN U. S. A.

NO. MR-20 ZGE API
 20 X 20 PER INCH

MRIR Calibration Curves (D)

(31)

System # F-5 Scanner Temp 50°C Module Temp 50°C Date 3/19/65



LOBBE DESIGN CO. MADE IN U. S. A.
 NITENOR-20 DRETZGER GRAPH PAPER 20 X 20 PER INCH

MRIR Calibration Curves (b)

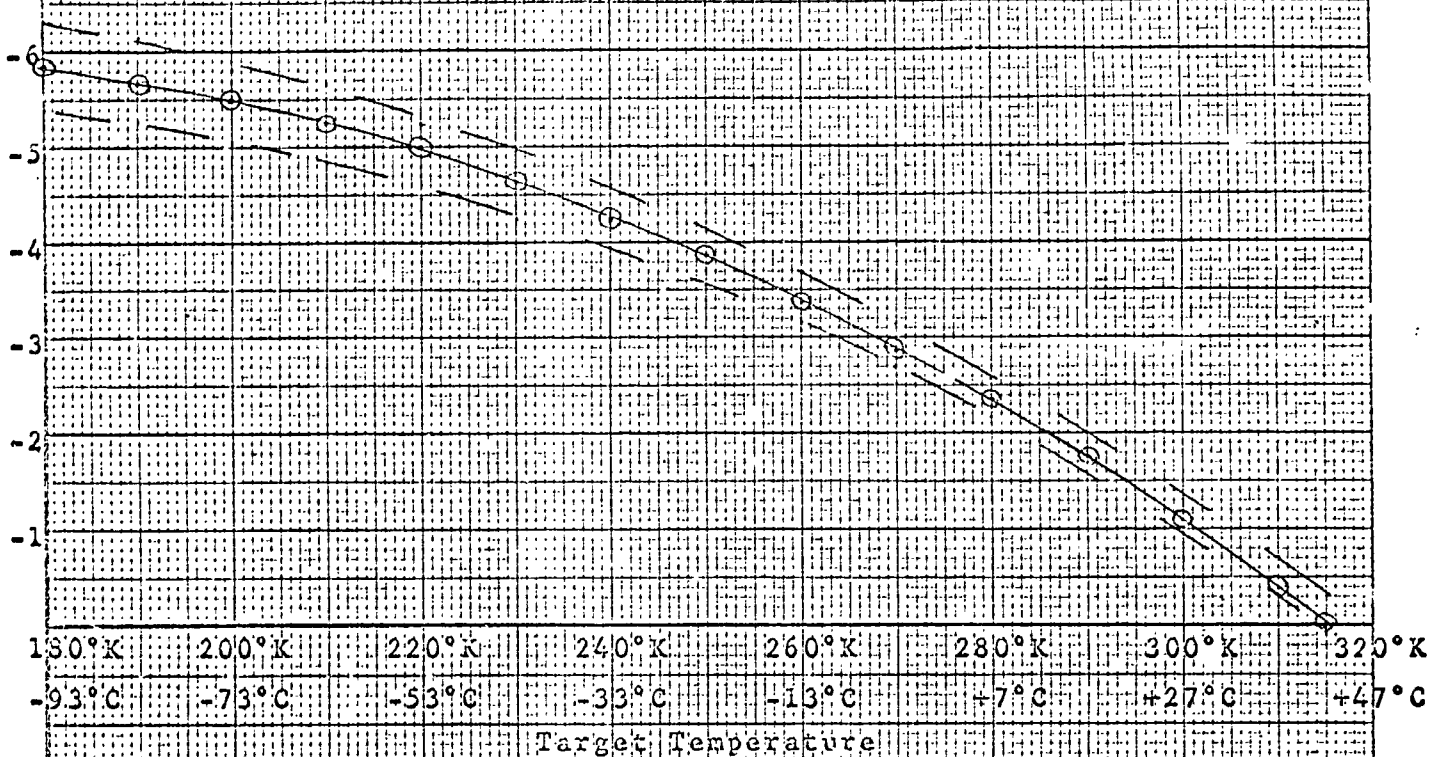
(3)

System # F-5 Scanner Temp 40°C Module Temp 40°C Date 3/19/65

5-30 micron channel

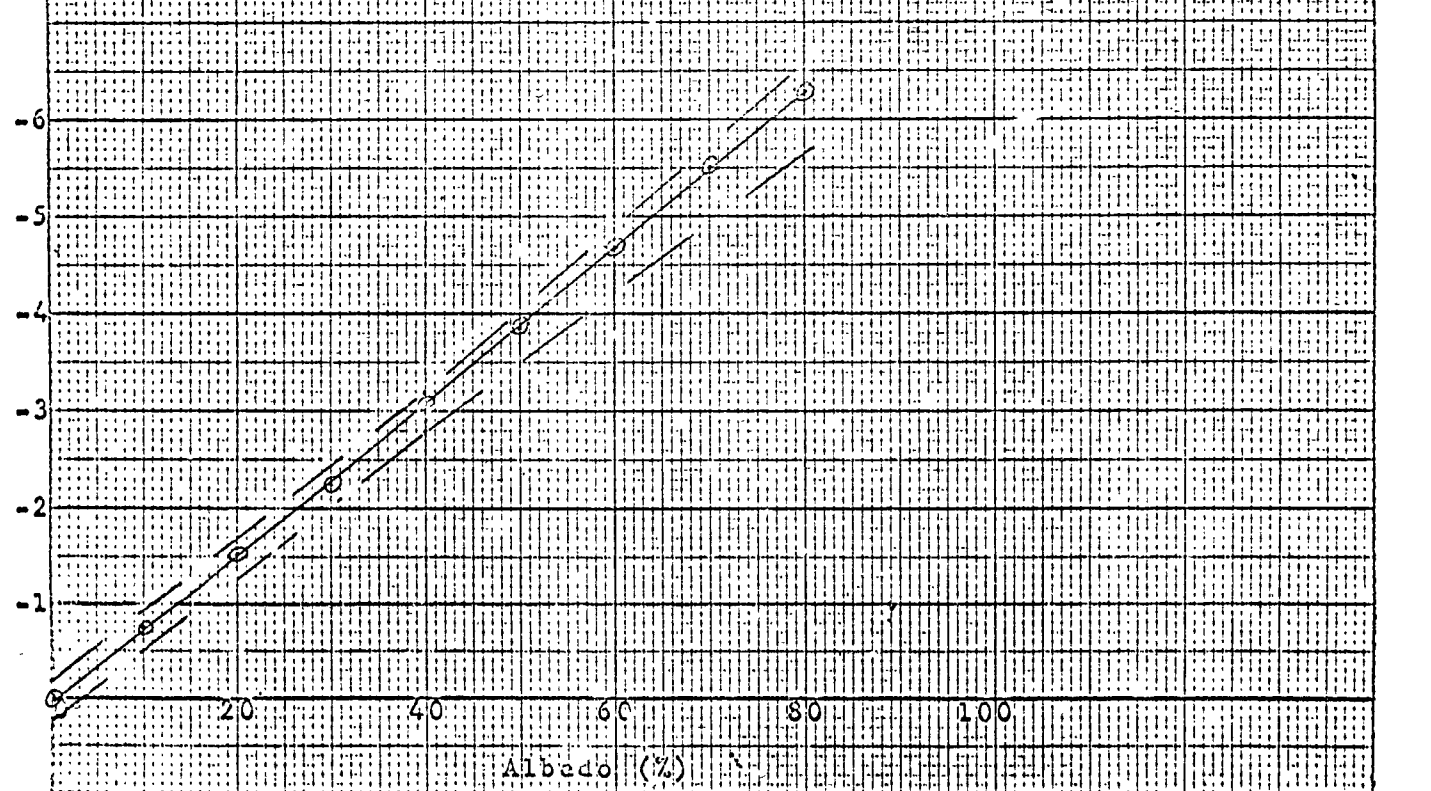
Figure 12

MRIR Channel Output (Volts dc)



0.2-4 micron channel

MRIR Channel Output (Volts dc)



Albedo (%)

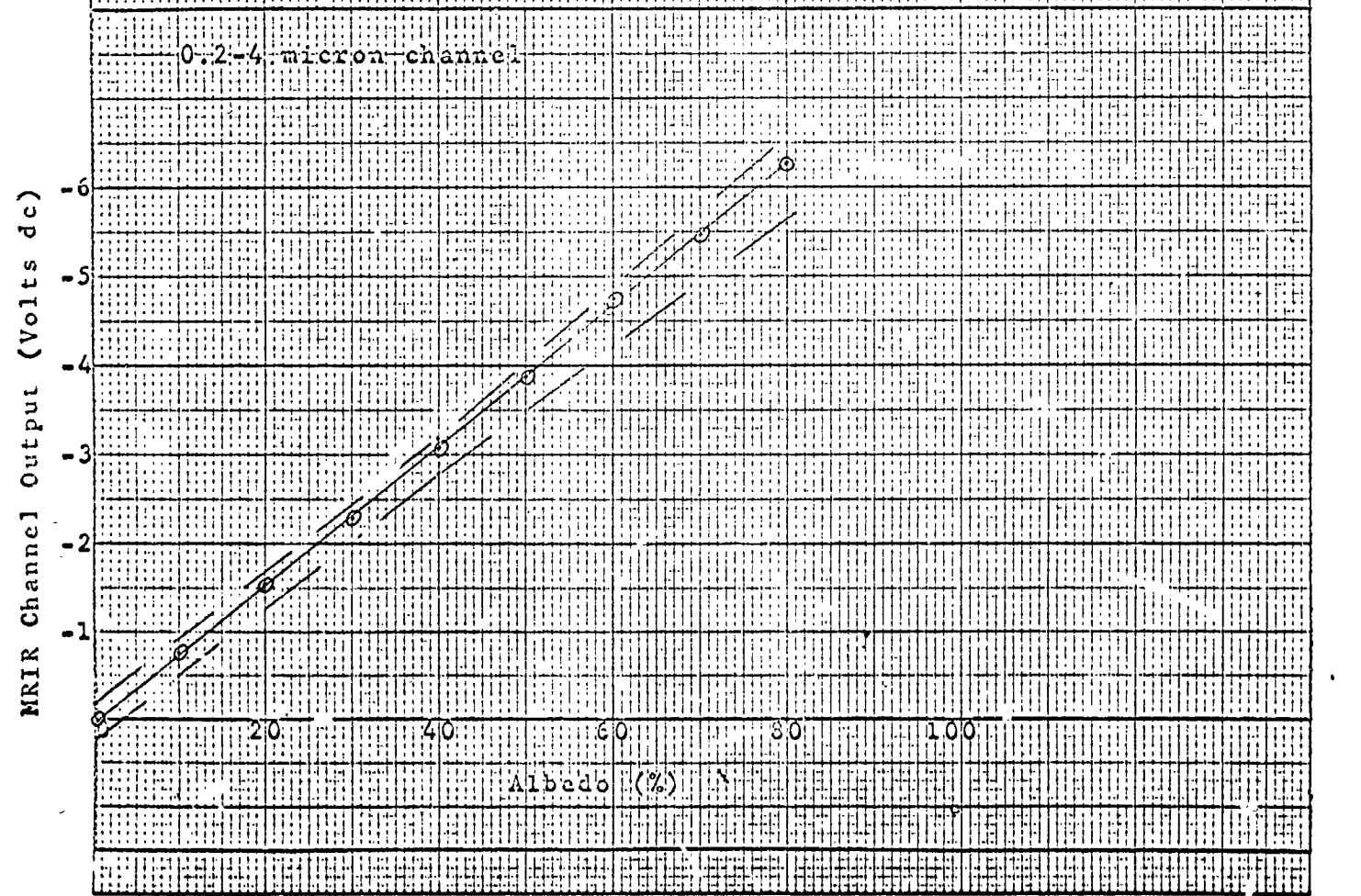
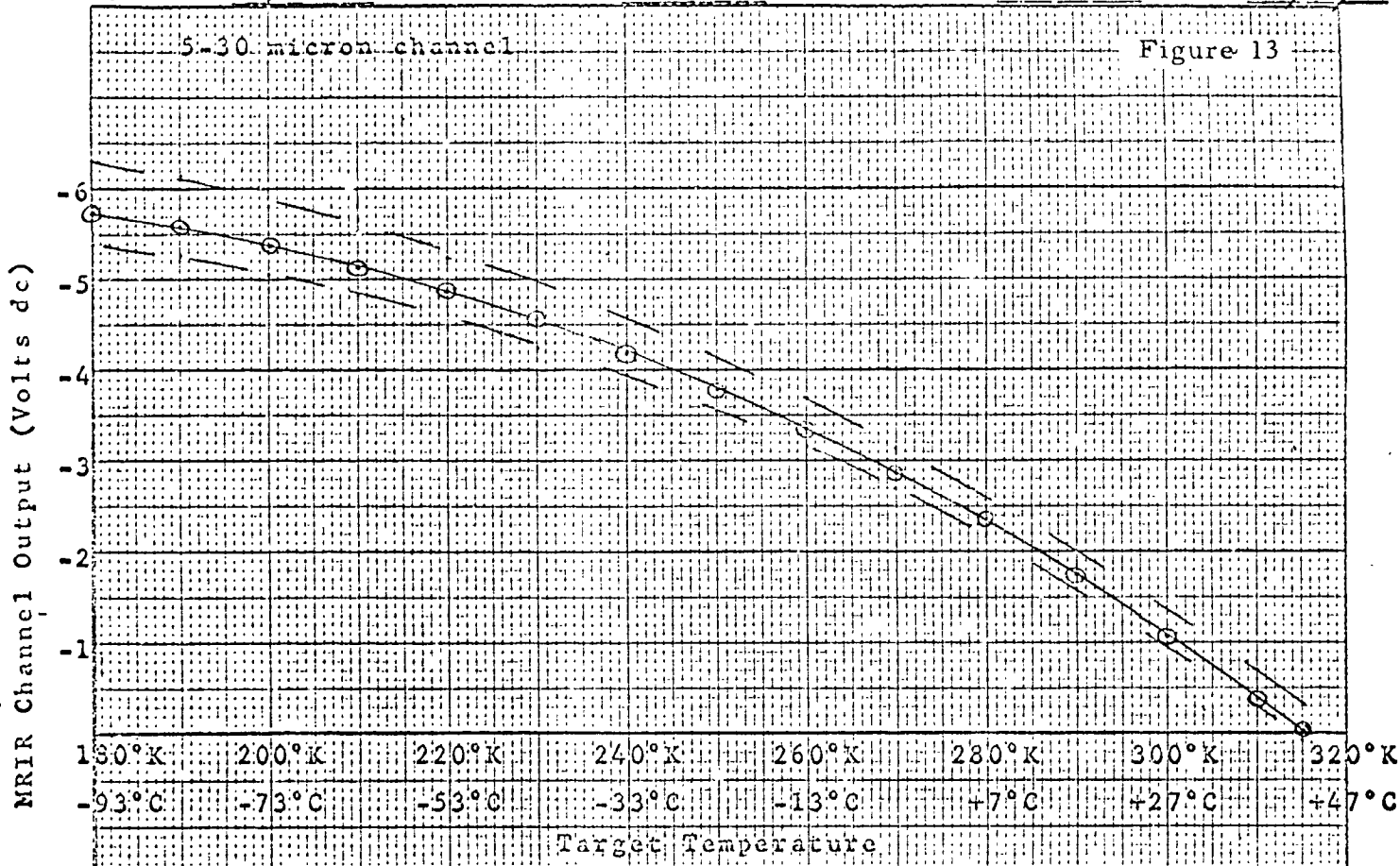
EUGENE DIEZGEN CO.
MADE IN U. S. A.

NATIONAL BUREAU OF STANDARDS
20 X 20 PER INCH

MRIR Calibration Curves (D)

(33)

System # *F-5* Scanner Temp *25°C* Module Temp *25°C* Date *3/17/65*



EUGENE DIETZGEN CO. MADE IN U. S. A.

NO. SW-26-DIETZGEN GRAPH PAPER 20 X 20 PER INCH

MRIR Calibration Curves (D)

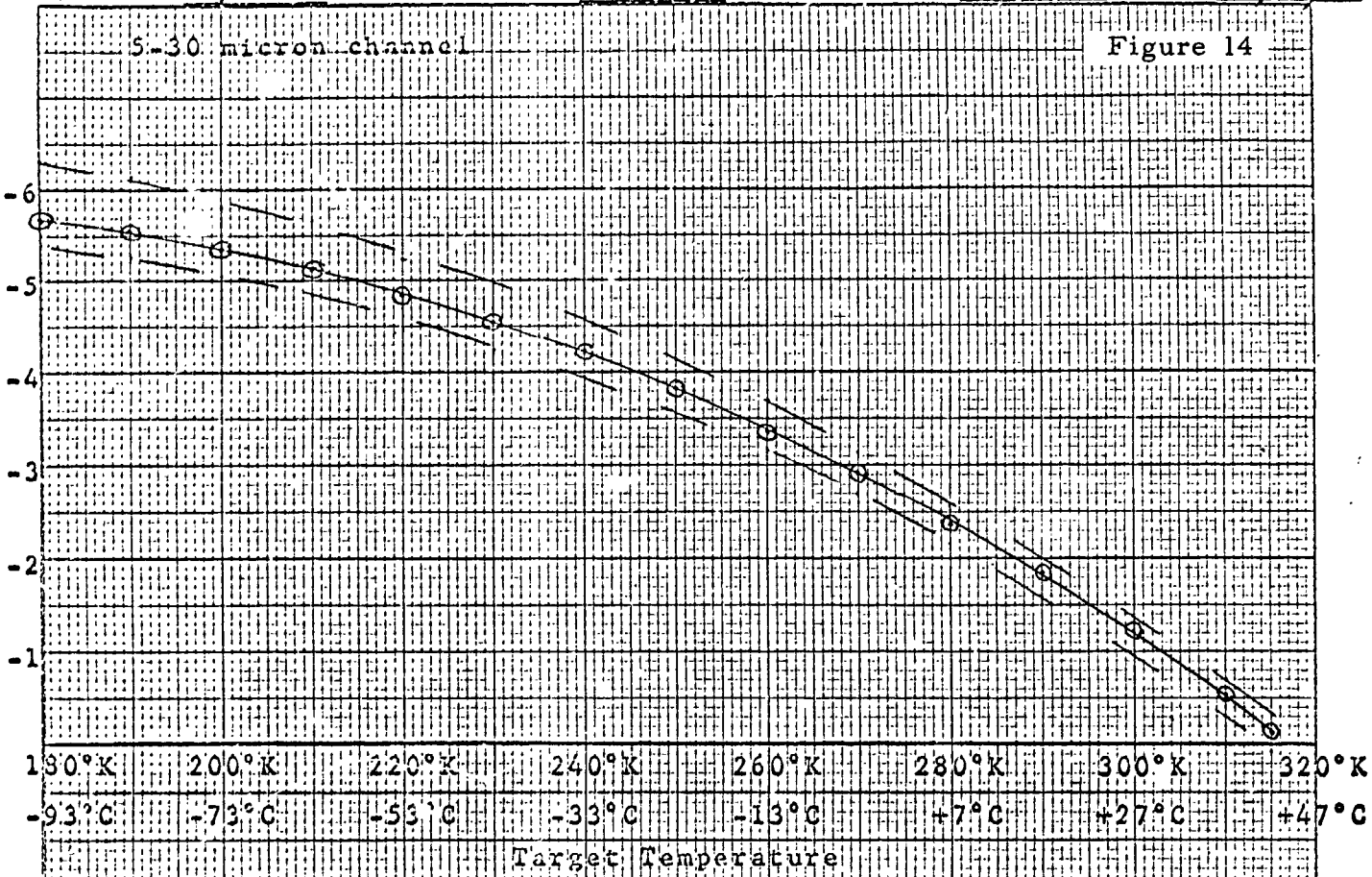
(34)

System # F-5 Scanner Temp 10°C Module Temp 10°C Date 3/19/65

5-30 micron channel

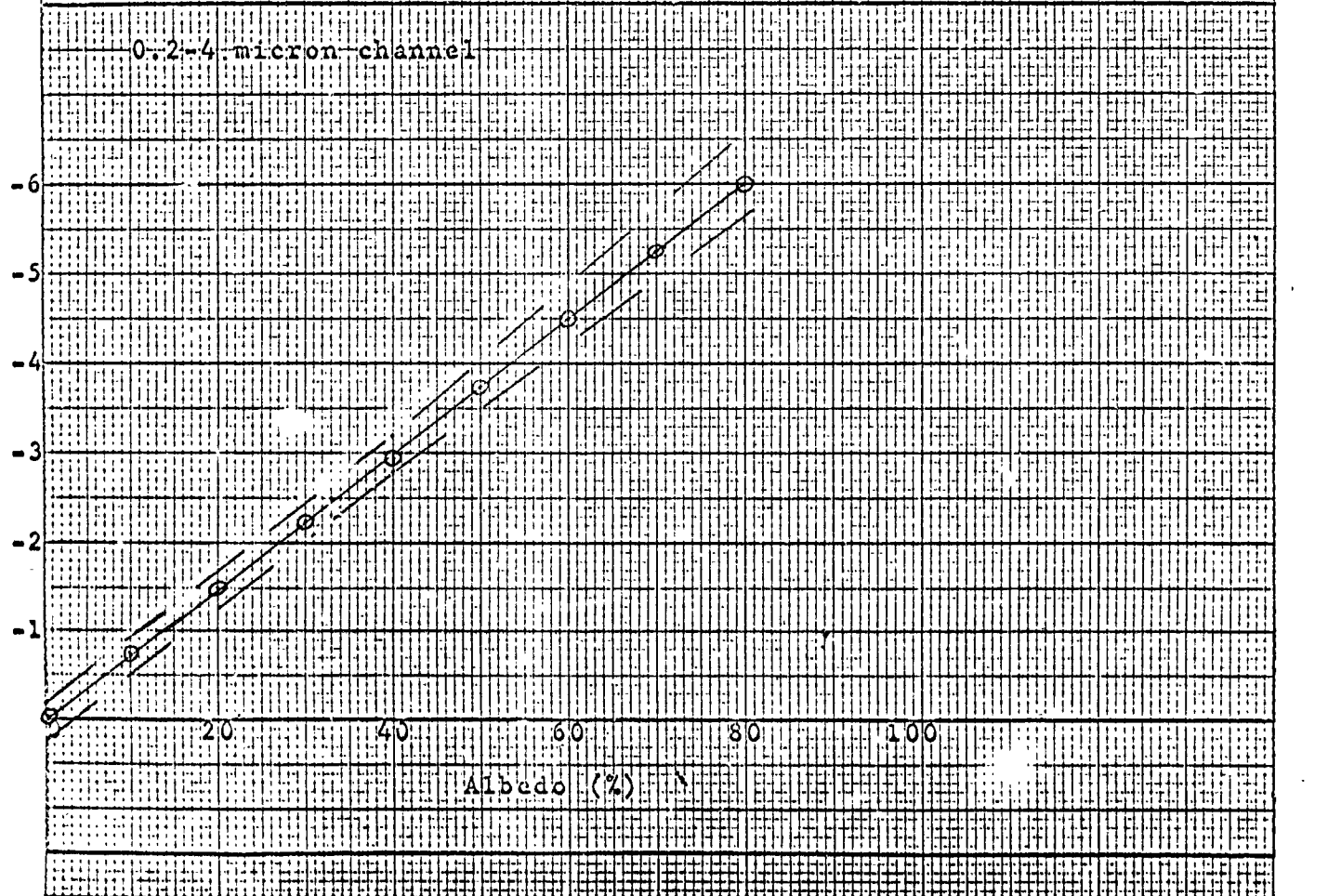
Figure 14

MRIR Channel Output (Volts dc)



0.2-4 micron channel

MRIR Channel Output (Volts dc)



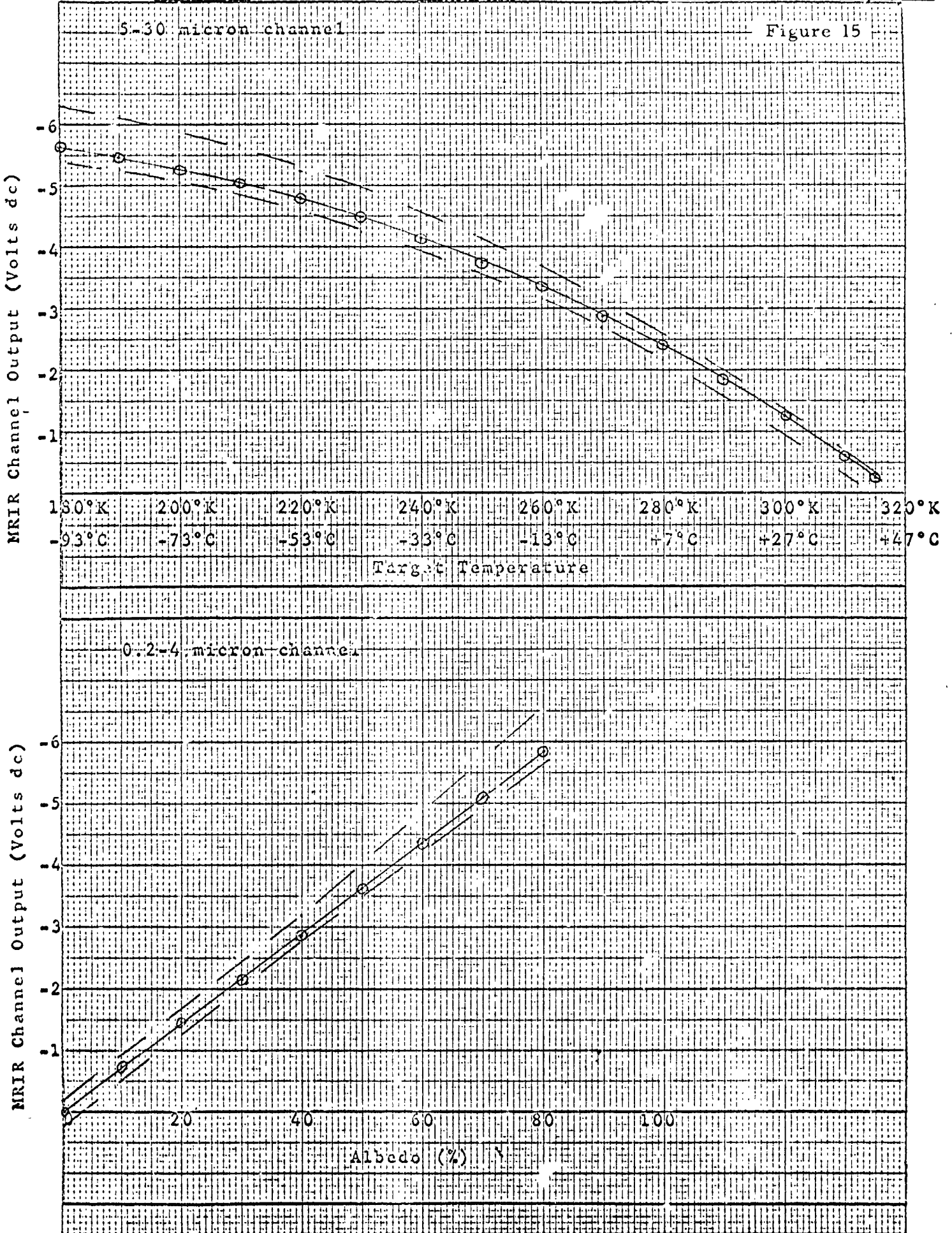
LOUISIANA INSTRUMENT CO.
MADE IN U. S. A.

NO. JR-20 2 1/2" X 2 1/2" GRAPH PAPER
20 X 20 PER INCH

MRIR Calibration Curves (D)

(35)

System # F-5 Scanner Temp 0°C Module Temp 0°C Date 3/11/65

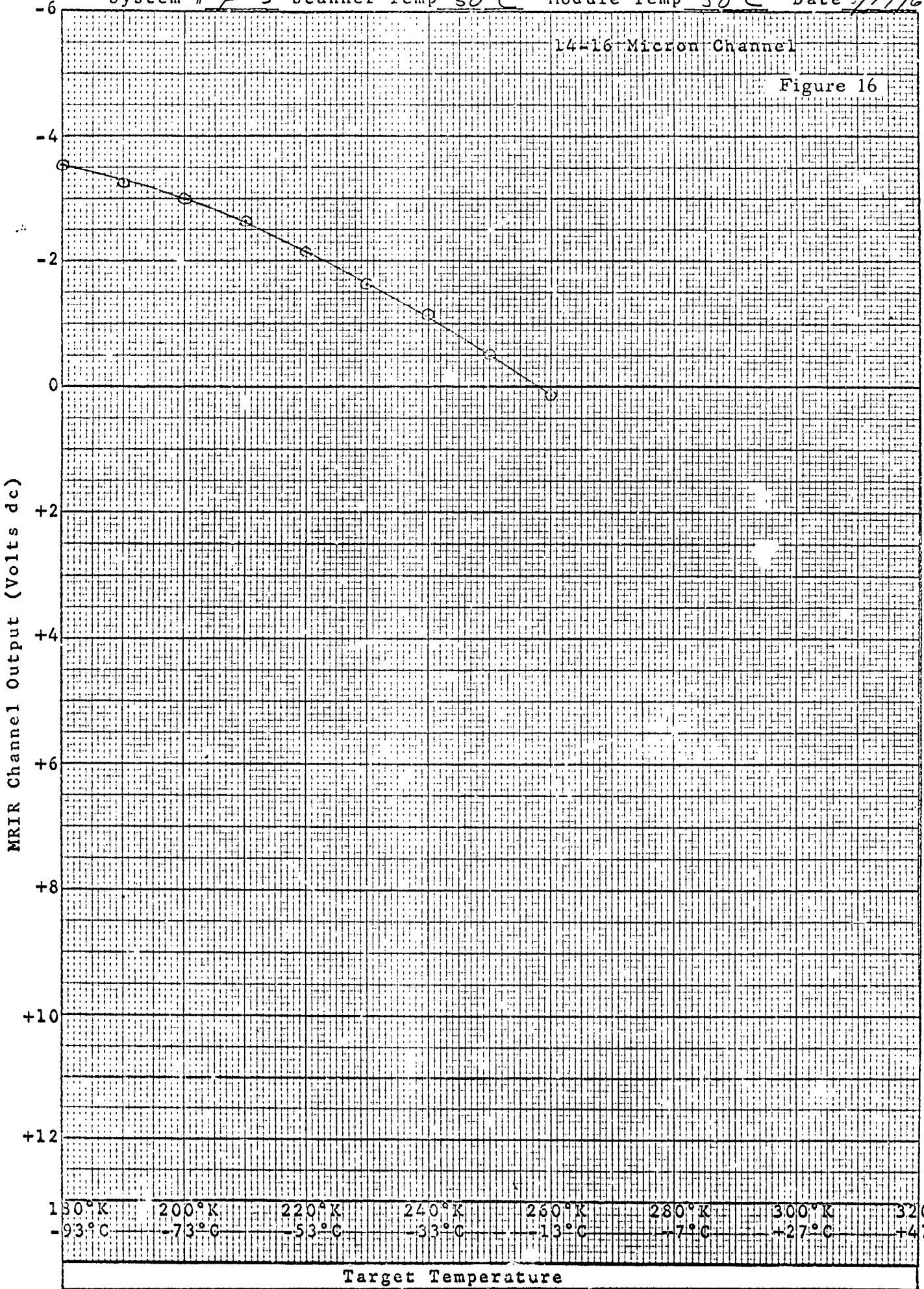


MRIR Calibration Curves (D)

System # F-5 Scanner Temp 50°C Module Temp 50°C Date 3/19/65

14-16 Micron Channel

Figure 16



INE B. L. L. SEN & CO.
MADE IN U. S. A.

DR-2 ETZG RAPT CR
20 X 20 PER INCH

Target Temperature

MRIR Calibration Curves (D)

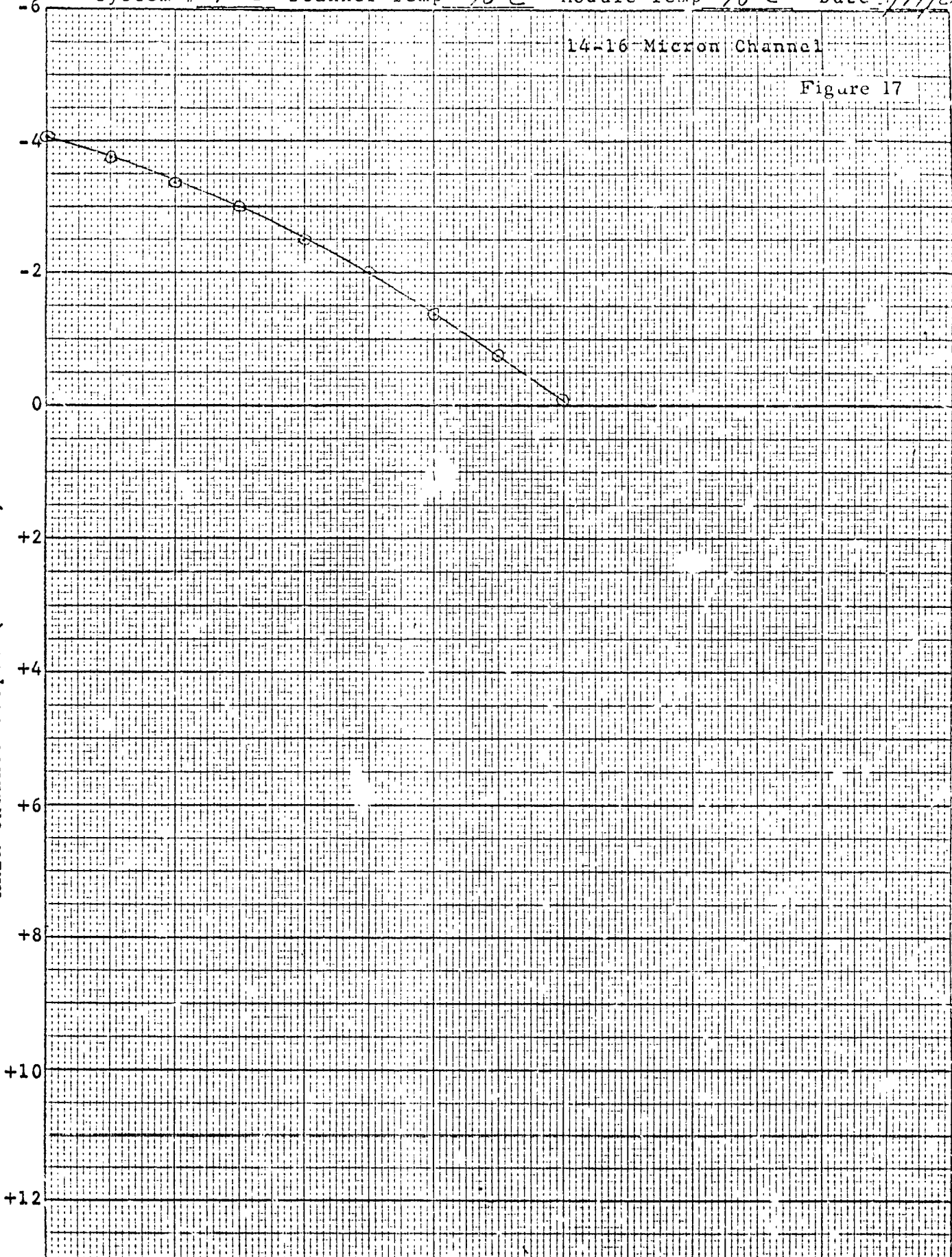
37

System # F-5 Scanner Temp 40°C Module Temp 40°C Date 3/14/65

14-16-Micron Channel

Figure 17

MRIR Channel Output (Volts dc)



Target Temperature

DR-Z 17ZG 34PF 20 X 20 PER INCH MADE IN U. S. A.

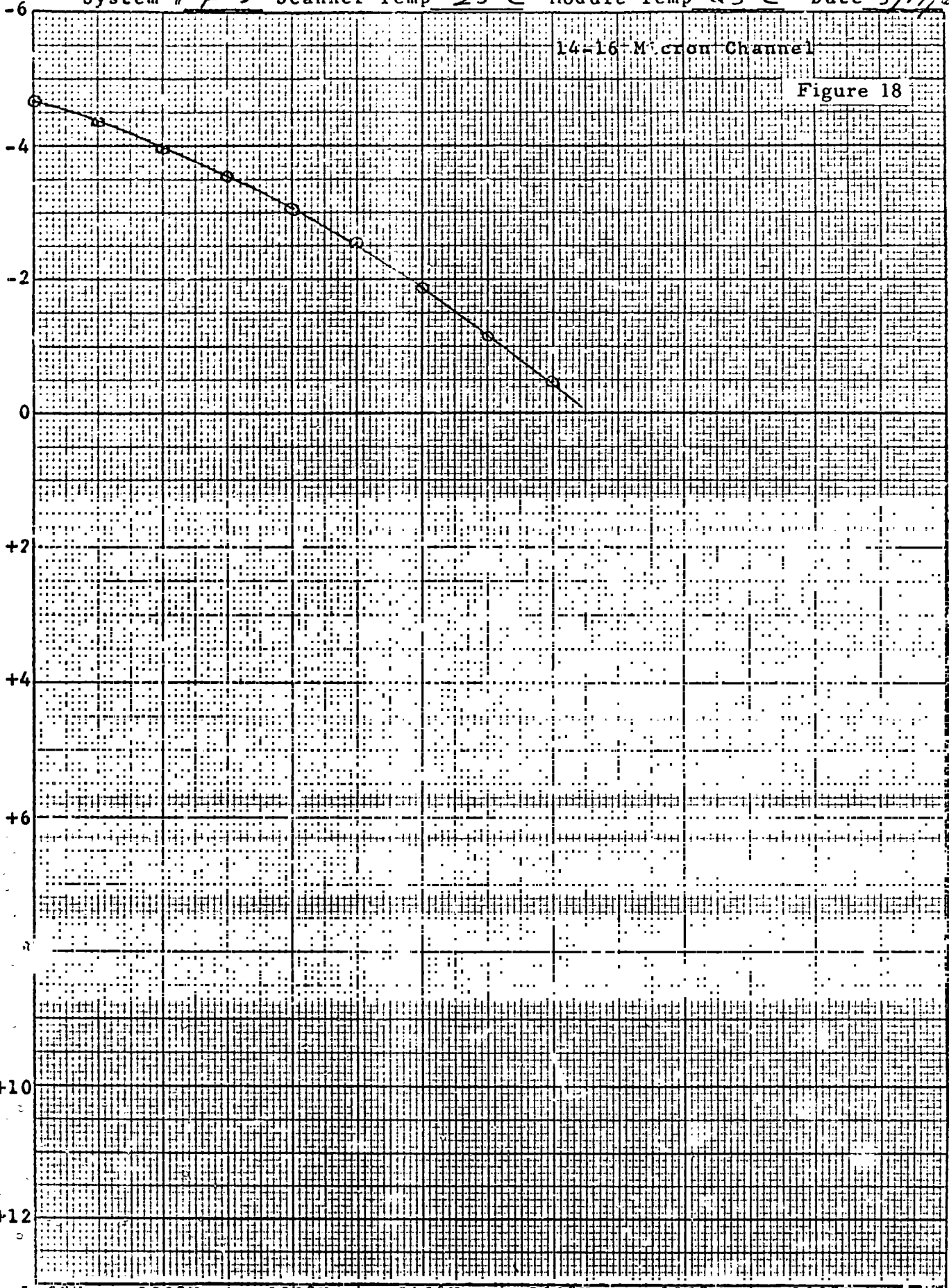
MIR Calibration Curves (D)

System # F-5 Scanner Temp 25°C Module Temp 25°C Date 3/19/65

14-16 Micron Channel

Figure 18

MIR Channel Output (Volts dc)



Target Temperature

GENE PERGEN
MADE IN U. S. A.

40R ETZOTRAP PER
20 X 20 PER INCH

MRIR Calibration Curves (D)

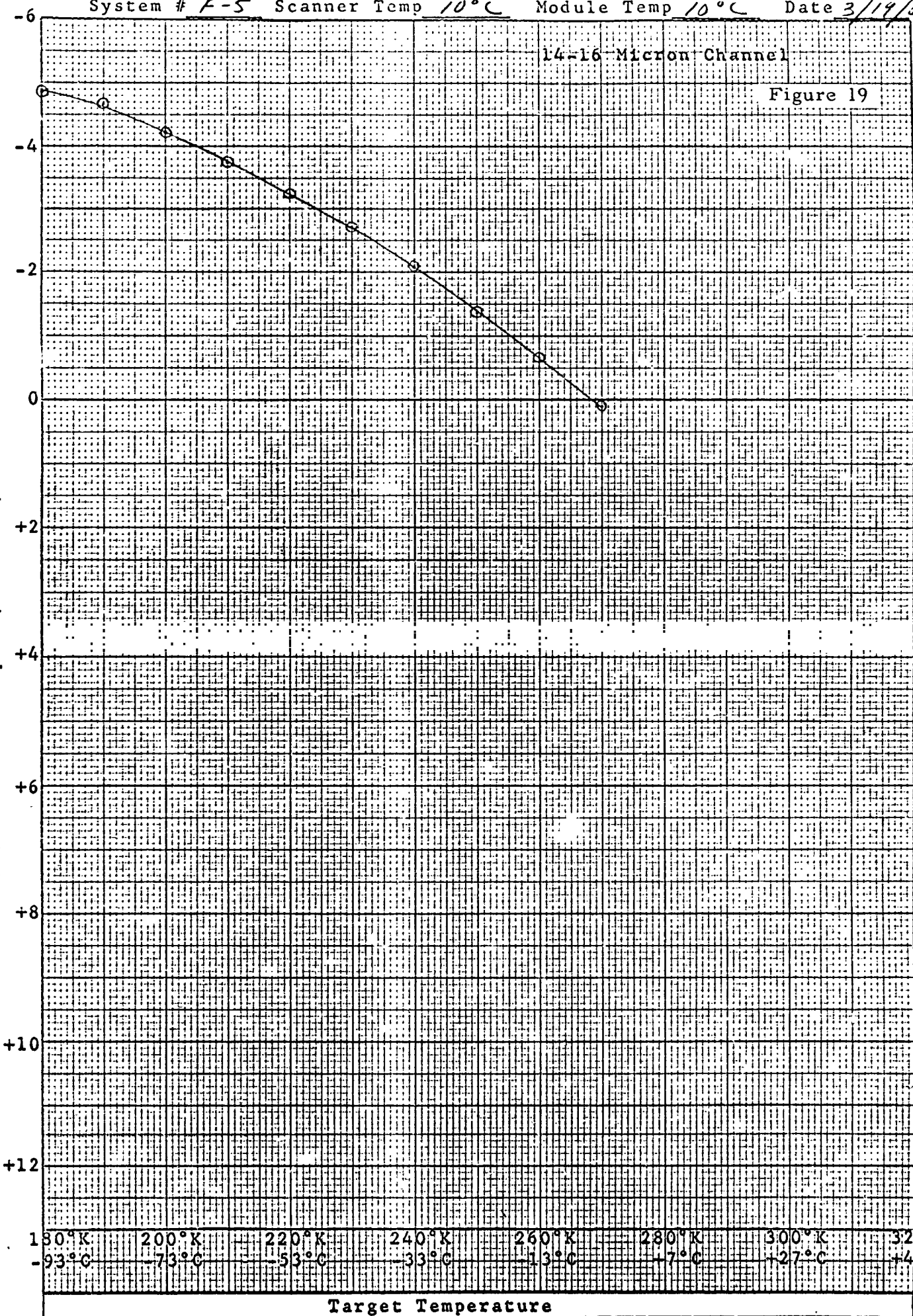
39

System # F-5 Scanner Temp 10°C Module Temp 10°C Date 3/19/65

14-16 Micron Channel

Figure 19

MRIR Channel Output (Volts dc)



Target Temperature

ETZC RAPI ER 20 X 20 PER INCH

NEESEN MADE IN U.S.A.

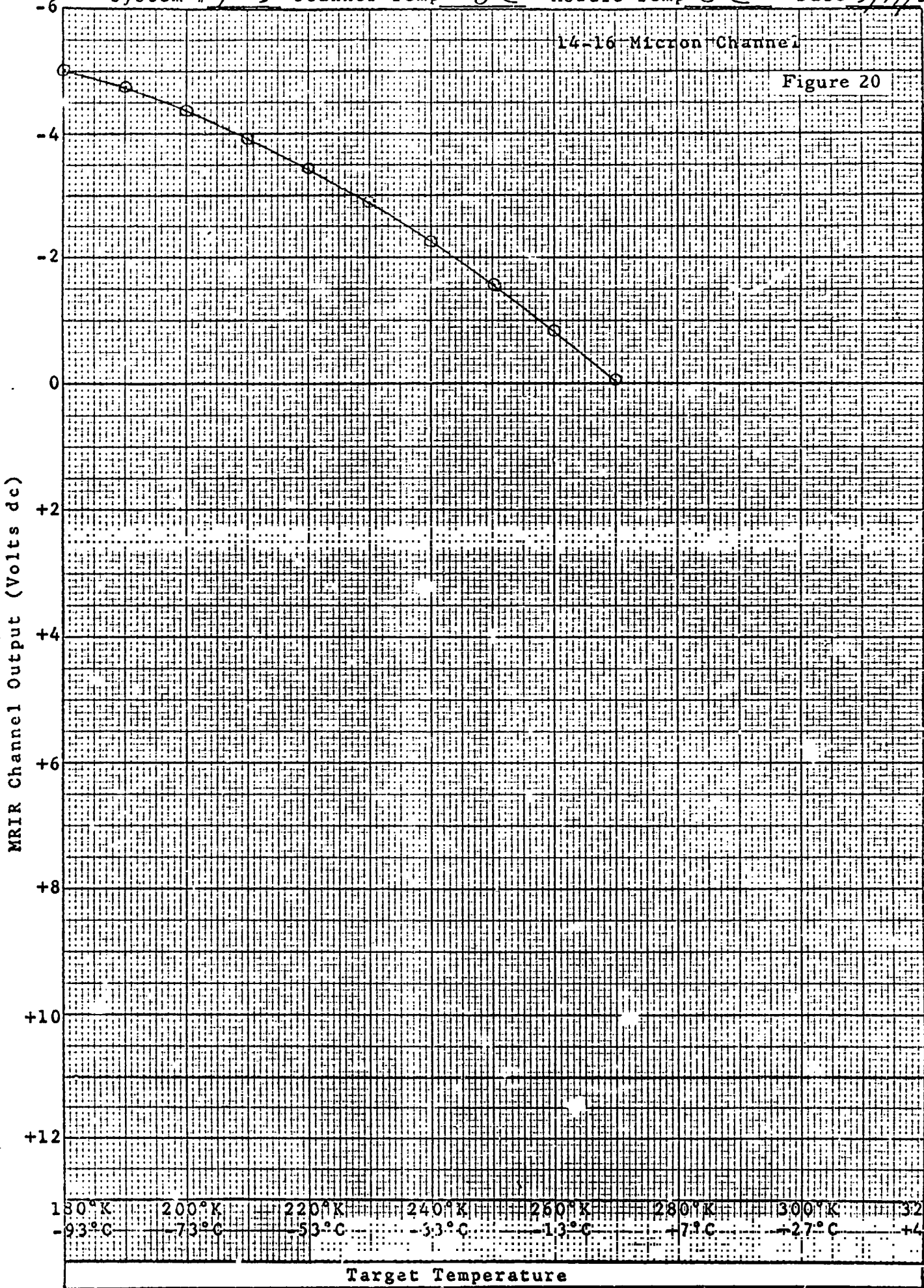
MRIR Calibration Curves (D)

(40)

System # F-5 Scanner Temp 0°C Module Temp 0°C Date 3/19/65

14-16 Micron Channel

Figure 20

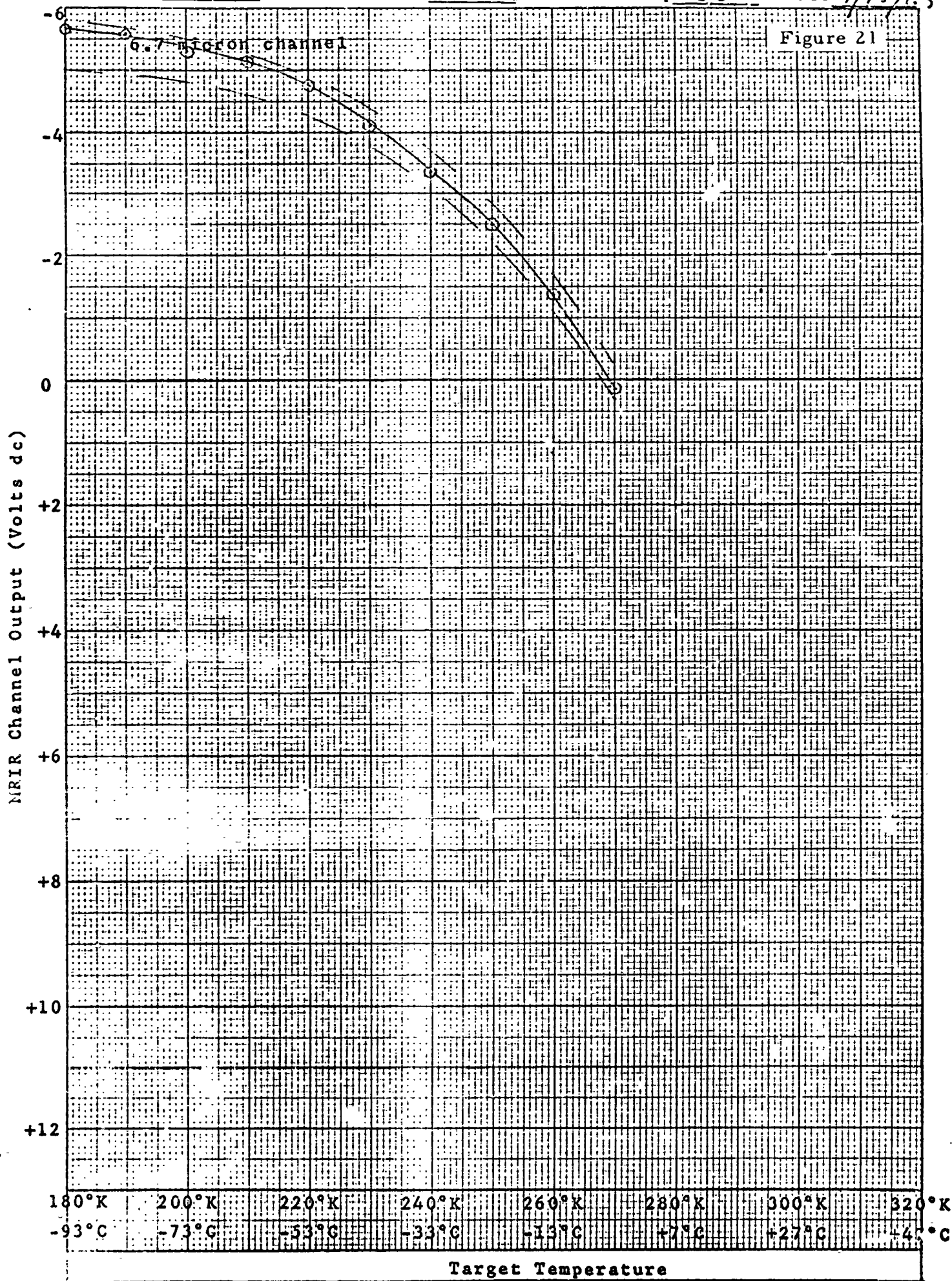


NE 3R-20 1766 APH R 20 X 20 PER INCH MADE IN U. S. A.

Target Temperature

MRIR Calibration Curves (D)

System # F-6 Scanner Temp 50°C Module Temp 50°C Date 1/15/65



N 307
 MADE IN U.S.A.
 20
 20
 20

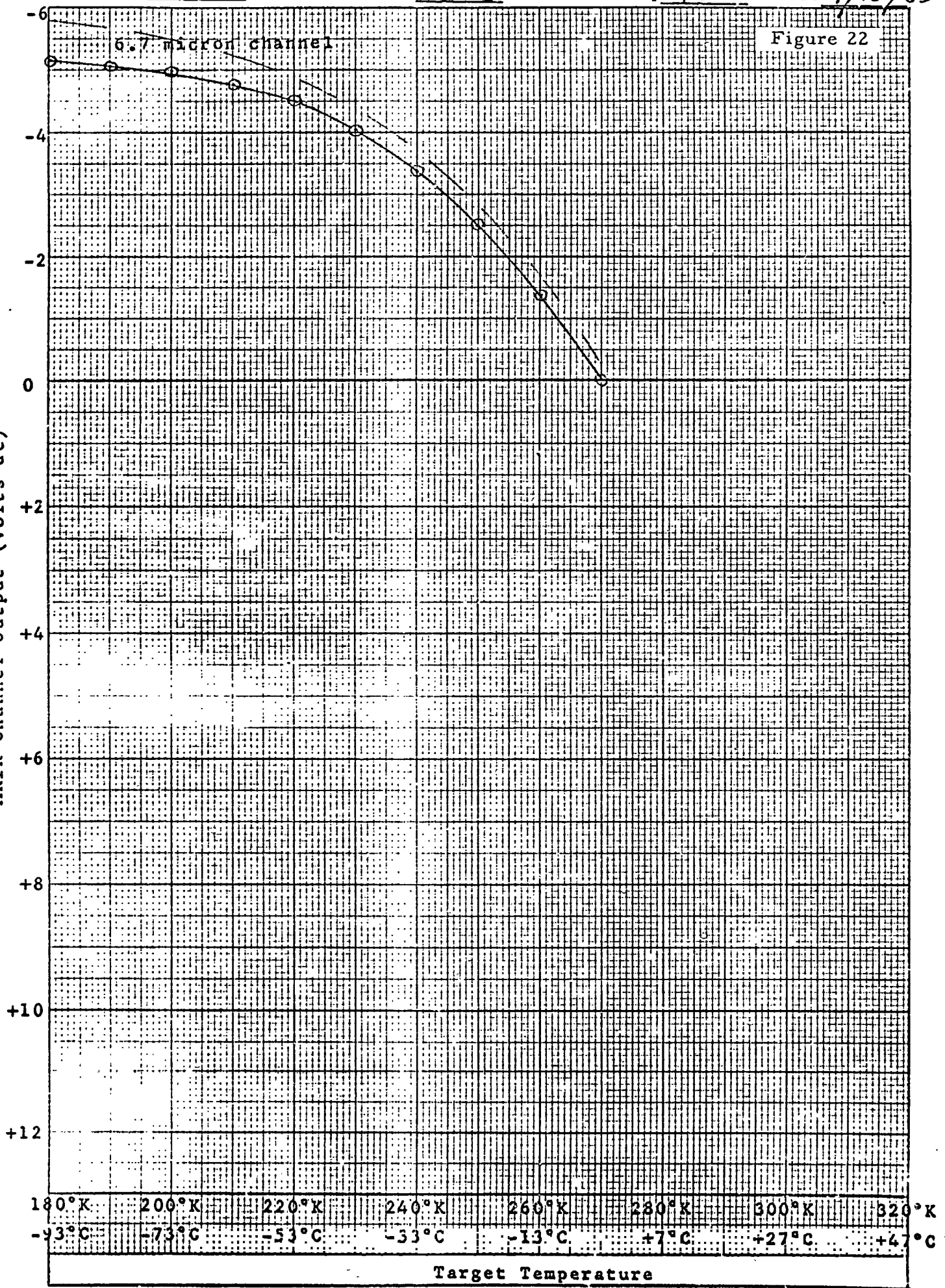
MRIR Calibration Curves (D)

System # F-6 Scanner Temp 40°C Module Temp 40°C Date 1/15/65

Figure 22

6.7 micron channel

MRIR Channel Output (Volts dc)



GEN. PER INCH 20

GEN. PER INCH 20

GEN. PER INCH 20

GEN. PER INCH 20

GEN. PER INCH 20

GEN. PER INCH 20

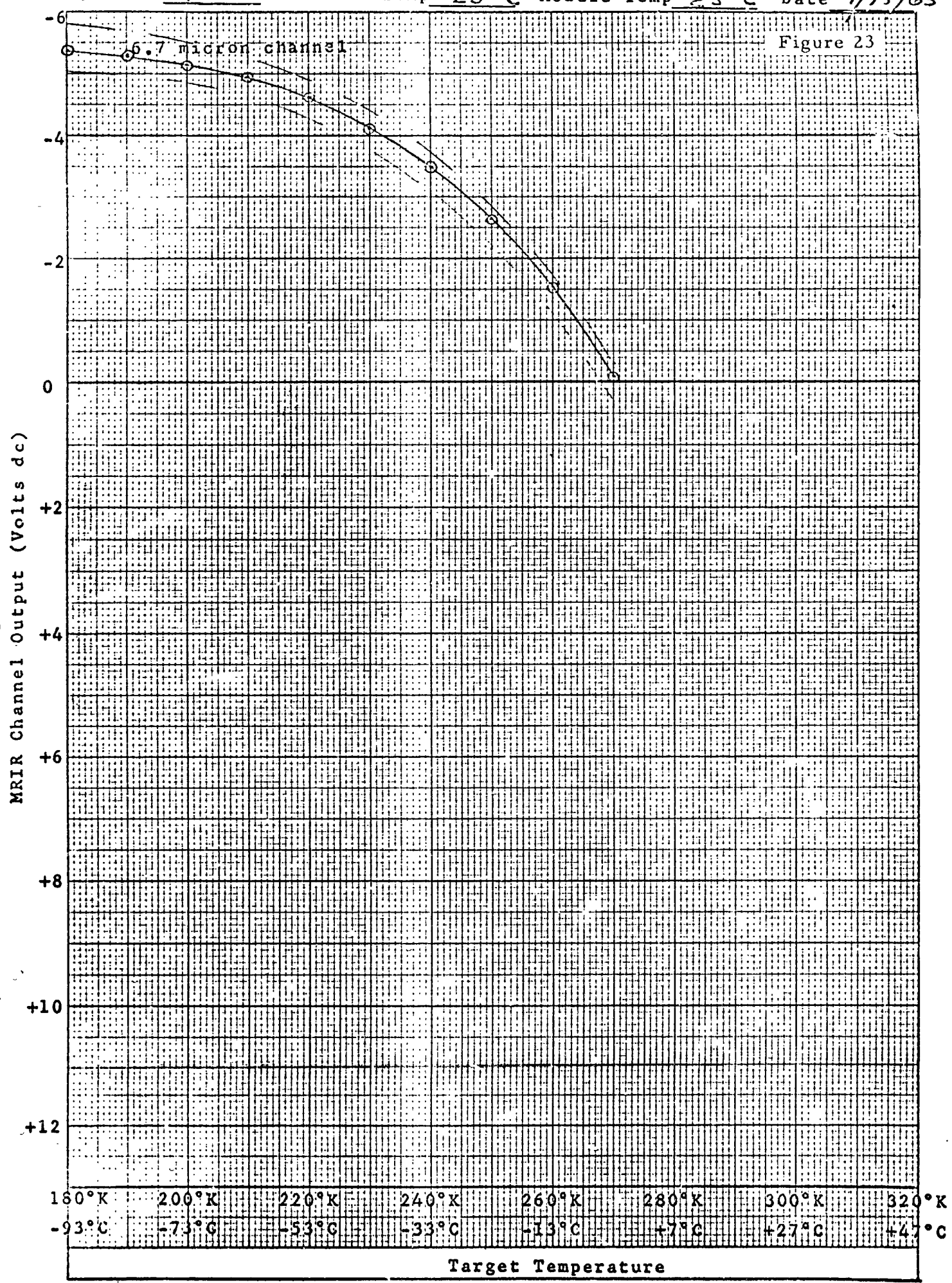
GEN. PER INCH 20

GEN. PER INCH 20

MRIR Calibration Curves (D)

System # F-6 Scanner Temp 25°C Module Temp 25°C Date 1/15/65

Figure 23



NO. 3-20 ZGEN PH 1 20 X 20 PER INCH MADE IN U.S.A.

MRIR Calibration Curves (D)

System # F-6 Scanner Temp 10°C Module Temp 10°C Date 1/15/65

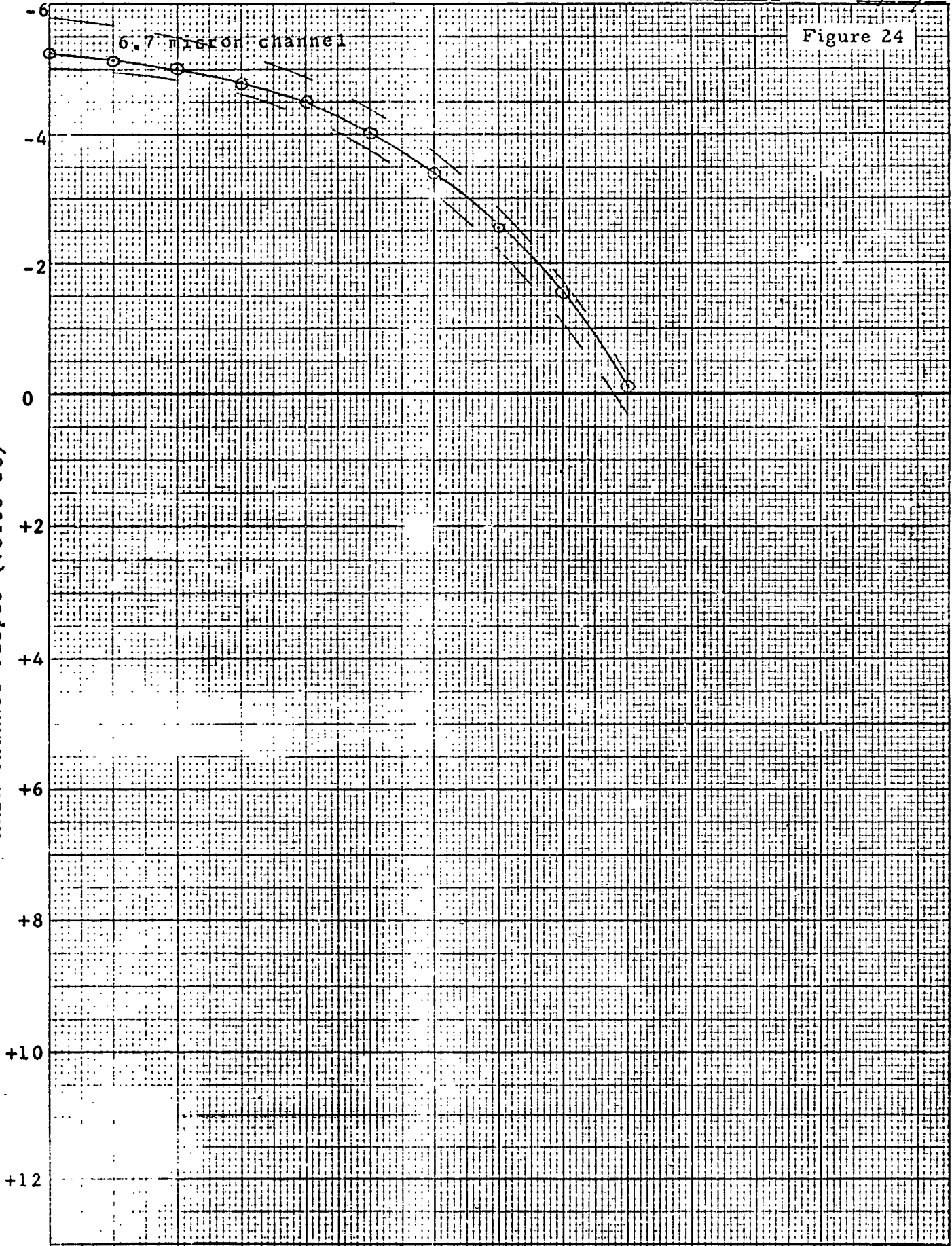
Figure 24

F 5011 NCC
MADE IN U.S.A.

1000
200 x 200 PER INCH

MRIR Channel Output (Volts dc)

6.7 micron channel



180°K	200°K	220°K	240°K	260°K	280°K	300°K	320°K
-93°C	-73°C	-53°C	-33°C	-13°C	+7°C	+27°C	+47°C

Target Temperature

MRIR Calibration Curves (D)

System # F-6

Scanner Temp 0°C

Module Temp 0°C

Date 1/15/65

Figure 25

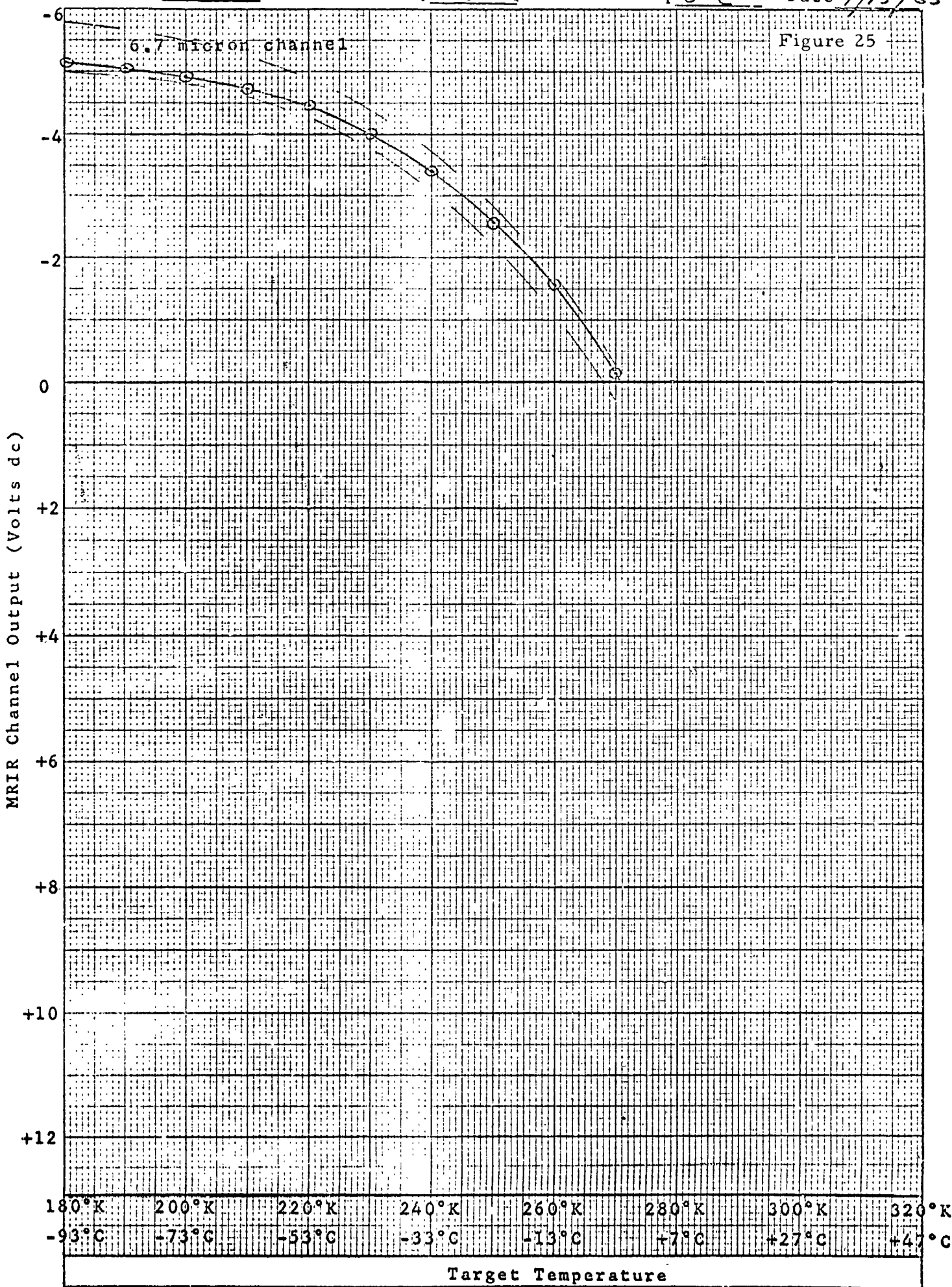


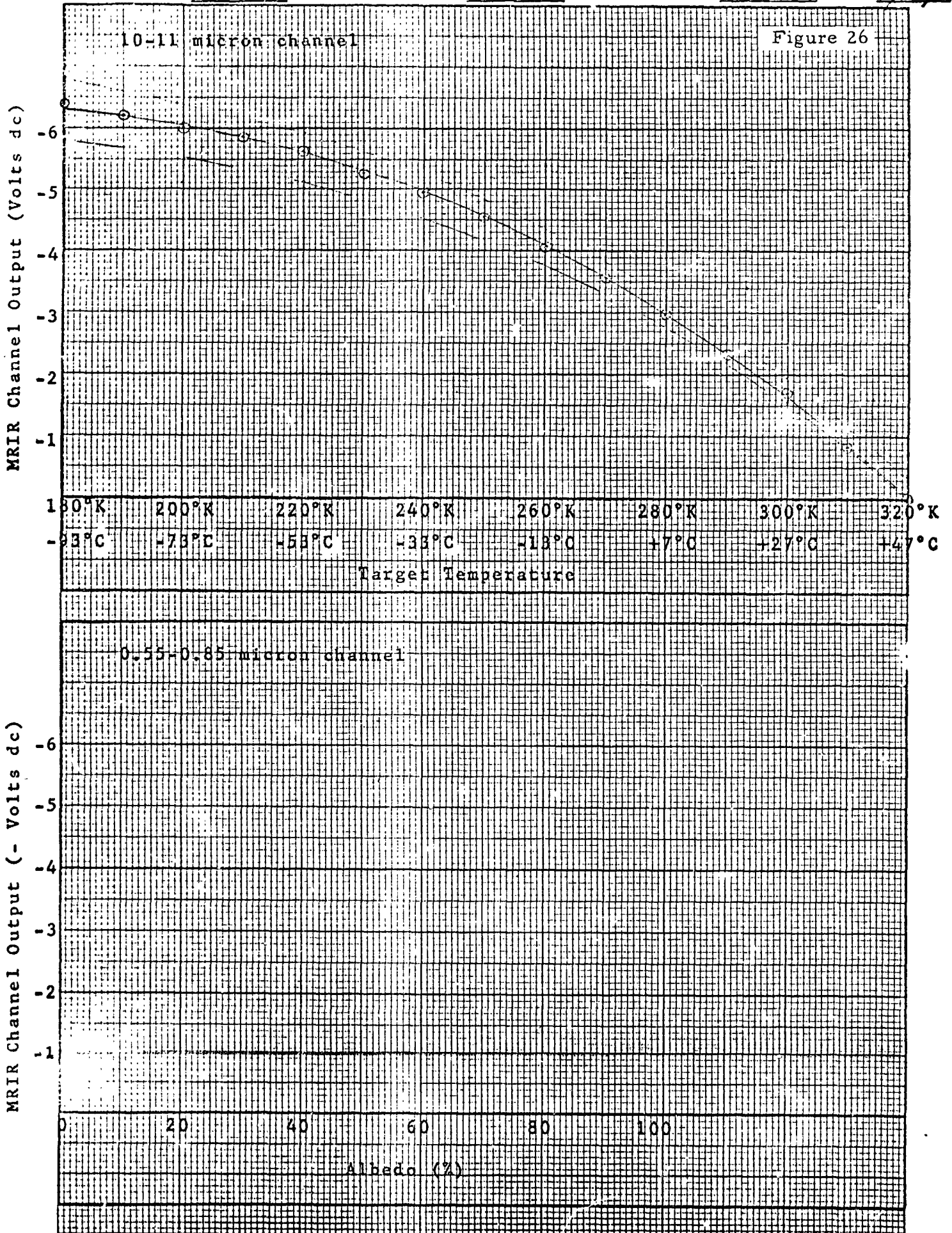
PHOTO COPY
NO. 20
20 X 20 PER INCH

Target Temperature

MRIR Calibration Curves (D)

(31)

System # F-6 Scanner Temp 50°C Module Temp 50°C Date 1/15/65



E. DIVISION OF AEC
MADE IN U. S. A.

ND 20 ZGEN 1PH 1
20 X 20 PER INCH

Figure 26

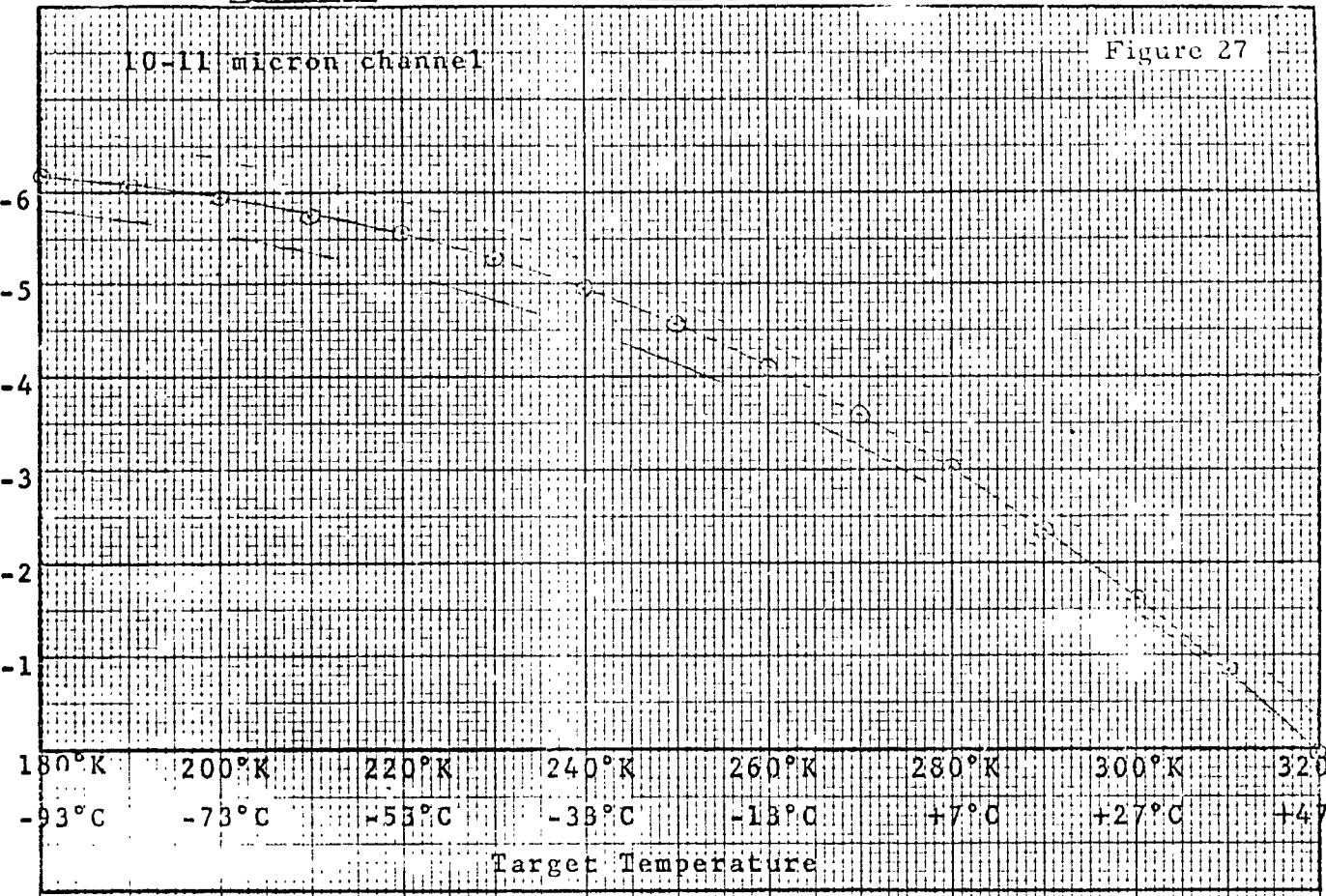
MRIR Calibration Curves (D)

System # F-6 Scanner Temp 410°C Module Temp 410°C Date 11/5/65

10-11 micron channel

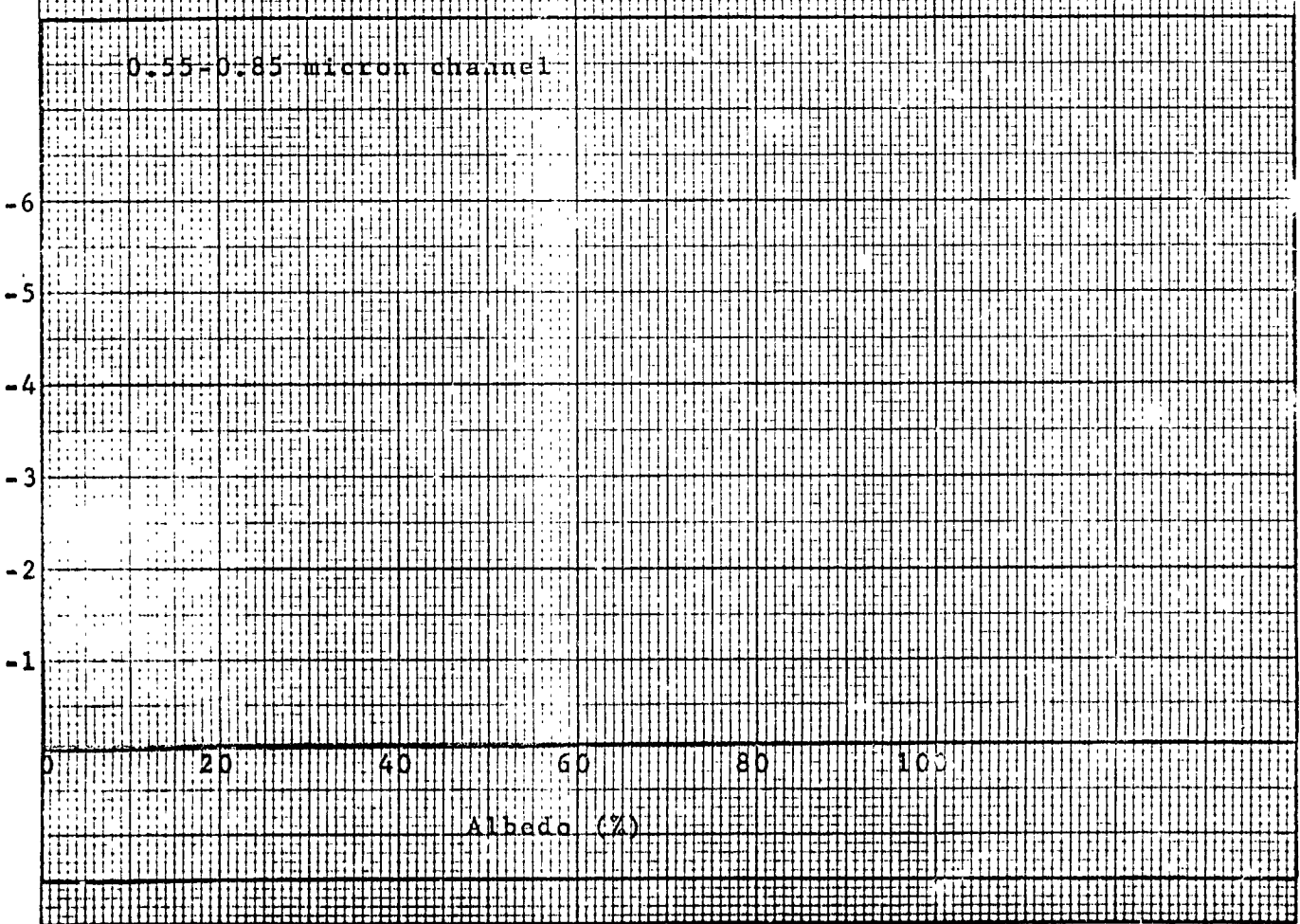
Figure 27

MRIR Channel Output (Volts dc)



0.55-0.85 micron channel

MRIR Channel Output (- Volts dc)



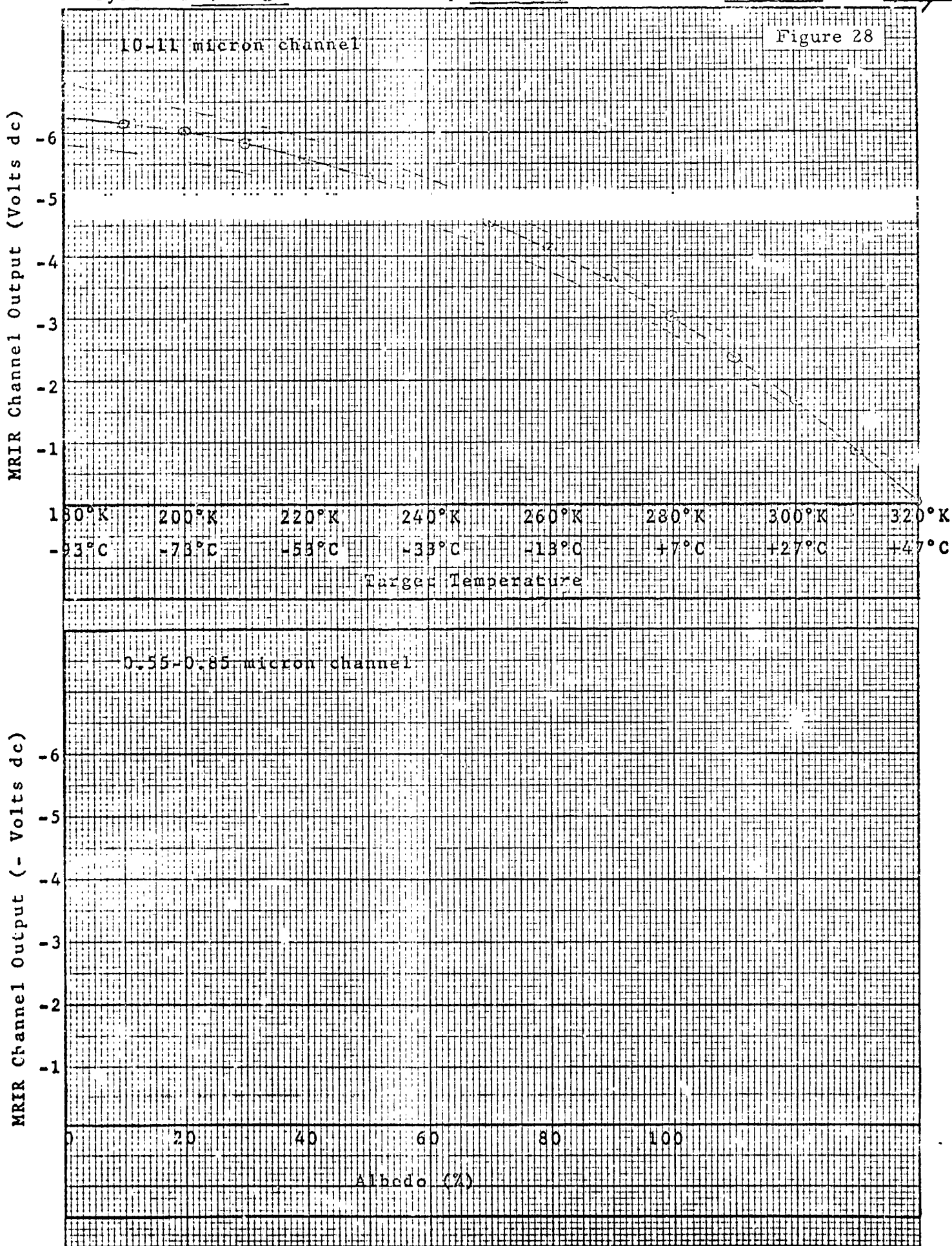
Albedo (%)

NO. 20 ZGEN. 20 A 20 PER INCH
 MADE IN U.S.A.

MRIR Calibration Curves (D)

(33)

System # F-6 Scanner Temp 25°C Module Temp 25°C Date 1/15/65



E. L. GEN. PH. I. 20 X 20 PER INCH MADE IN U.S.A.

MRIR Calibration Curves (D)

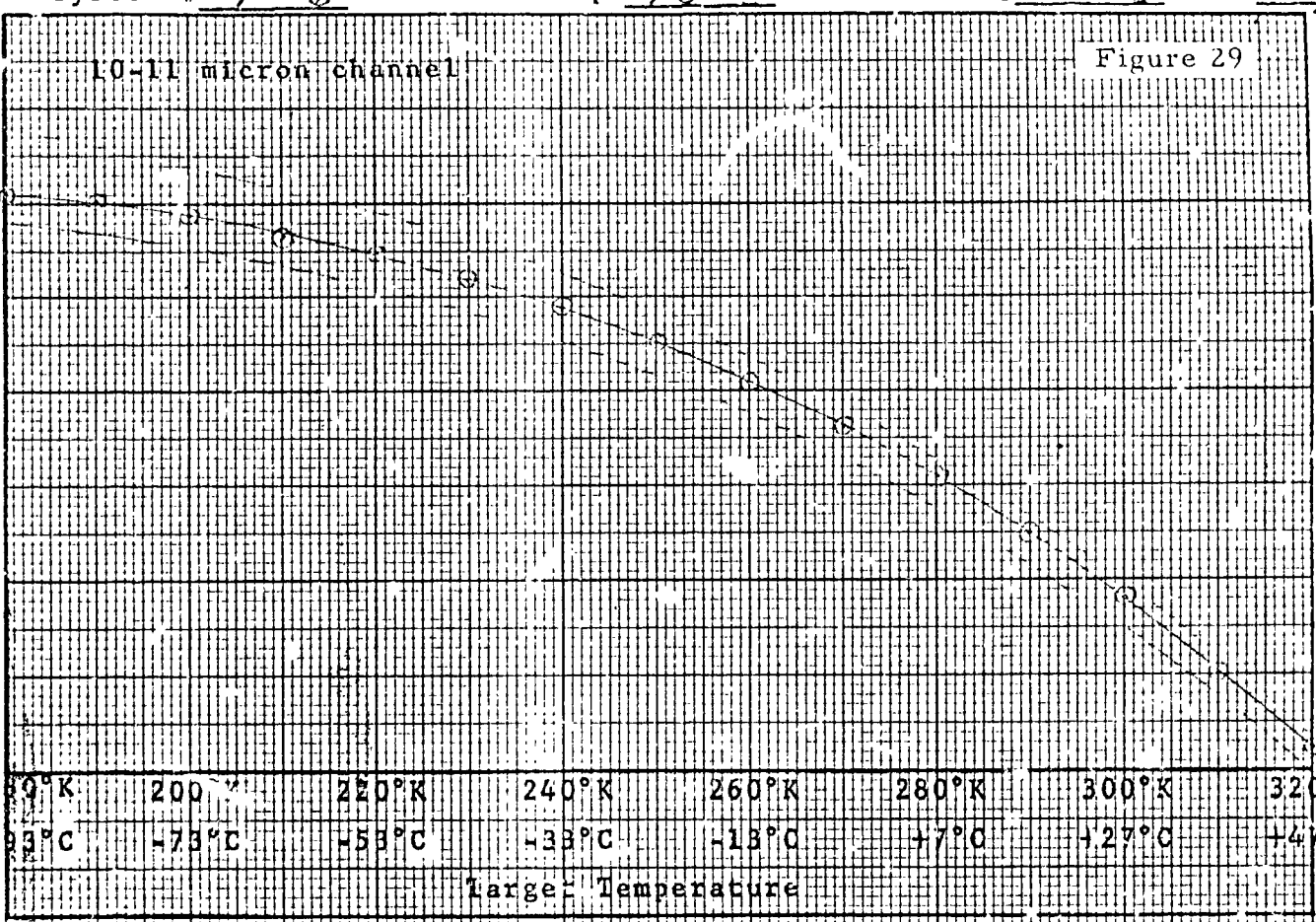
(34)

System # F-6 Scanner Temp 10°C Module Temp 16°C Date 1/15/65

Figure 29

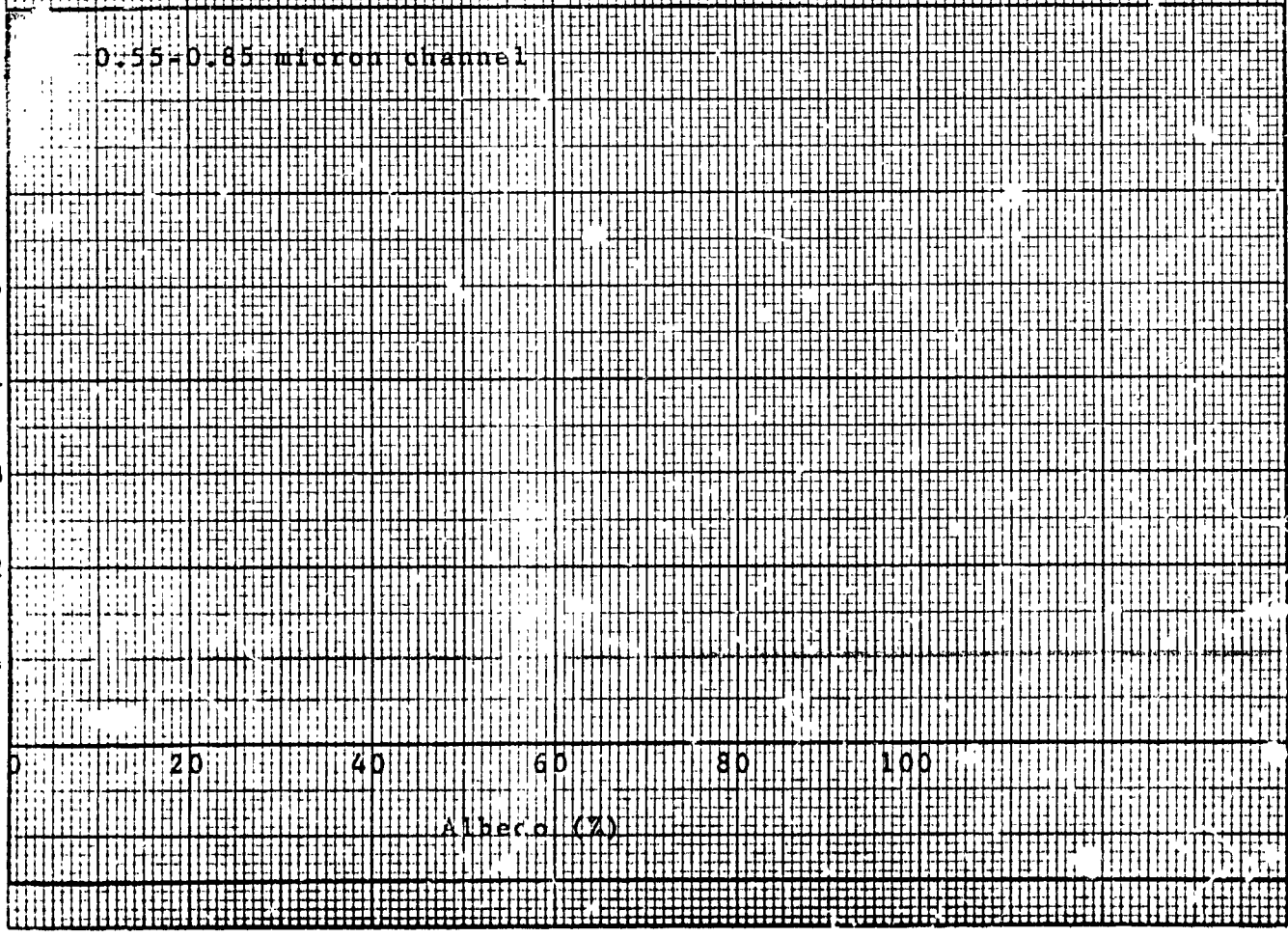
E. DI. NCC
MADE IN U. S. A.

MRIR Channel Output (Volts dc)



R-20 Z6E1
20 X 20 PER INC.

MRIR Channel Output (- Volts dc)

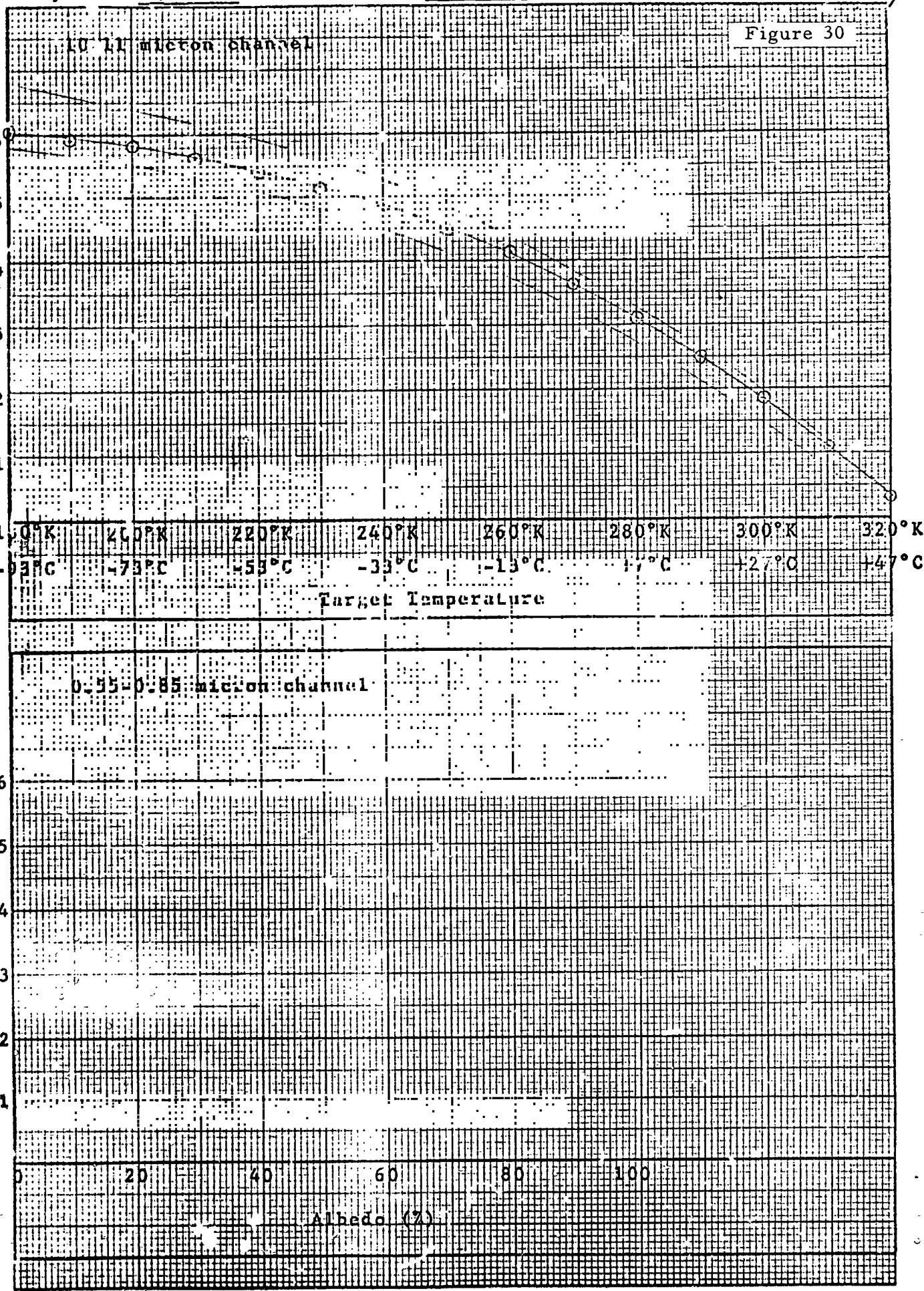


MRIR Calibration Curves (D)

53

System # F-6 Scanner Temp 0°C Module Temp 0°C Date 1/15/65

Figure 30



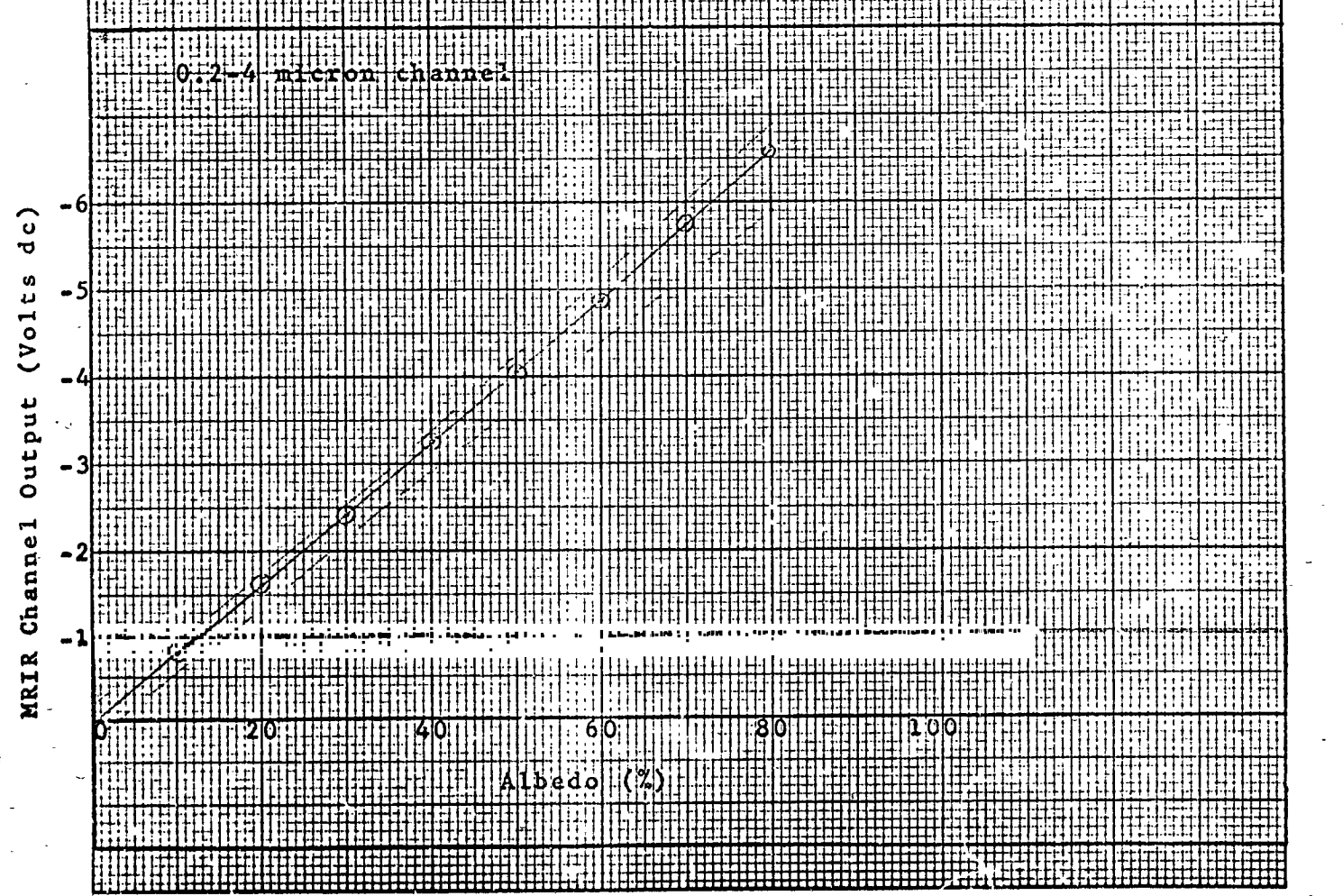
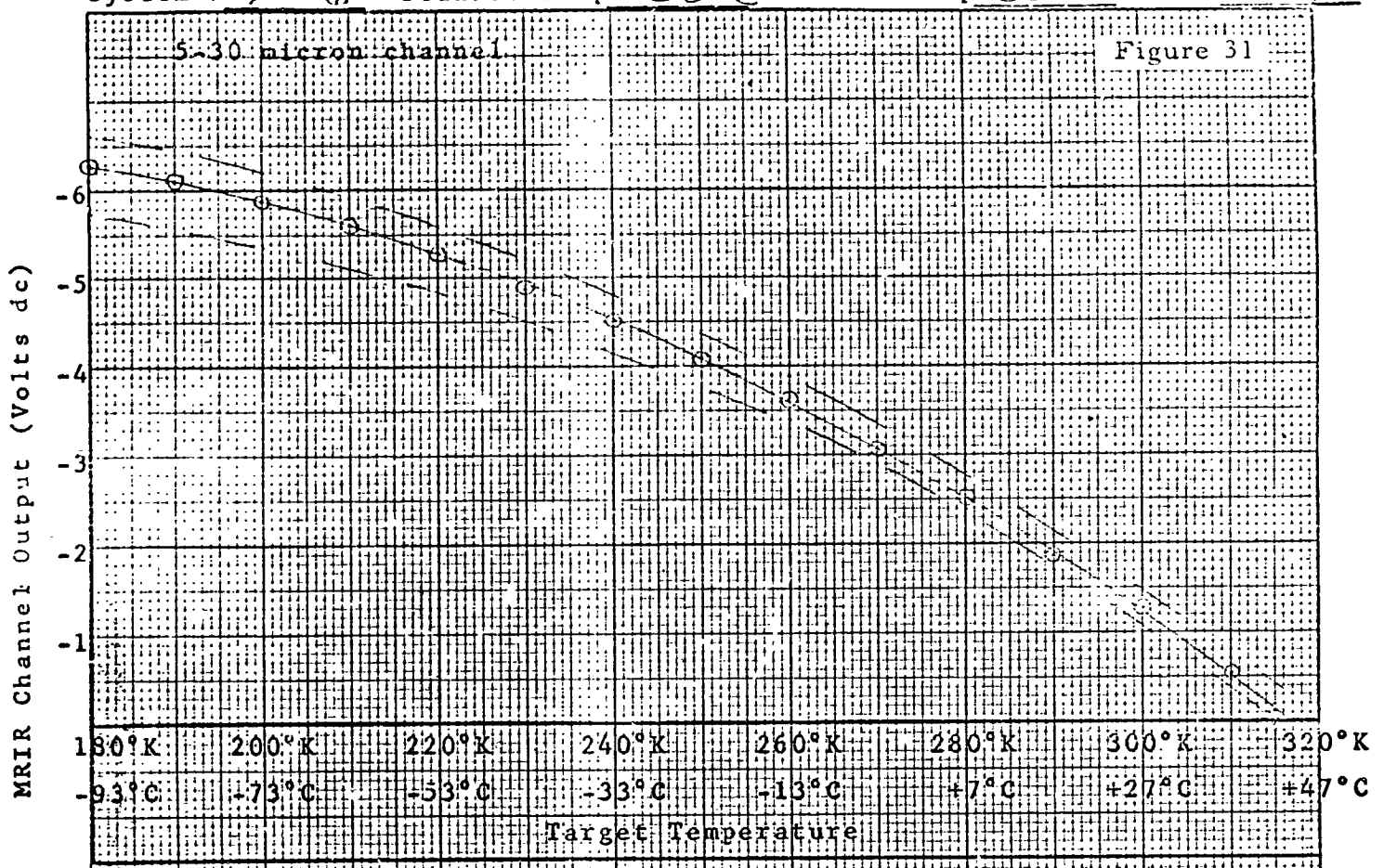
EDIE CO.
MADE IN U. S. A.

1-20 GEN. C. PH.
20 X 20 PER INCH

MRIR Calibration Curves (D)

③

System # *F-6* Scanner Temp *50°C* Module Temp *50°C* Date *1/15/65*

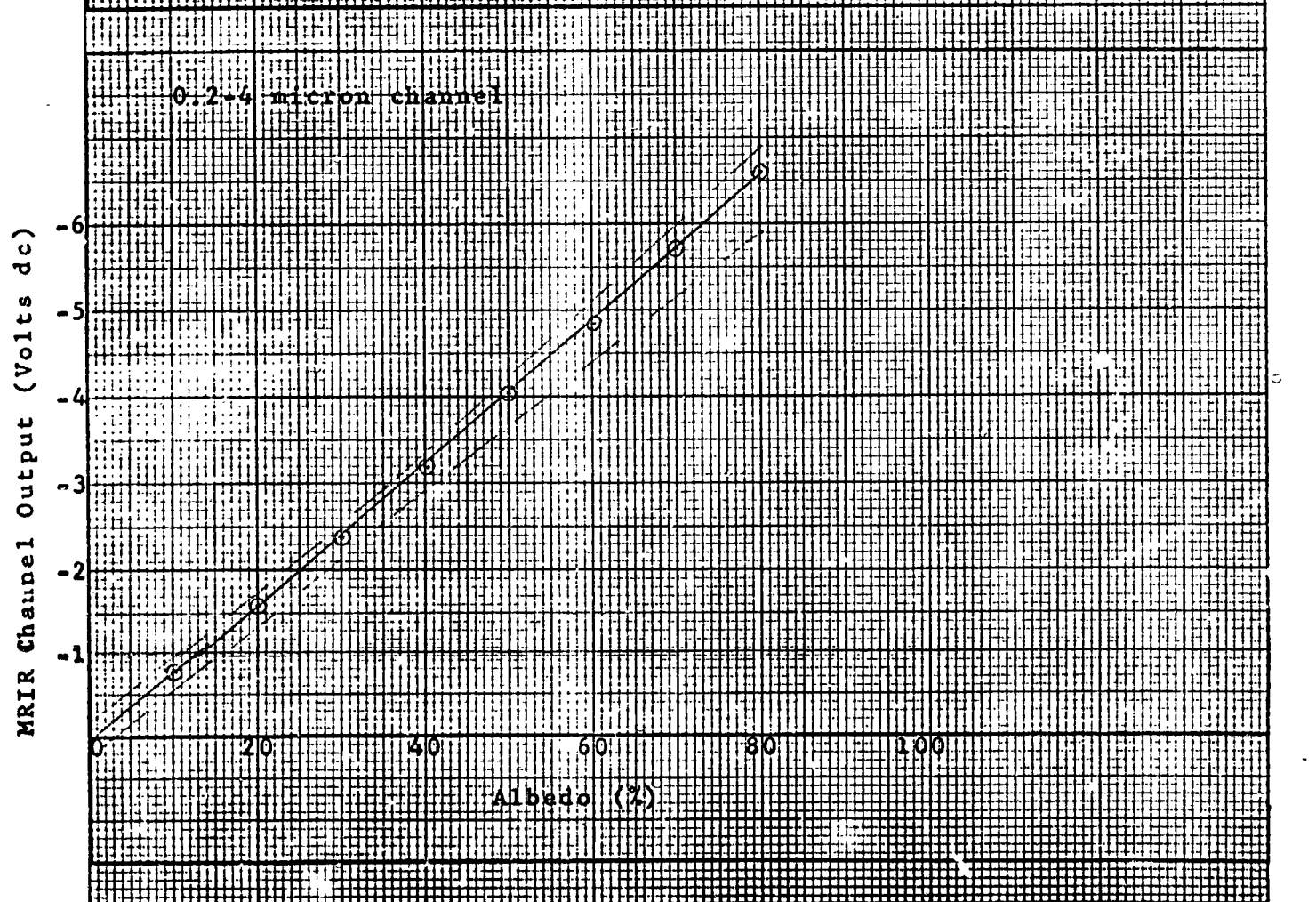
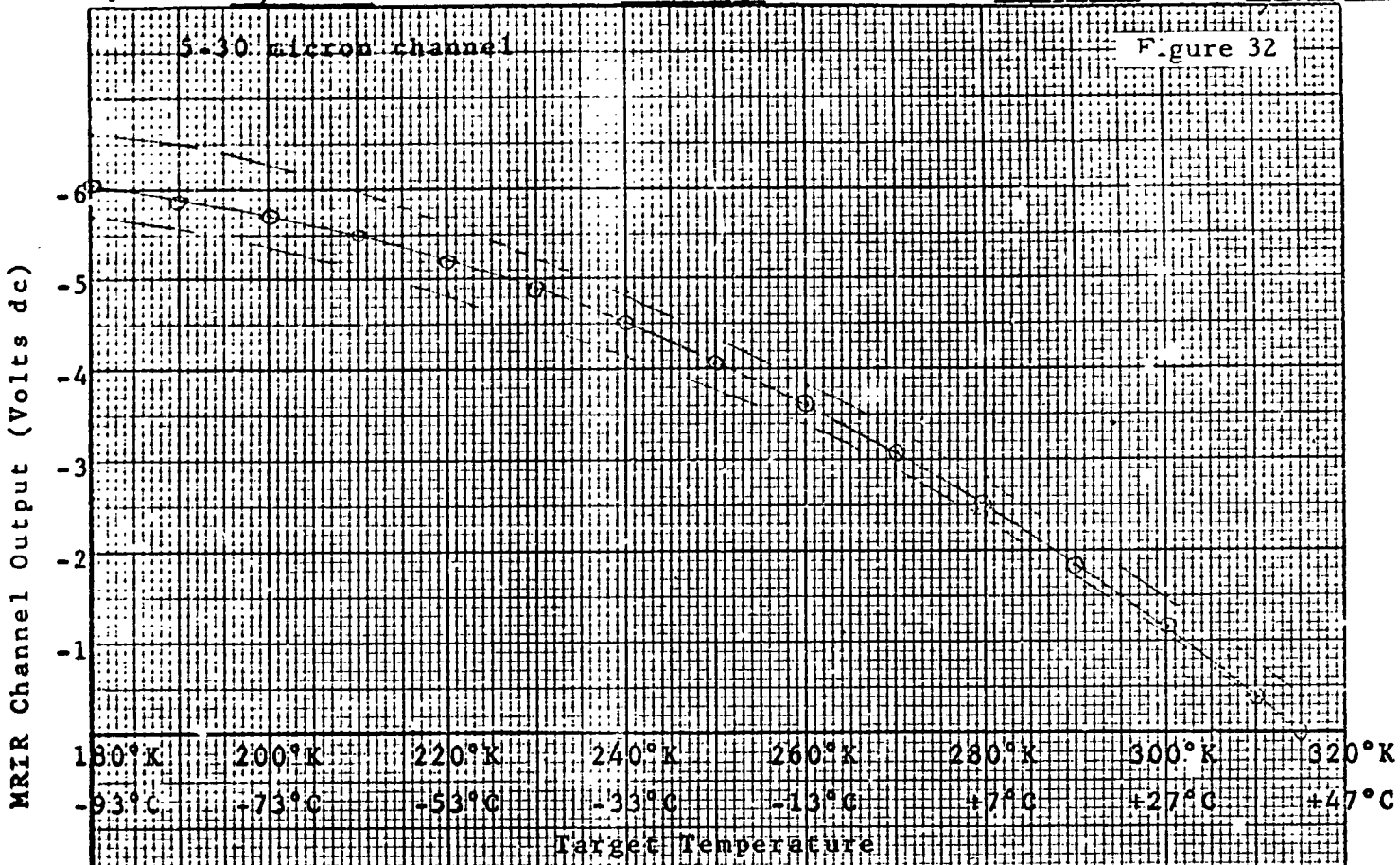


10 X 20 PER INCH

MRIR Calibration Curves (D)

37

System # F-6 Scanner Temp 40°C Module Temp 40°C Date 1/15/65



MADE IN U.S.A.

GEN. PH. 7
20 X 20 PER INCH

MRIR Calibration Curves (D)

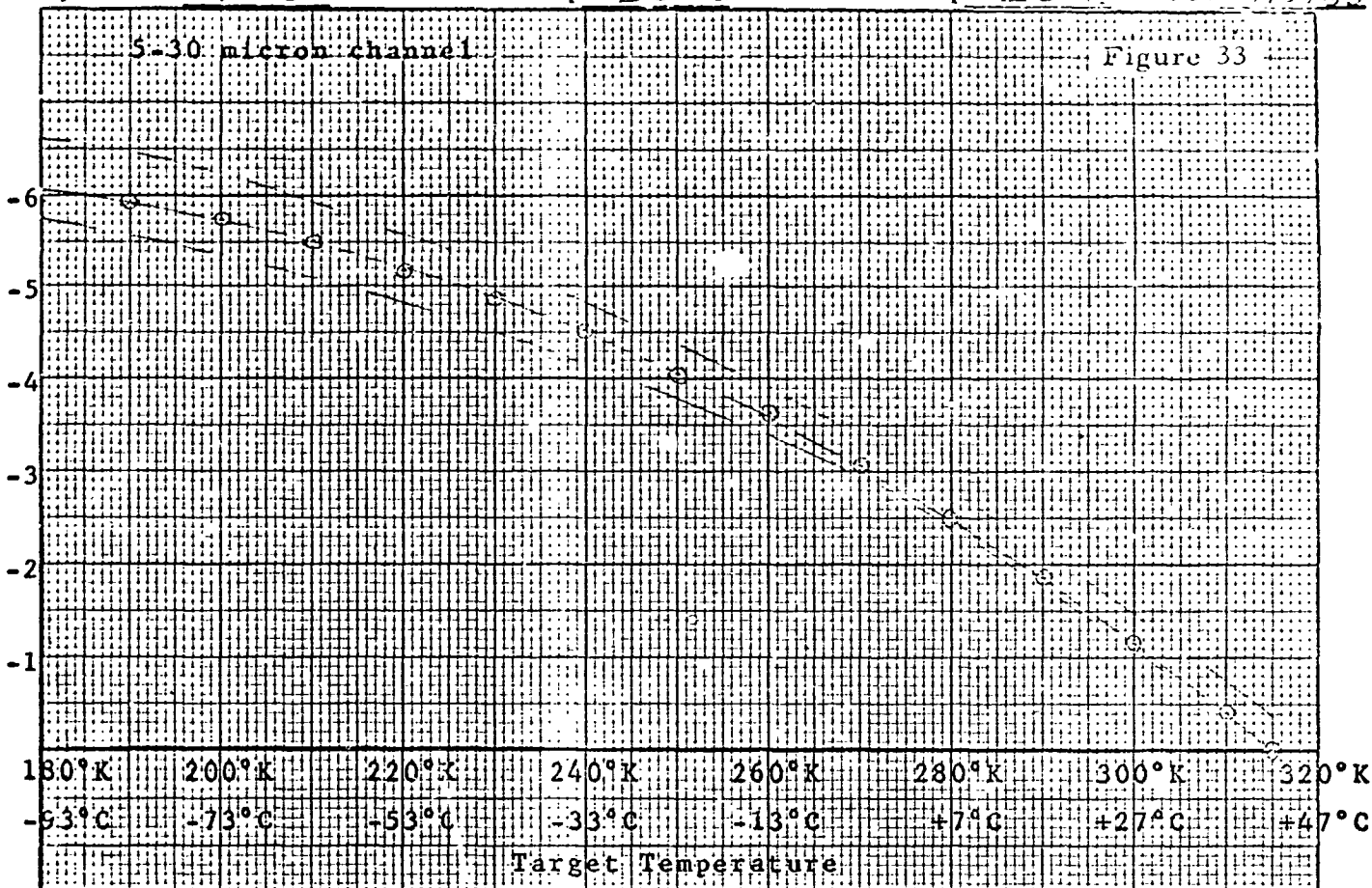
(35)

System # F-6 Scanner Temp 250C Module Temp 250C Date 1/15/65

5-30 micron channel

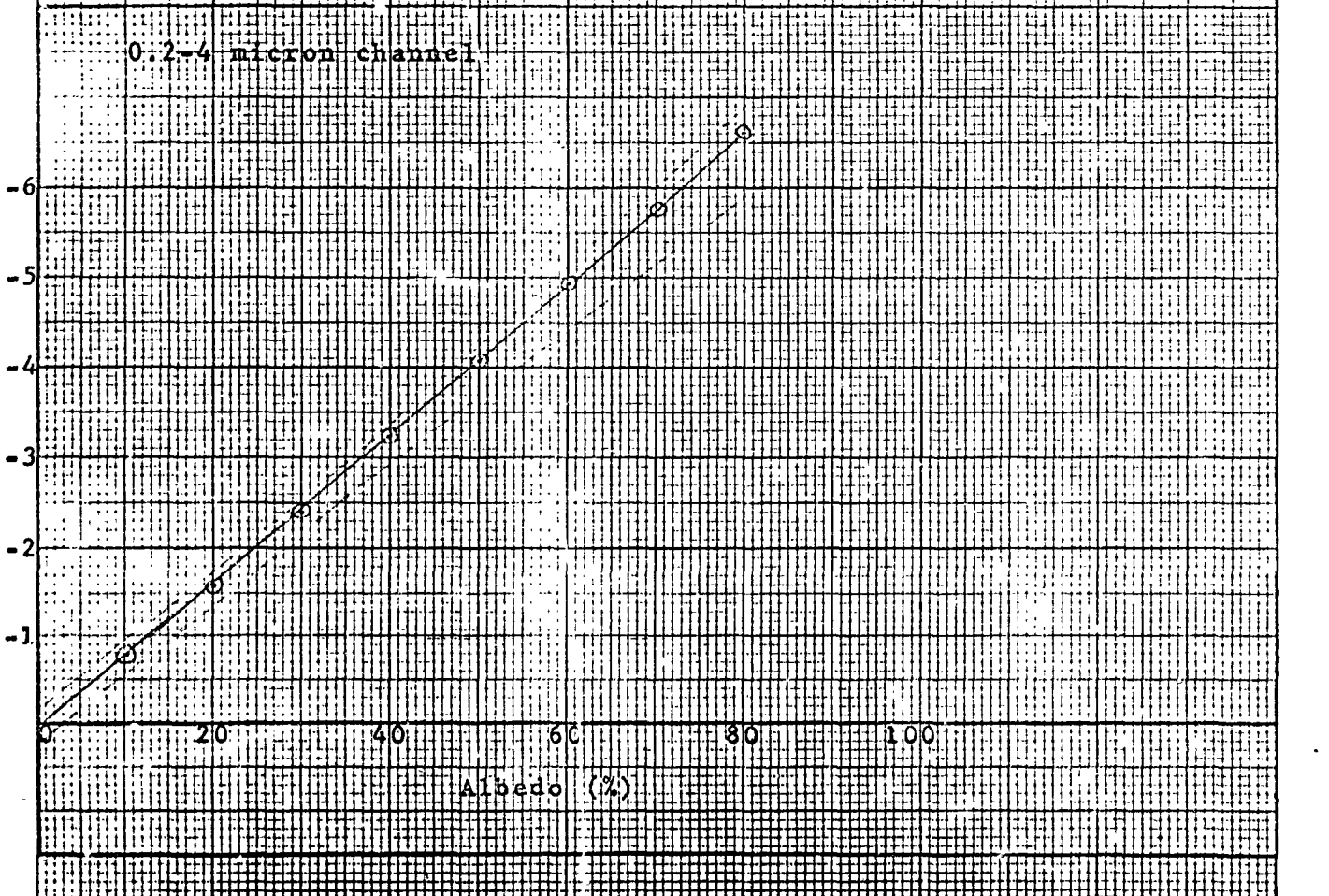
Figure 33

MRIR Channel Output (Volts dc)



0.2-4 micron channel

MRIR Channel Output (Volts dc)



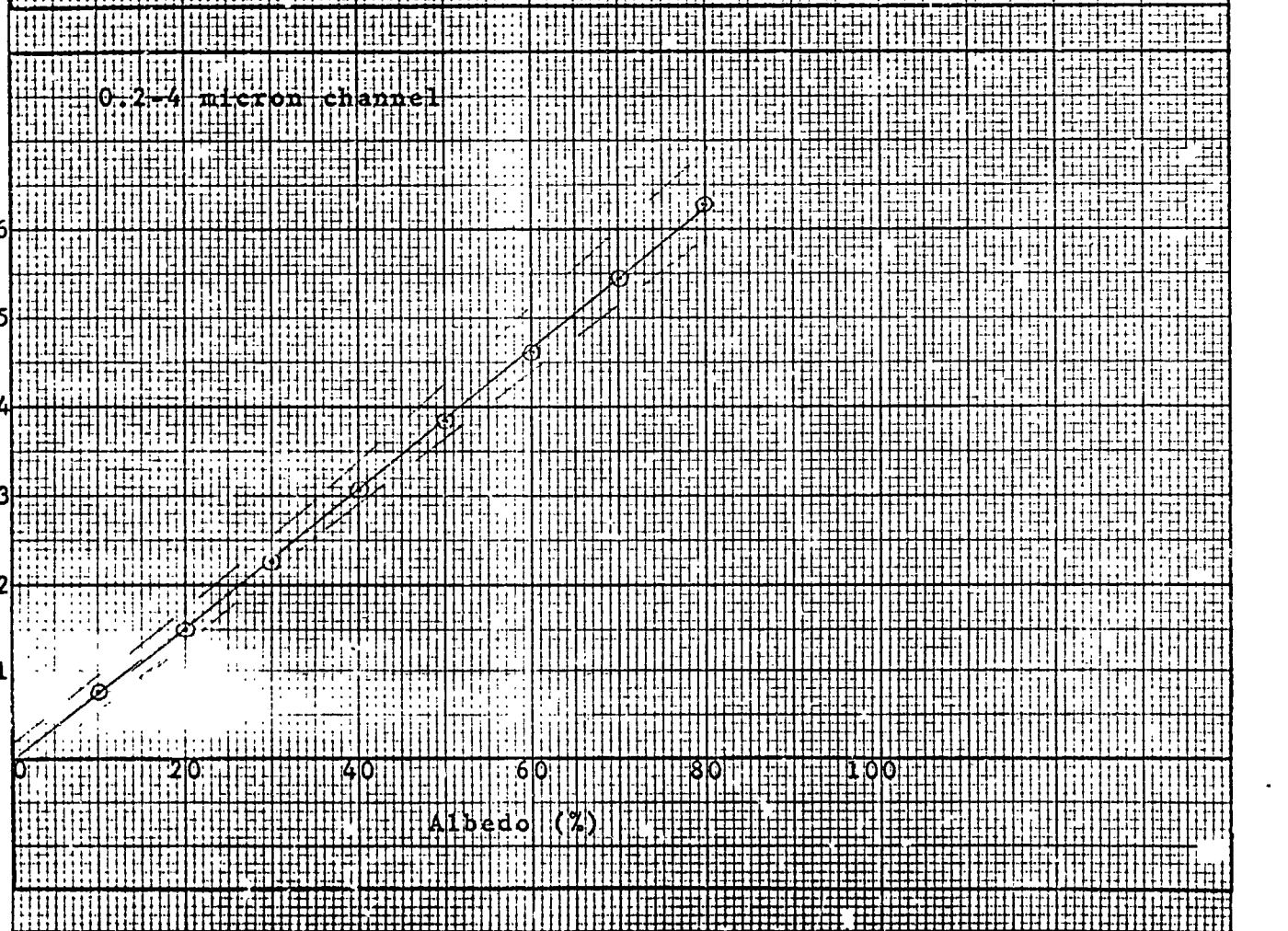
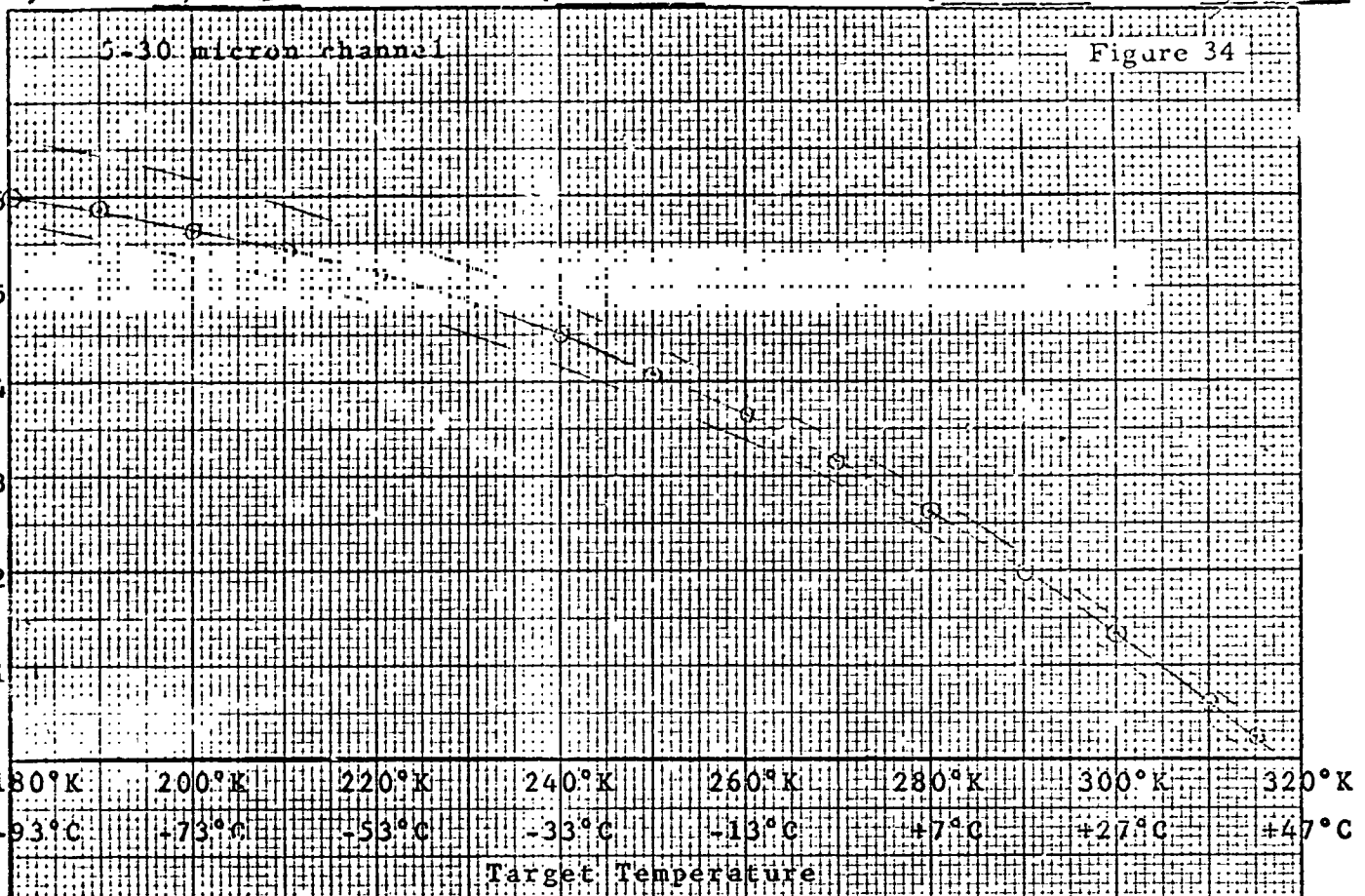
EU DIF 1 CO. MADE IN U. S. A.

GEN. NO. 20 X 20 PER INCH

MRIR Calibration Curves (D)

39

System # F-6 Scanner Temp 10°C Module Temp 10°C Date 1/15/65



EDIE V CO
MADE IN U. S. A.

NO. 7-20 ZGEN PH F
20 X 20 PER INLM

MRIR Channel Output (Volts dc)

MRIR Channel Output (Volts dc)

Albedo (%)

MRIR Calibration Curves (D)

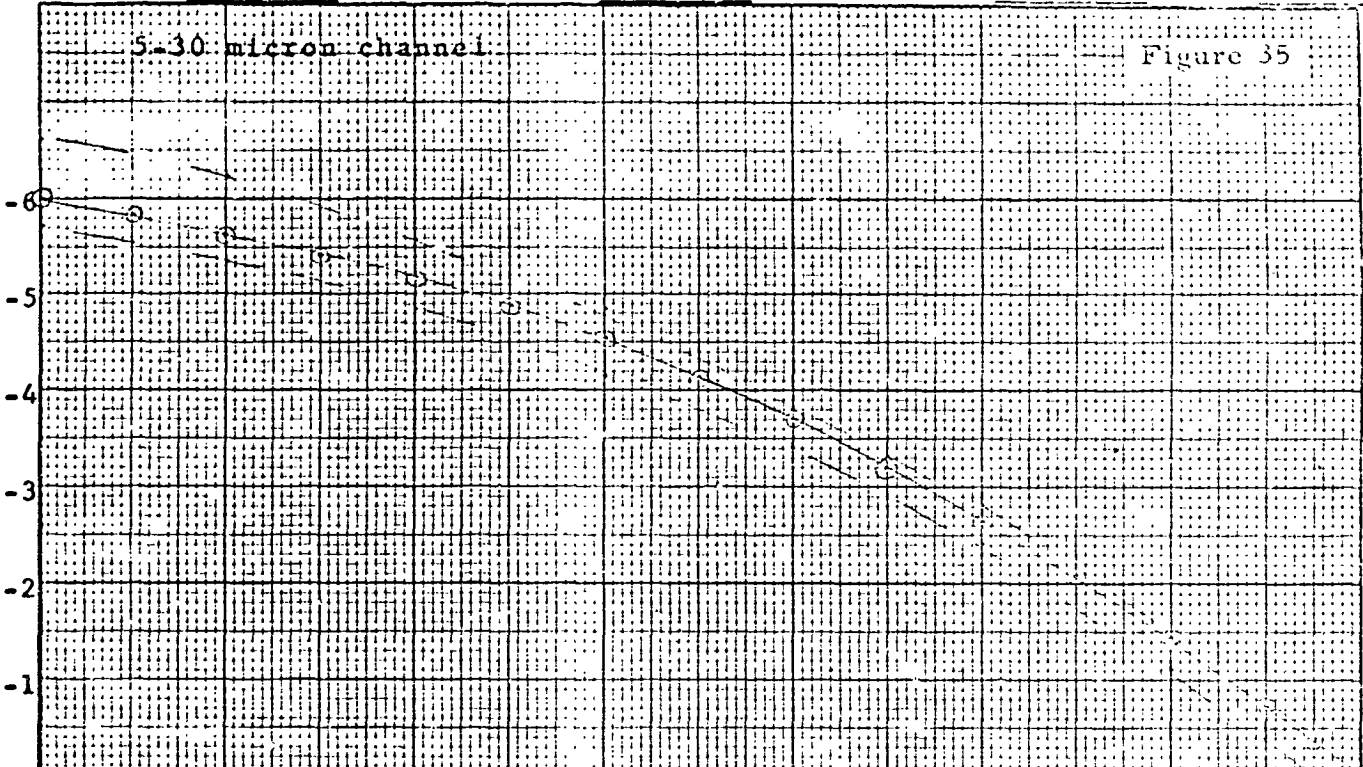
35

System # *F-6* Scanner Temp *0°C* Module Temp *0°C* Date *1/15/55*

5-30 micron channel

Figure 35

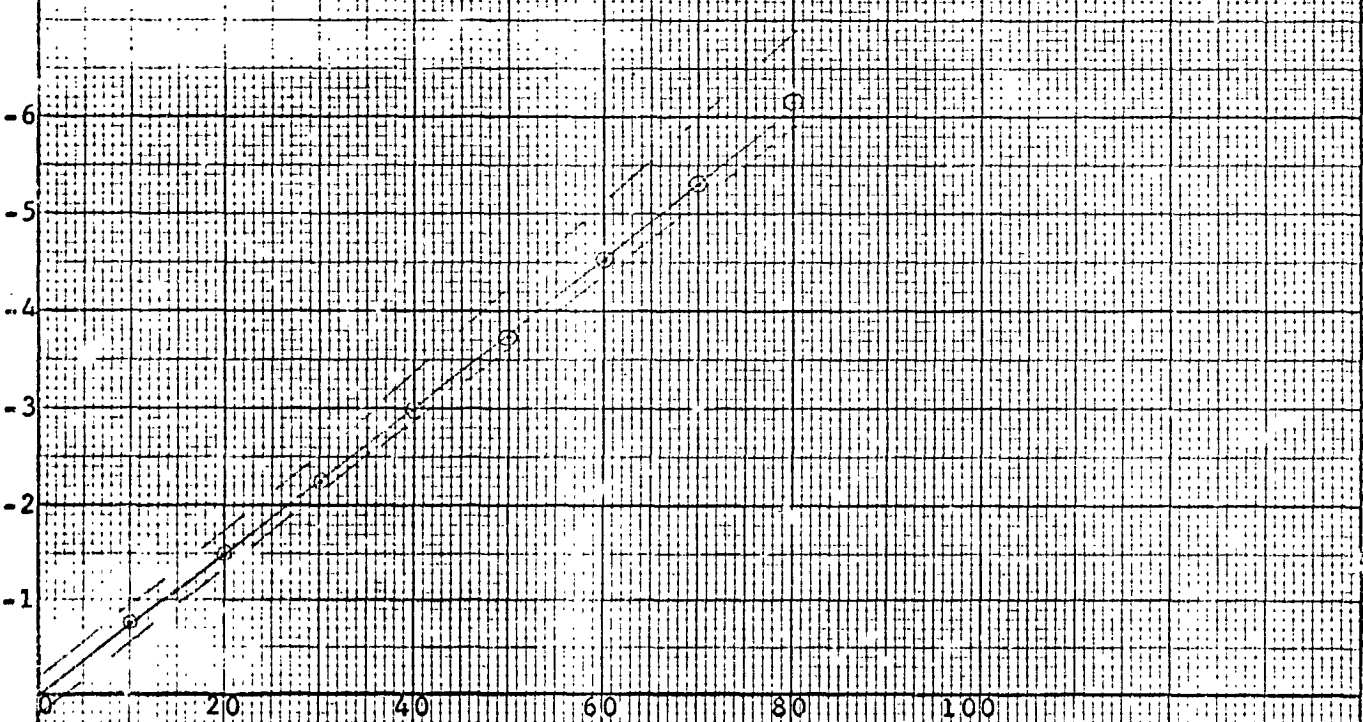
MRIR Channel Output (Volts dc)



180°K	200°K	220°K	240°K	260°K	280°K	300°K	320°K
-93°C	-73°C	-53°C	-33°C	-13°C	+7°C	+27°C	+47°C
Target Temperature							

0.2-4 micron channel

MRIR Channel Output (Volts dc)



Albedo (%)

E DIE N CO
MADE IN U. S. A.

ND. 2-70 UZGEN .PH. 1
20 X 20 PER INCH

MRIR Calibration Curves (D)

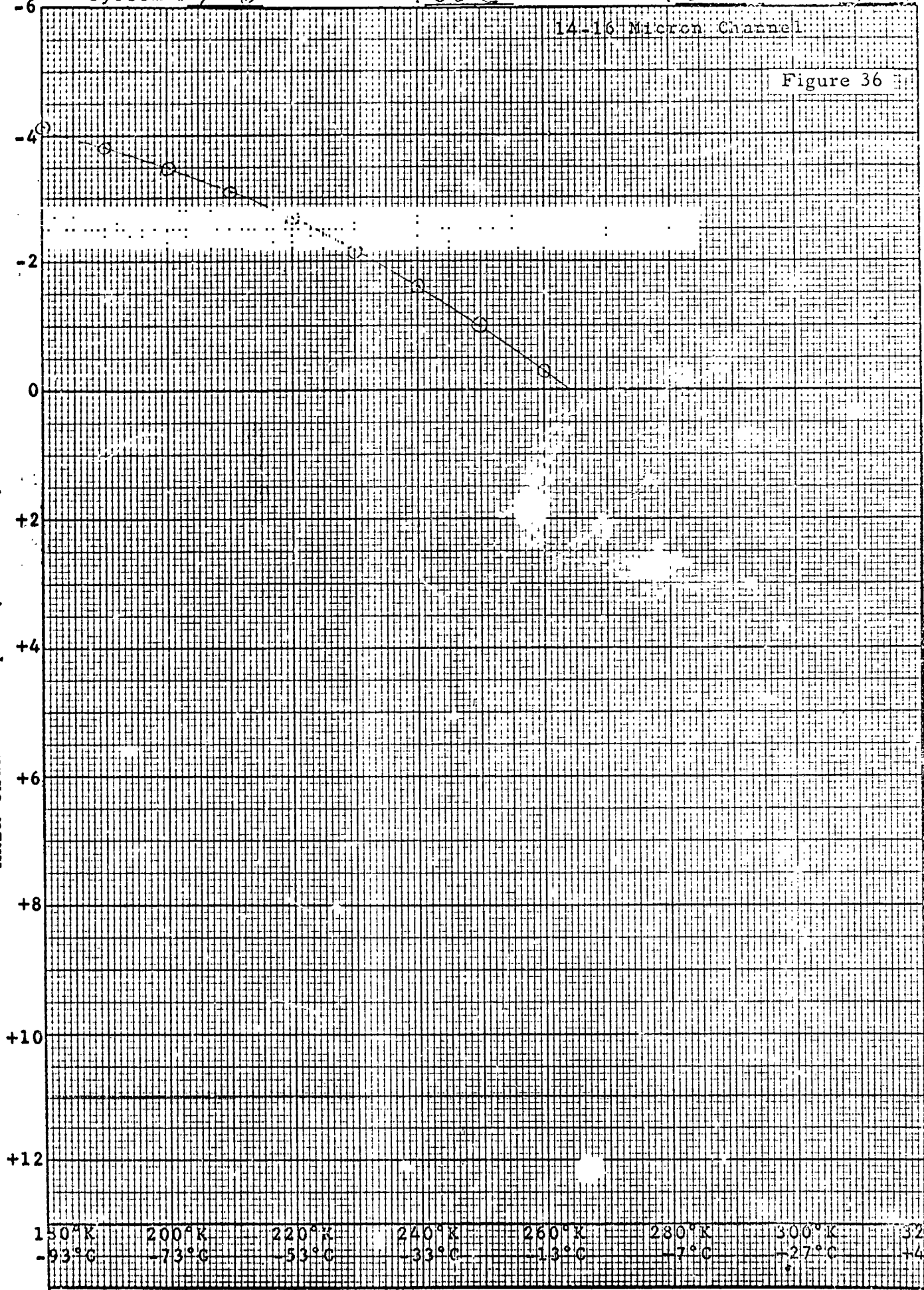
(41)

System # F-6 Scanner Temp 50°C Module Temp 50°C Date 1/25/65

14-16 Micron Channel

Figure 36

MRIR Channel Output (Volts dc)



Target Temperature

EUGENE DIETZGEN CO.
MADE IN U. S. A.

NO. 340R-20 DIETZGEN GRAPH PAPER
20 X 20 PER INCH

MRIR Calibration Curves

(42)

System # *F-6* Scanner Temp *40°C* Module Temp *40°C* Date *1/25/63*

14-16 Micron Channel

Figure 37

MRIR Channel Output (Volts dc)

-6
-4
-2
0
+2
+4
+6
+8
+10
+12

180°K 200°K 220°K 240°K 260°K 280°K 300°K 320°K
-93°C -73°C -53°C -33°C -13°C -7°C -27°C -17°C

Target Temperature

EUGENE DIETZGEN CO.
MADE IN U. S. A.

NO. 340R-20 DIETZGEN GRAPH PAPER
20 X 20 PER INCH

MRIR Calibration Curves

System # F-6 Scanner Temp 25°C Module Temp 25°C Date 1/27/65

②

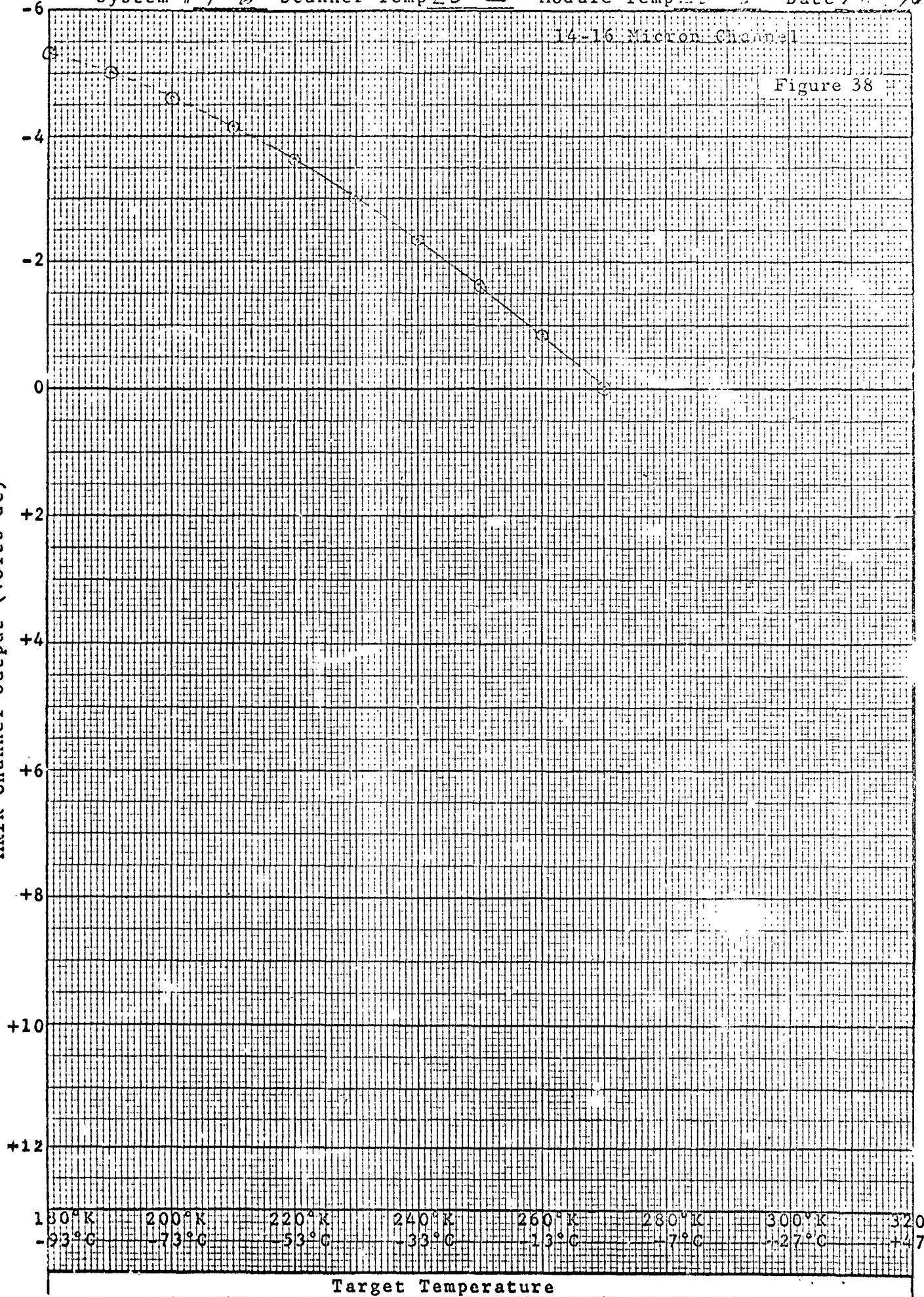
14-16 Micron Channel

Figure 38

EUGENE DIETZGEN CO.
MADE IN U. S. A.

NO. 34DR-20 DIETZGEN GRAPH PAPER
20 X 20 PER INCH

MRIR Channel Output (Volts dc)



Target Temperature

MRIR Calibration Curves

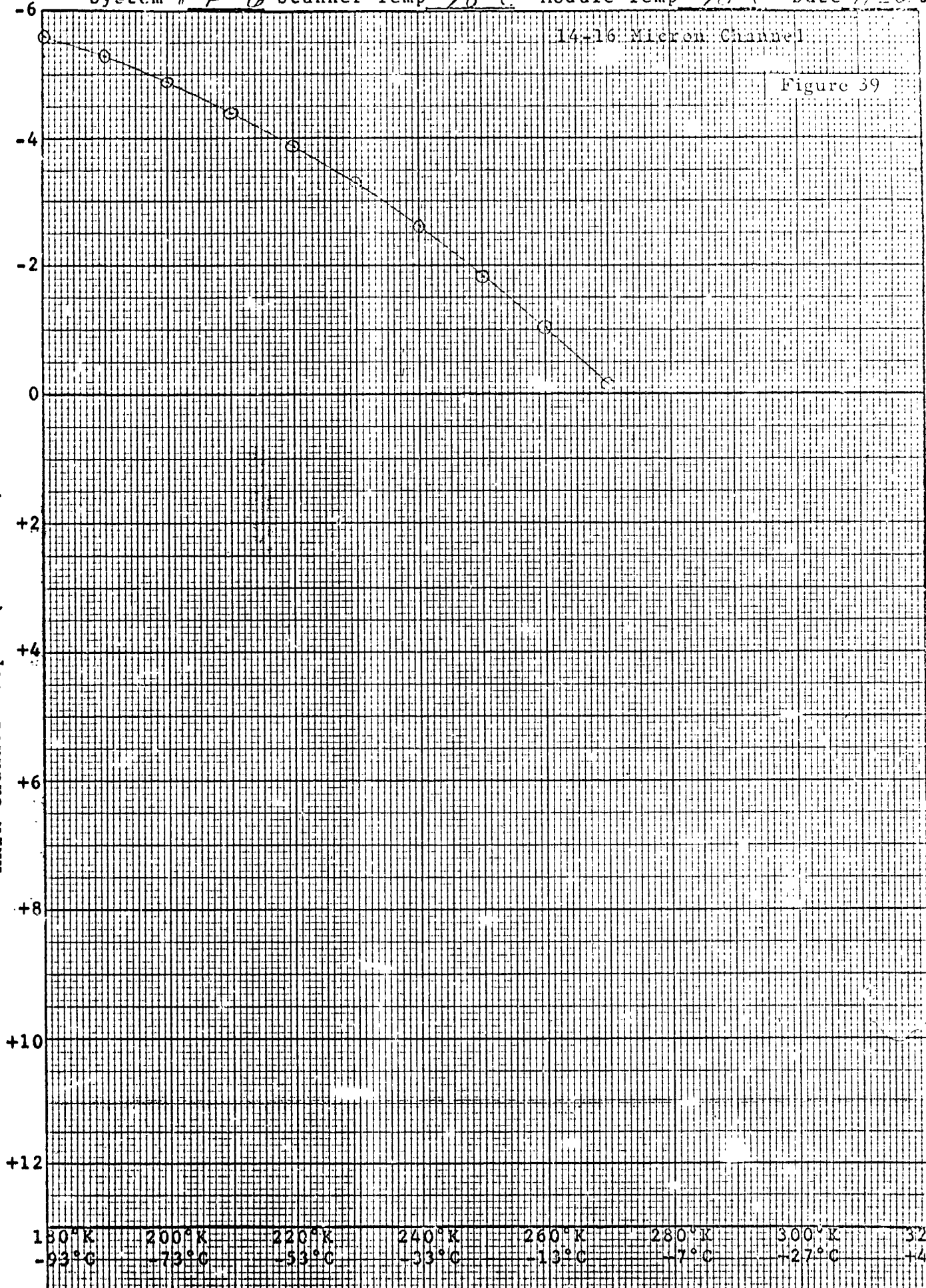
System # F-6 Scanner Temp 10°C Module Temp 10°C Date 1/26/65

39

14-16 Micron Channel

Figure 39

MRIR Channel Output (Volts dc)



Target Temperature

EUGENE DIETZGEN CO.
MADE IN U. S. A.

NO. 34DR-20 DIETZGEN GRAPH PAPER
20 X 20 PER INCH

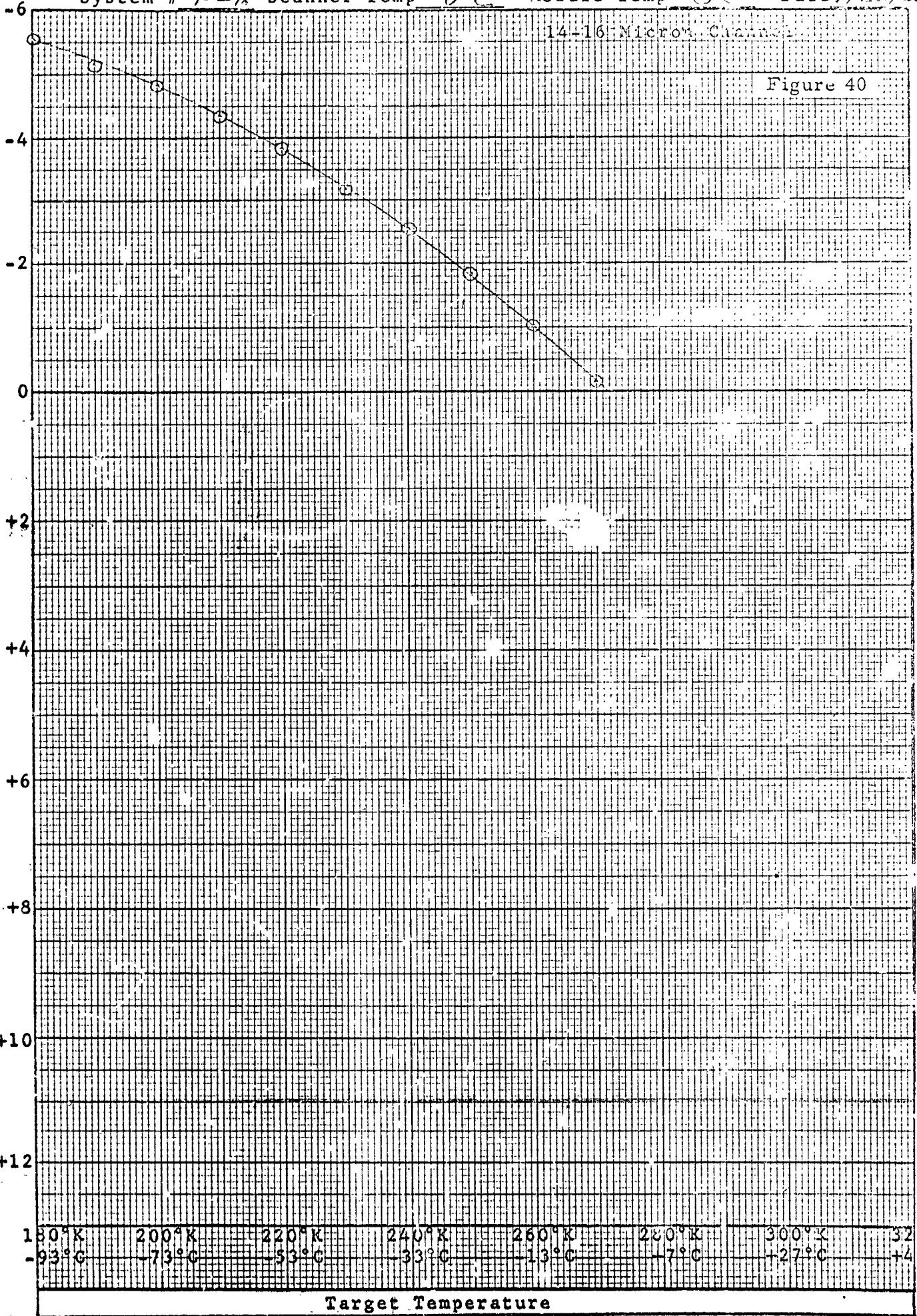
MRIR Calibration Curves

System # F-1 Scanner Temp 0°C Module Temp 0°C Date 1/26/65

14-16 Micro Channel

Figure 40

MRIR Channel Output (Volts dc)



EUBENE DIETZGEN CO.
MADE IN U. S. A.

NO. 340R-20 DIETZGEN GRAPH PAPER
20 X 20 PER INCH

Target Temperature

Section 3

F-2 MRIR CHECK-OF-CALIBRATION MEASUREMENTS

Check-of-calibration measurements were performed on the F-2 MRIR after the radiometer had been subjected to orbital simulation testing at NASA. The measurements were made at 25°C radiometer temperature.

The check-of-calibration data that were obtained from these measurements were compared with the final calibration data that had been obtained approximately a year earlier on the F-2 MRIR. The results of this comparison are shown in Figures 41 through 43.

It can be seen from these figures that very little change in calibration had occurred in the F-2 MRIR over a period of one year and after exposure to an orbital simulation environment.

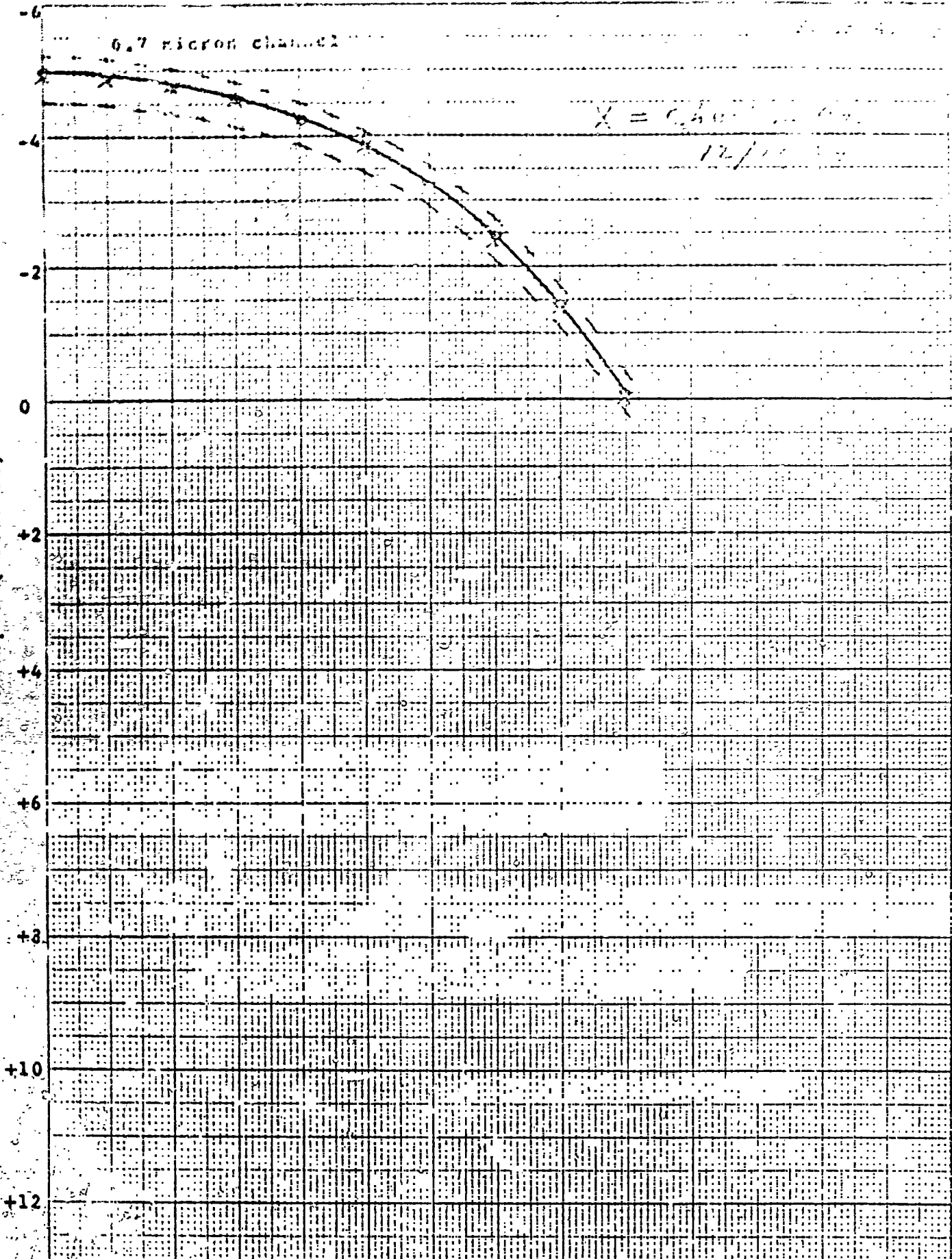
MPIR Calibration Curves (6)

System 2 Scanner Temp _____ Module Temp _____

0.7 micron channel

$X = C_{10} T^{10}$
12/11/72

MPIR Channel Output (Volts dc)



Target Temperature

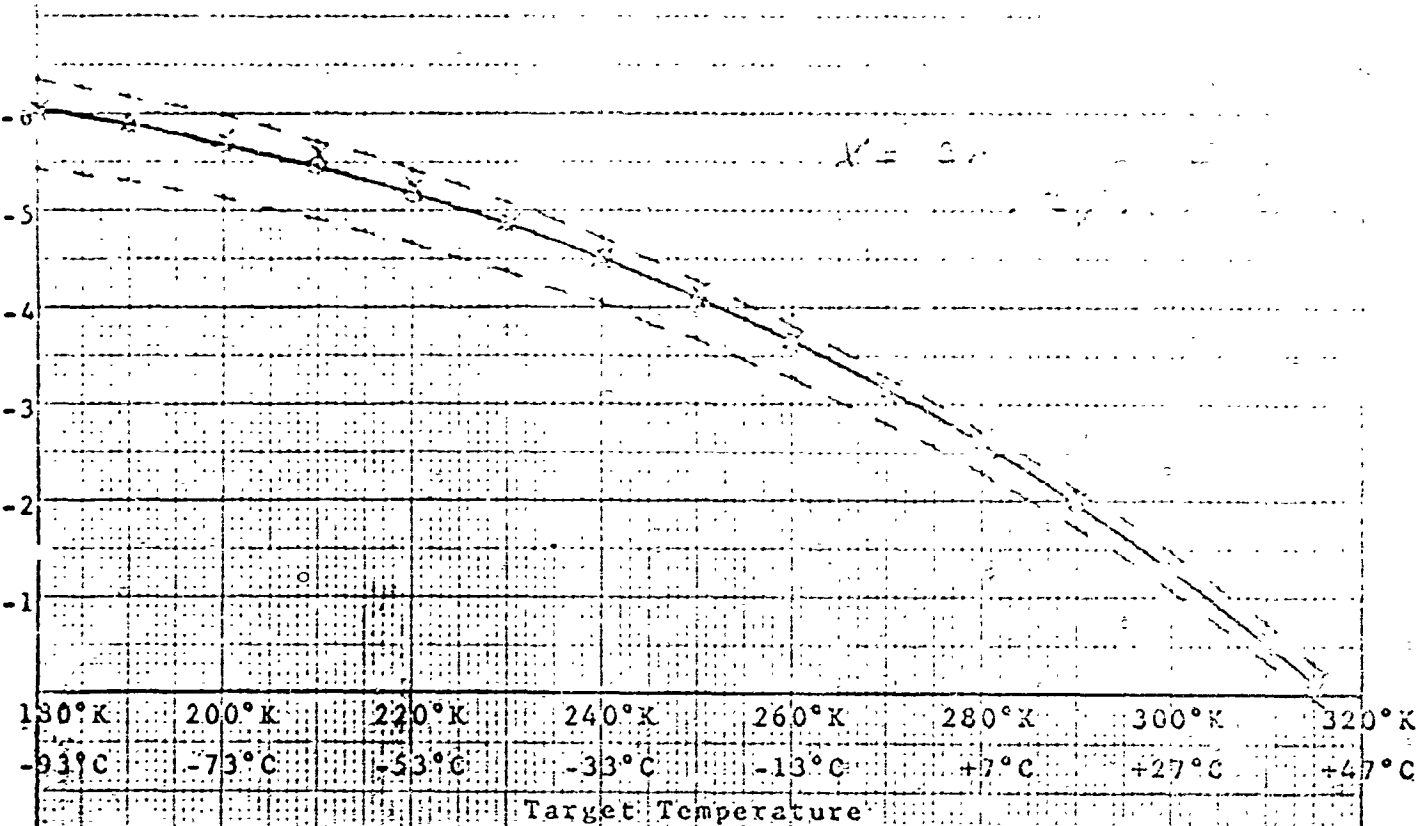
C. O. DI...
MADE IN U.S.A.

20 X 20 PER INCH

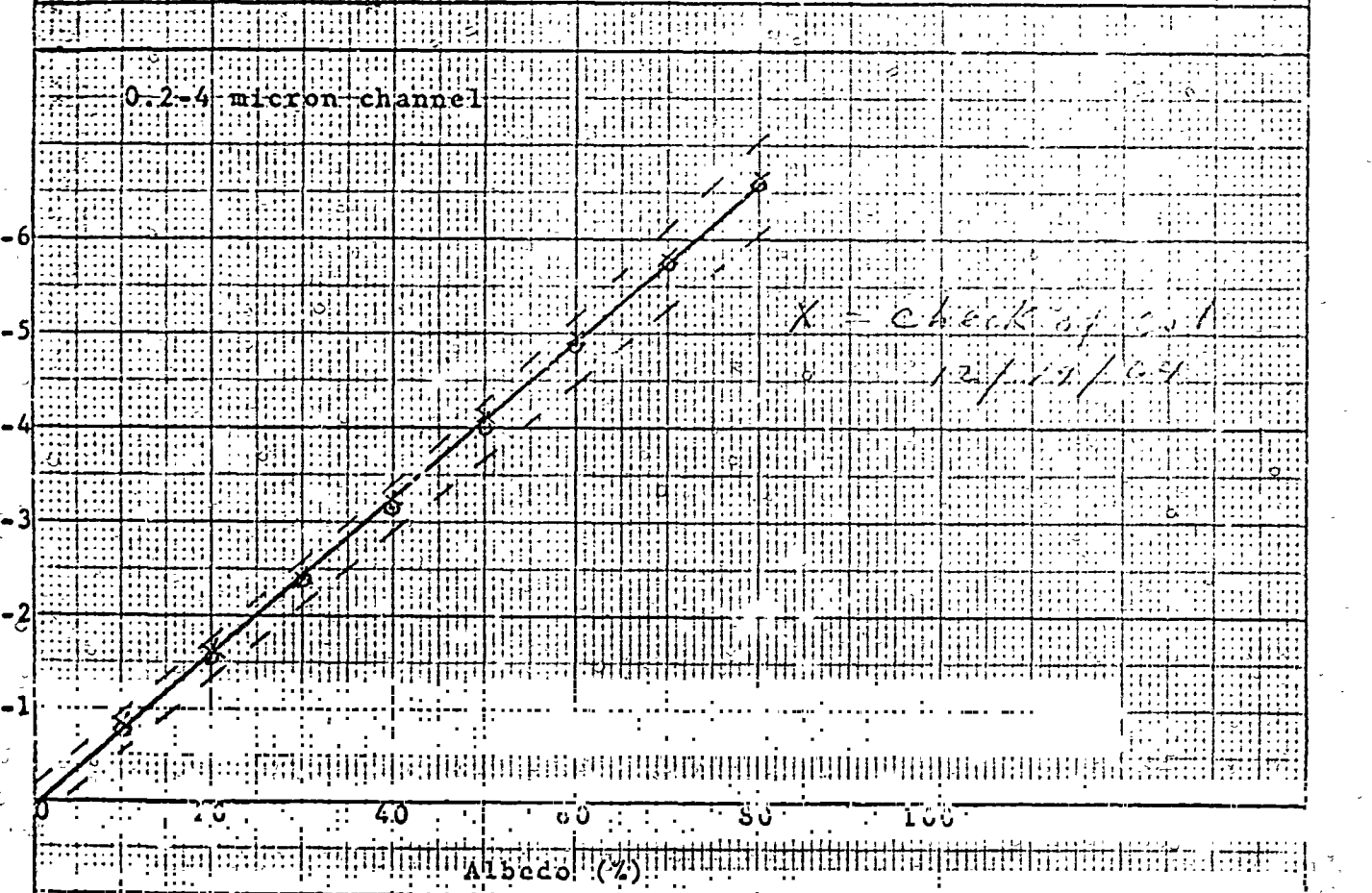
System - Scanner 7

5-30 micron channel

MRIR Channel Output (Volts dc)



MRIR Channel Output (Volts dc)



GEN. ELECTRIC DIVISION OF MCO INC. MADE IN U.S.A.

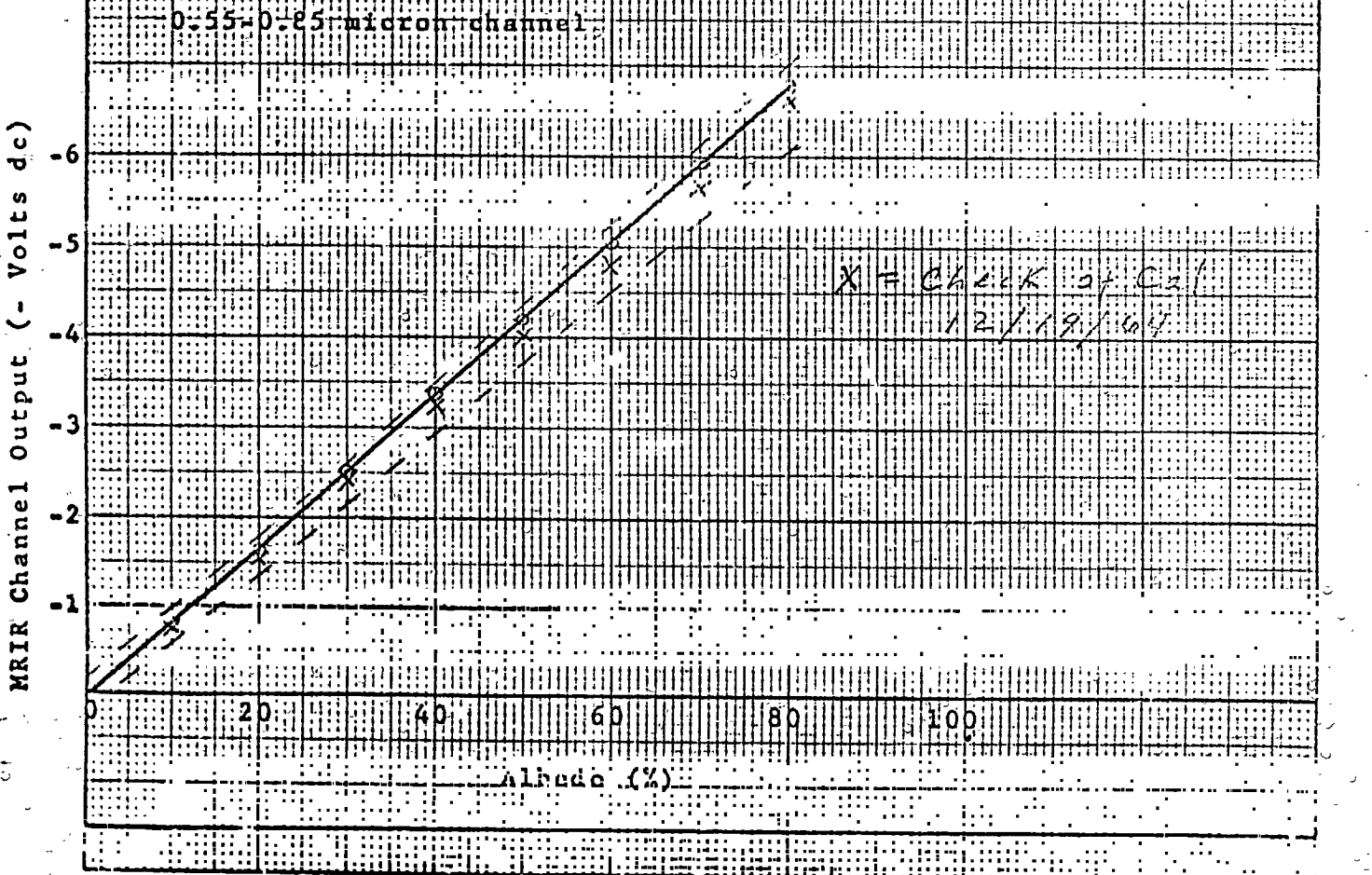
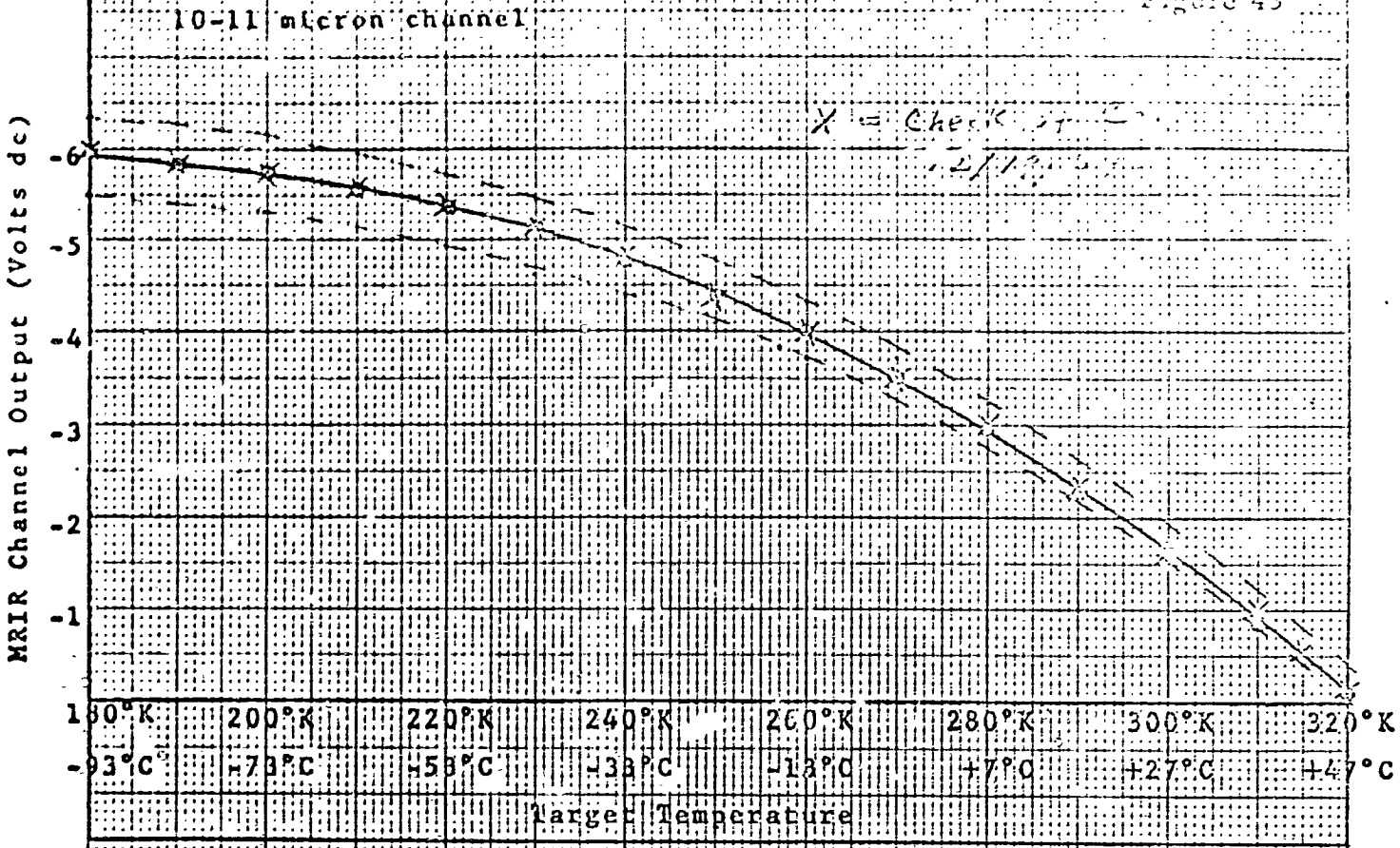
NO. 1201 GEN. 20 X 20 PER INCH

MRIR Calibration Curves (D)

(33)

System # F-2 Scanner Temp 55°C Module Temp 55°C Date 1/12/64

Figure 43



VEDI NCI
MADE IN U.S.A.

NO. 34DR-20 NITZGEN GRAPH PAPER
200mm PERFORATED

Section 4

ANALYSIS OF F-2 MRIR OFFSET CIRCUITRY BEHAVIOR
DURING ORBITAL SIMULATION TESTING AT NASA

An analysis was performed on a limited portion of the test data obtained during the orbital simulation tests conducted by NASA on the F-2 MRIR. The purpose of this analysis was to determine whether the offset generating circuits of the three MRIR thermal channels functioned properly under an orbital simulation environment when the MRIR was protected by the NASA designed thermal radiation shield.

On the basis of the results of the analysis, it appears that the errors introduced into the radiometer by thermal gradients set up by the orbital simulation environment are less than or on the order of magnitude of the combined MRIR calibration errors and measurement errors associated with the tests. These errors are estimated to be approximately the equivalent of ± 0.1 volt (radiometer output) or $\pm 2^{\circ}\text{C}$ (scene temperature) — the voltage error being applicable to the upper portion of the MRIR calibration curves (low scene temperature) and the temperature error being applicable to the lower portion of the calibration curves (high scene temperature).

However, it should be emphasized that because of the apparent interaction between the simulated space (cryo-walls) and the simulated earth — due to neither being a good blackbody — the analysis could only be performed on a limited portion of the test data and had to be, in part, based on correction factors obtained from the observed interaction of the simulated space and earth — from other portions of the data.

ANALYSIS AND RESULTS

The following describes the analysis that was carried out and the results that were obtained.

Basis

If the MRIR offset circuitry is functioning properly (and the radiometer gain has not changed) a one point check-of-calibration should result in a voltage that could be predicted from the calibration curves (which were obtained with the radiometer in a stabilized temperature environment). If the voltage is different from the predicted value, either an offset voltage error exists or a gain change has occurred and a second check-of-calibration point would be required.

Because a remote possibility exists that a correct one point check-of-calibration can occur when compensating gain and offset errors occur, a second check-of-calibration point is also desirable.

Gain Correction

The F-2 MRIR was calibrated under two sets of conditions: 1) the electronics module at 25°C and the scanner at different temperatures, and 2) the electronics module and the scanner at the same temperature. However, during the orbital simulation testing the electronics module was always warmer than the scanner. For the three spacecraft temperatures that were analyzed (1°C, 30°C, and 50°C) the average scanner temperature (in the chopper area) was approximately 4°C, 17.5°C, and 27.5°C, respectively, and the electronics module temperature was 12.5°C, 32°C, and 52°C, respectively.

The approach used to correct the calibration curves for the temperature conditions that existed was as follows:

1. The calibration curves (for the scanner and electronics module at the same temperature) were interpolated to obtain a curve which corresponded to the indicated scanner temperature. For example, for the 4°C scanner

temperature, values falling 0.4 of the way between the 0°C calibration curve and the 10°C calibration curve were used to define a new curve.

2. The voltage values defining the new calibration curve generated in step (1) were multiplied by a correction factor to take into account the fact that the module is at a higher temperature. Information for this correction factor is located on pages 67 through 69 of Section 12 (Electronics Test Data) in the F-2 Data Book. Although these gain data only represent four points between 0°C and 50°C, a reasonable gain correction factor is obtained by plotting the gain values as a function of temperature (ambient temperature being approximately 25°C) and drawing a best-fit curve. The results obtained by doing this yielded the gain correction values presented in Table 1.

Table 1. Gain Correction Values for F-2 MRIR

Temperature Change (°C)	Channel		
	6.7μ (%)	10-11μ (%)	5-30μ (%)
4 to 12.5	+1.5	+0.65	+1.25
17.5 to 32	+2.5	+1.5	+2.2
27.5 to 52	+3.5	+3.5	+3.0

The results of correcting the values obtained in step (1) by the values given in Table 1 are shown in Figures 44 through 52. The curves shown in these figures more closely represent the calibration curves that should be used for the 10°C, 30°C, and 50°C spacecraft runs. Although the resultant curve corrections are relatively small they must be taken into account since they are of the order of magnitude of the errors we are looking for.

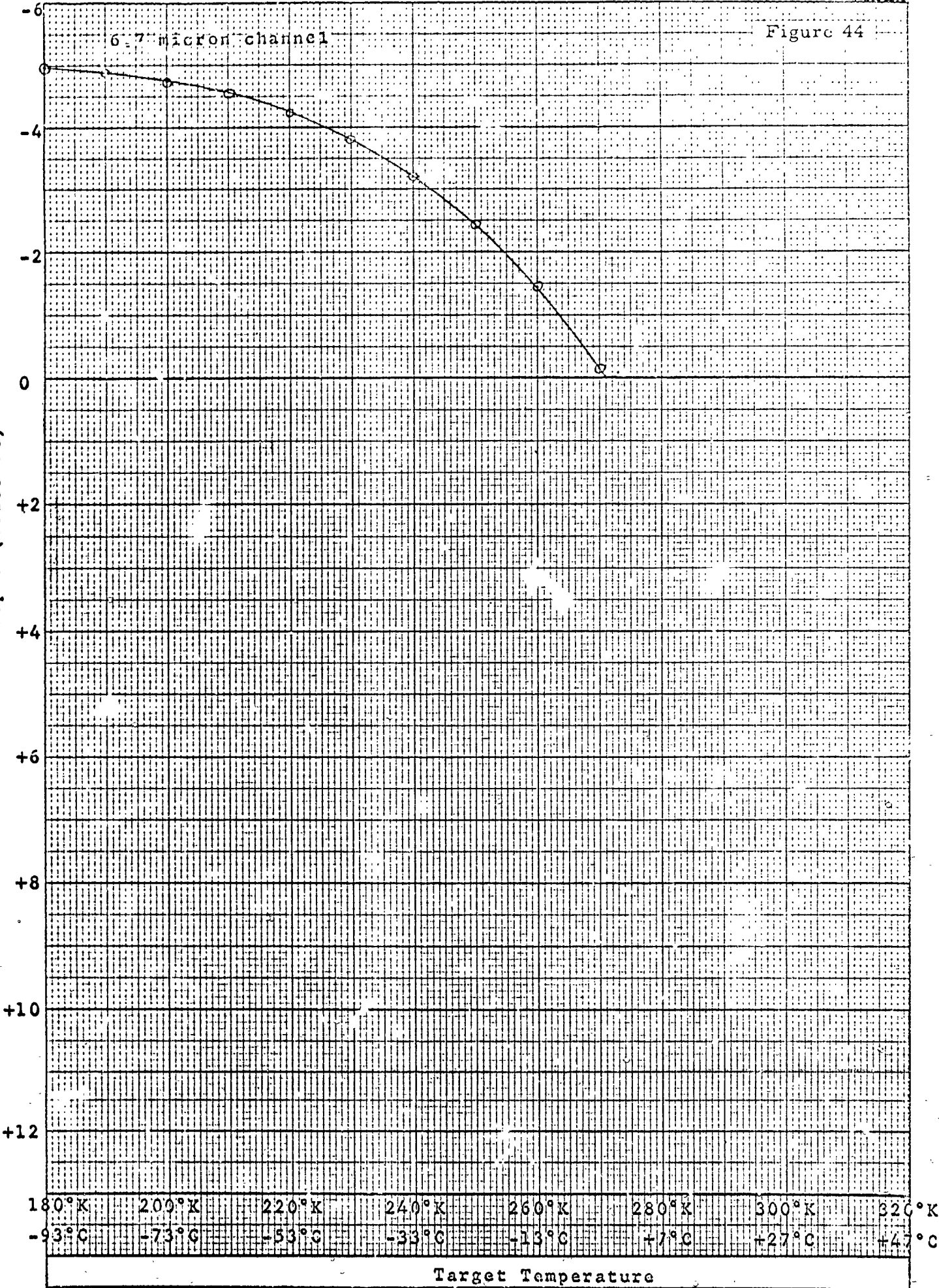
MRIR Calibration Curves

System # F-2 Scanner Temp 4°C Module Temp 12.5°C Date 3/9/60

6.7 micron channel

Figure 44

MRIR Channel Output (Volts dc)



EUGENE DIETZEN CO.
MADE IN U. S. A.

140. J-UR-20 J.L. ZGEN GRAPH PAPER
20 X 20 PER INCH

Target Temperature

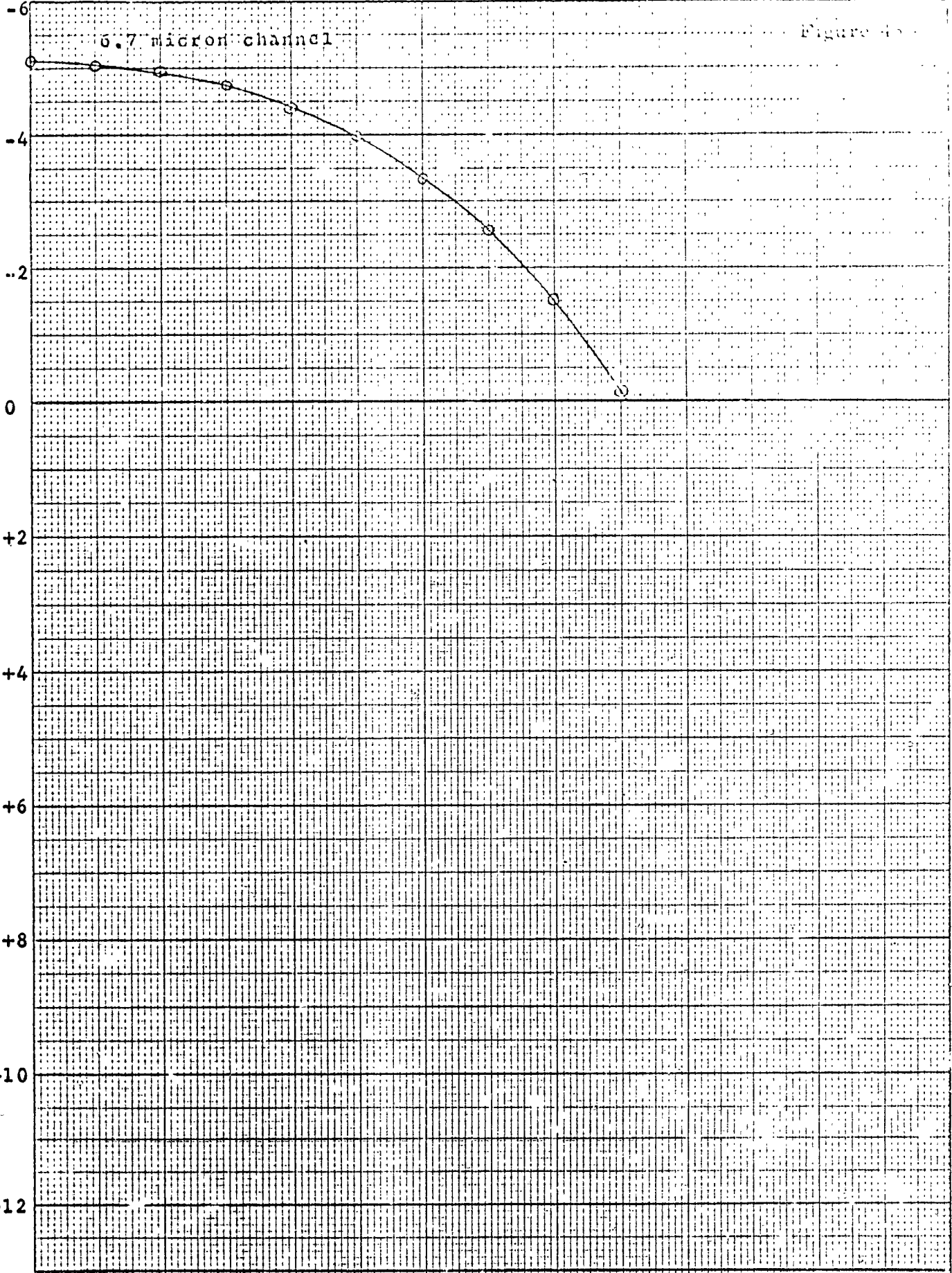
MRIR Calibration Curves

System # F-2 Scanner Temp 17.5°C Module Temp 22°C Date 1/17/57

Figure 10

0.7 micron channel

MRIR Channel Output (Volts dc)



EUGENE DIETZGEN CO.
MADE IN U. S. A.

NO. 340R-20 DIETZGEN GRAPH PAPER
20 X 20 PER INCH

180°K 200°K 220°K 240°K 260°K 280°K 300°K 320°K
-93°C -73°C -53°C -33°C -13°C +7°C +27°C +47°C

Target Temperature

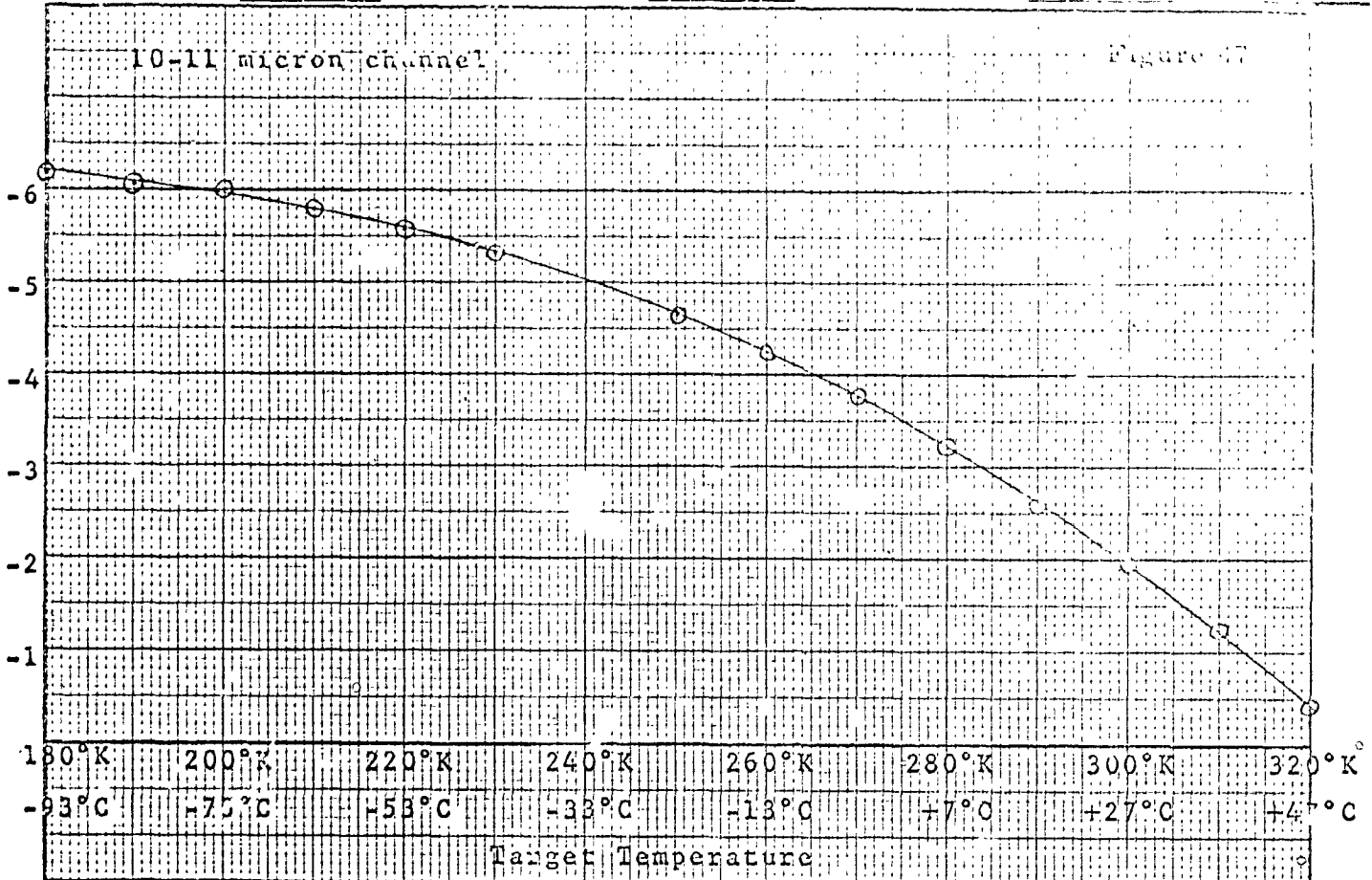
MRIR Calibration Curves

System # F-2 Scanner Temp 4°C Module Temp _____ Date _____

10-11 micron channel

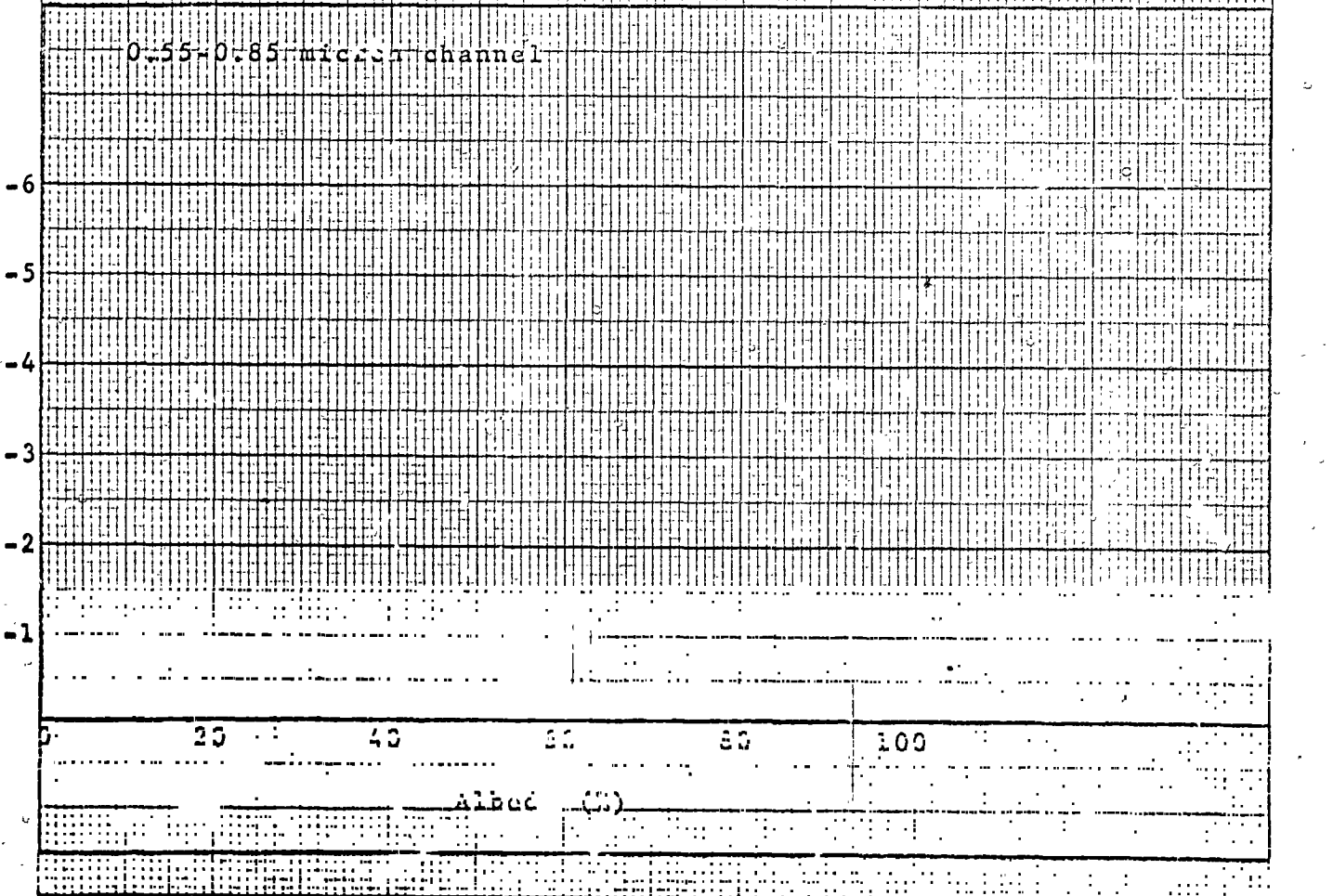
Figure 47

MRIR Channel Output (Volts dc)



0.55-0.85 micron channel

MRIR Channel Output (- Volts dc)

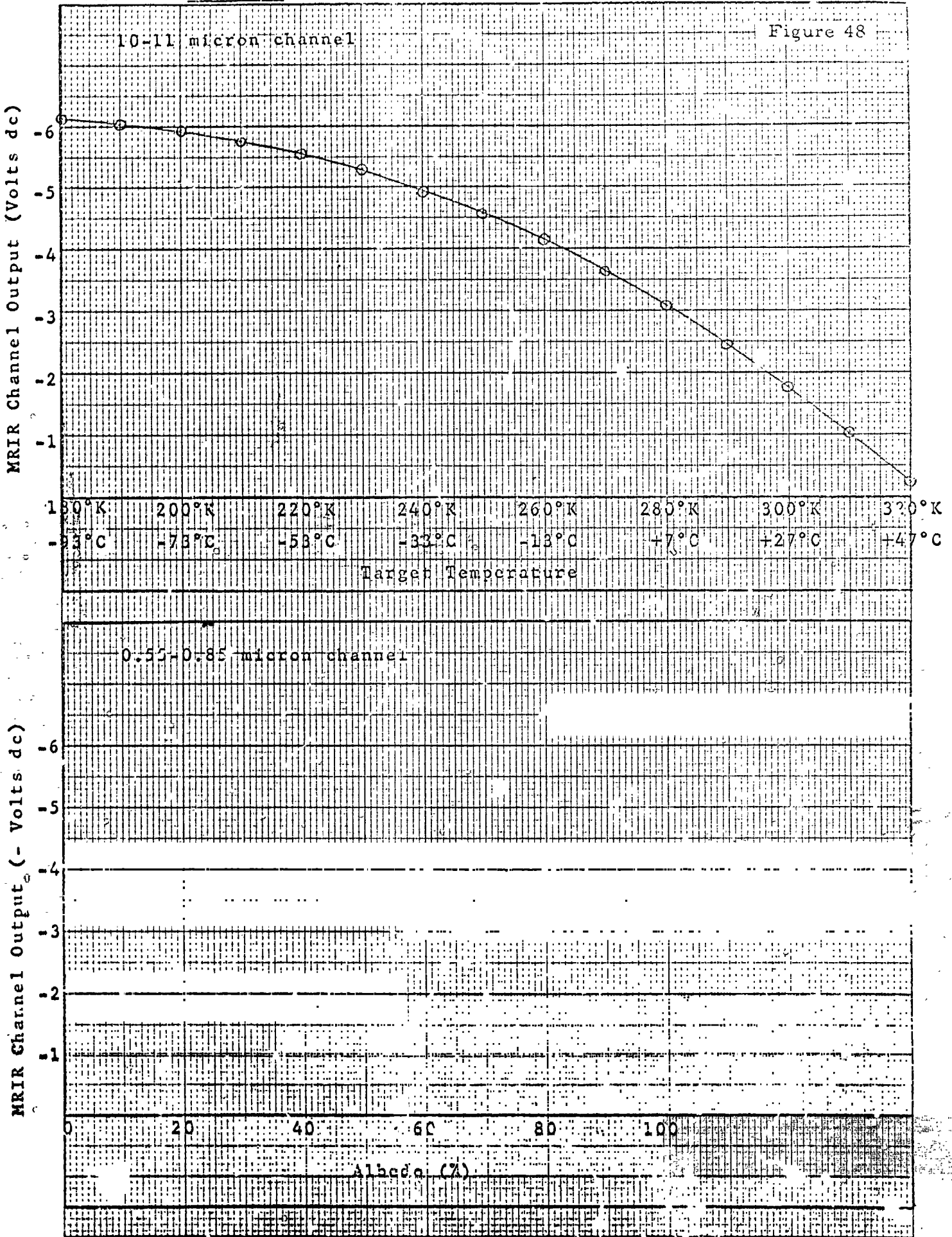


EUGENE DILLIGEN CO. MADE IN U. S. A.

MODEL MR-20 20 PER INCH GRAPH PAPER 20 X 20 PER INCH

MRIR Calibration Curves

System # F-2 Scanner Temp 17.5 °C Module Temp 32 °C Date 8/55



COURNE DIETZGEN CO.
MADE IN U. S. A.

NO. 5433-20 DIETZGEN GRAPH PAPER
20 X 20 PER INCH

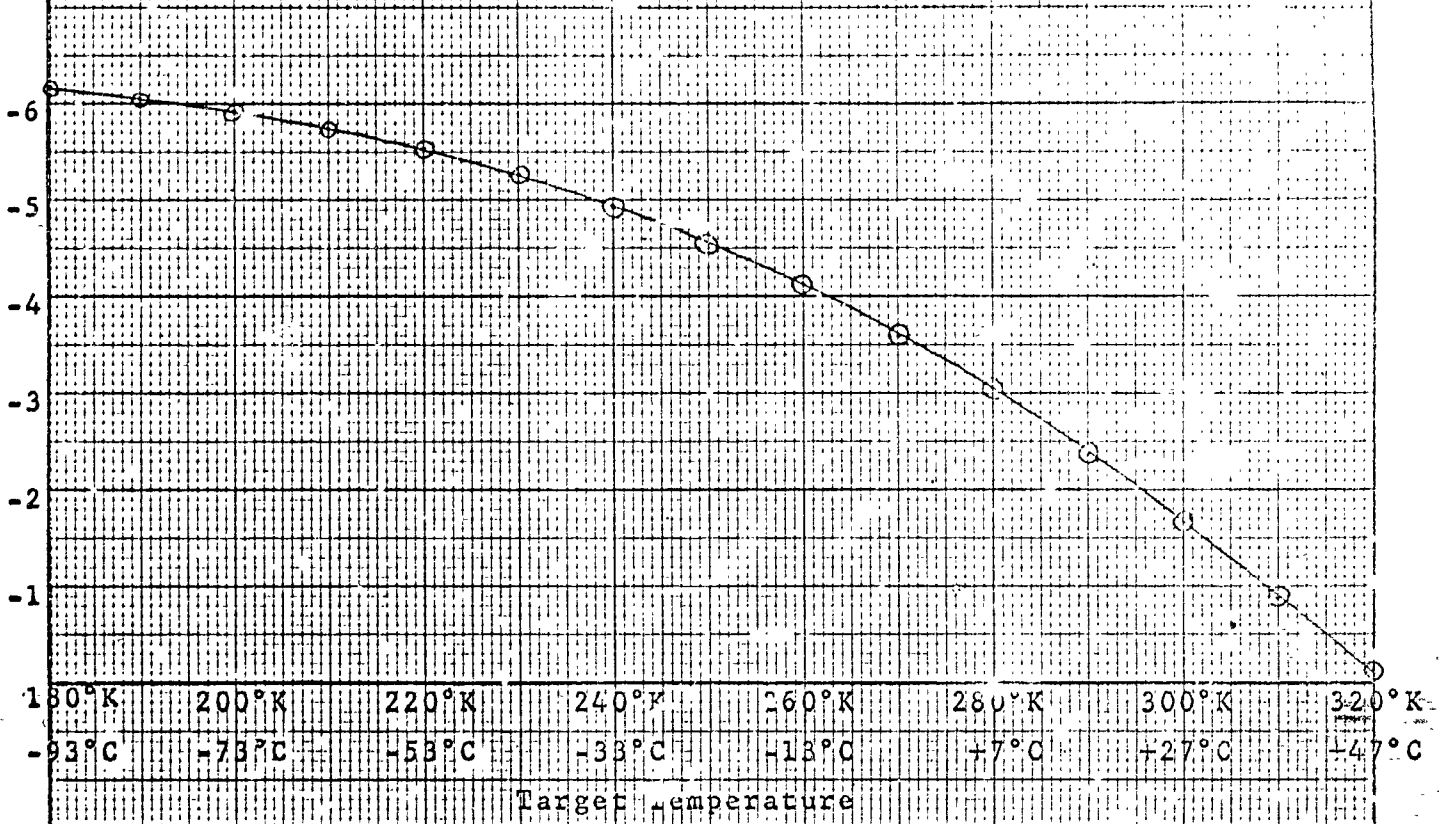
MRIR Calibration Curves

System # F-2 Scanner Temp 27.5°C Module Temp 52°C Date _____

Figure 49

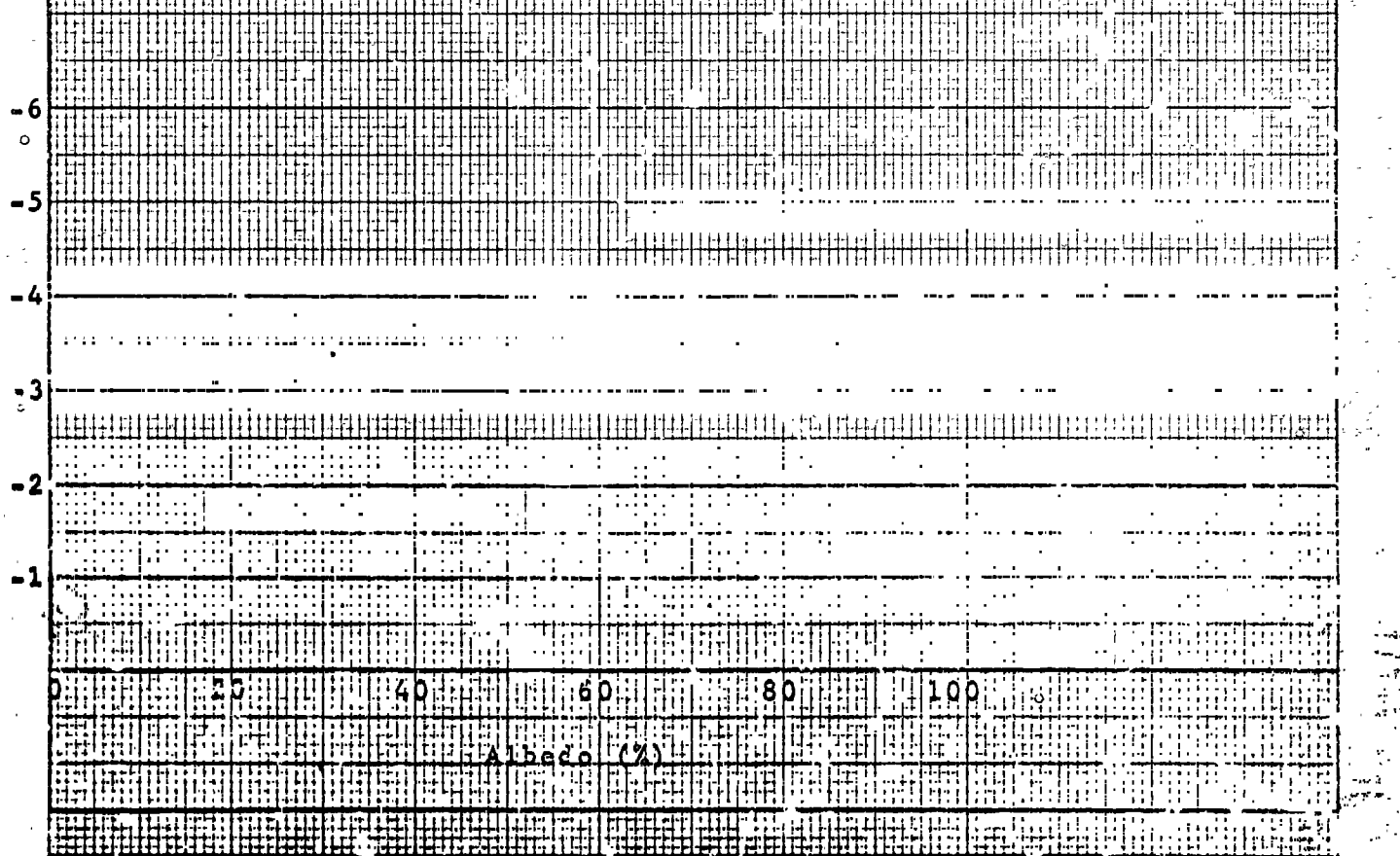
MRIR Channel Output (Volts dc)

10-11 micron channel



MPIR Channel Output (- Volts dc)

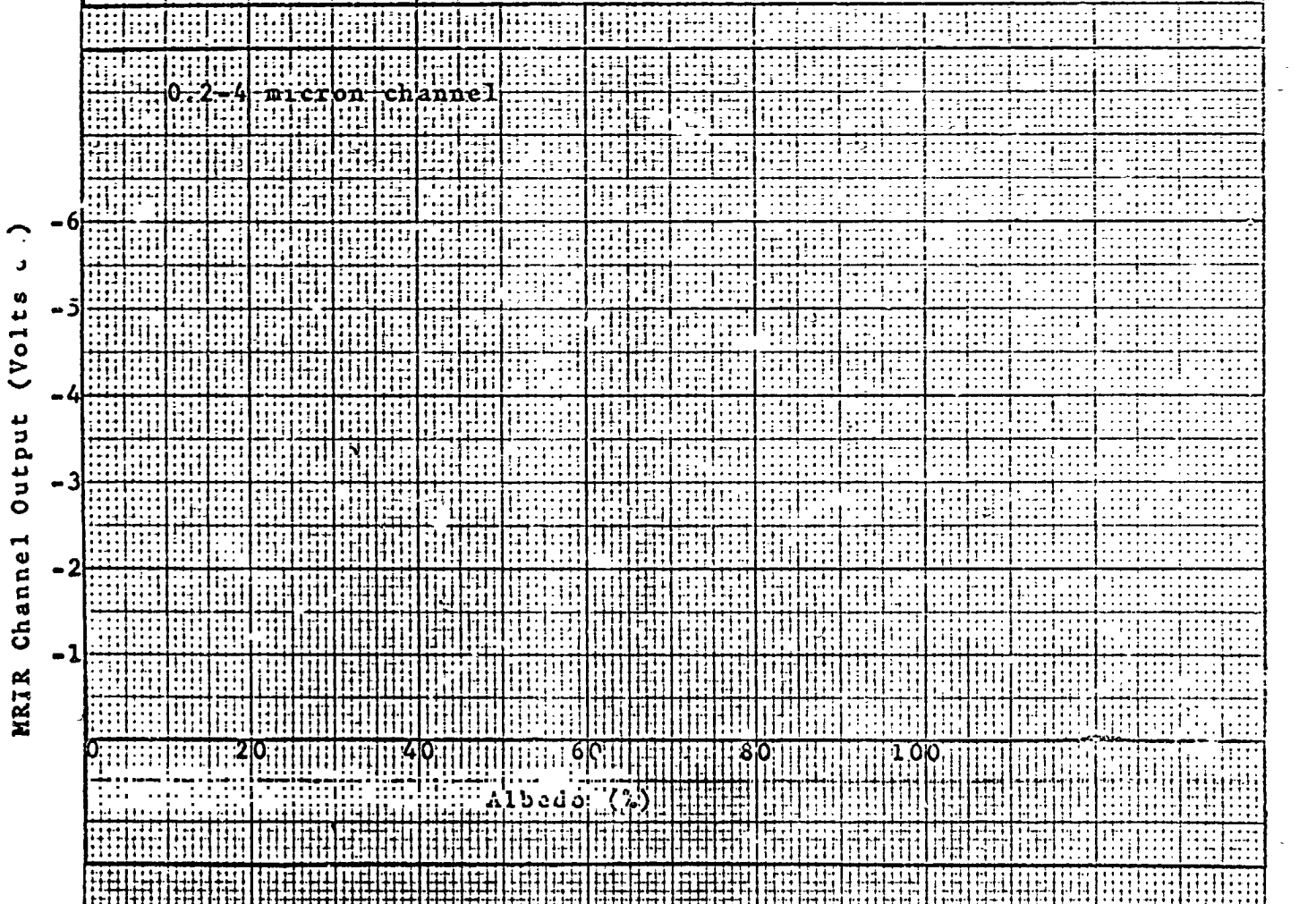
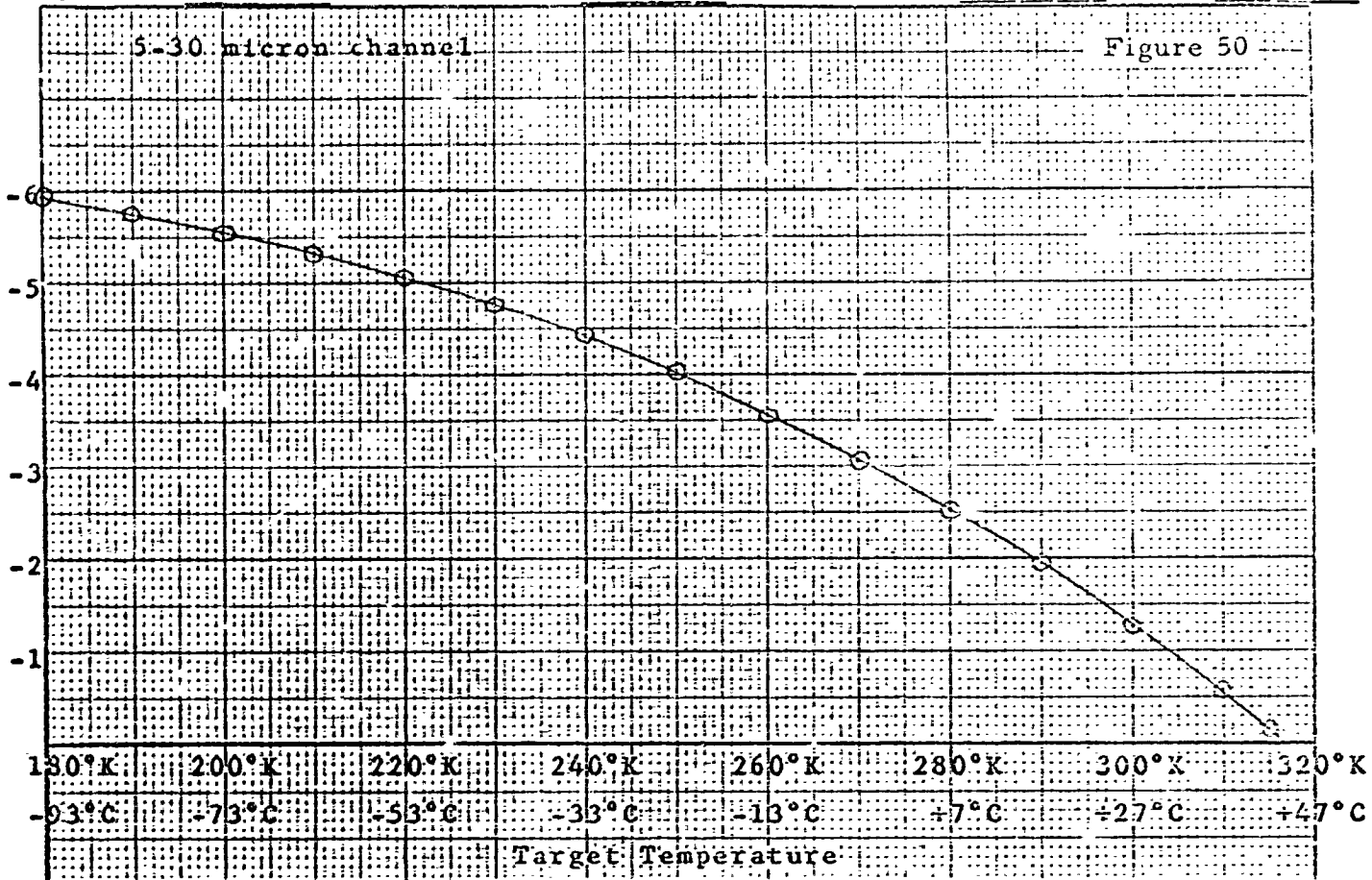
0.55-0.85 micron channel



NO. 20-201-21ZIGERAPH
 28 X .0 PER INCH
 MADE IN U. S. A.

MRIR Calibration Curves

System # F-2 Scanner Temp 4°C Module Temp 12.5°C Date 8/2/55



COURSE DESIGNER C. S. MADE IN U. S. A. NO. 25-10R-25 20 X 20 PER INCH

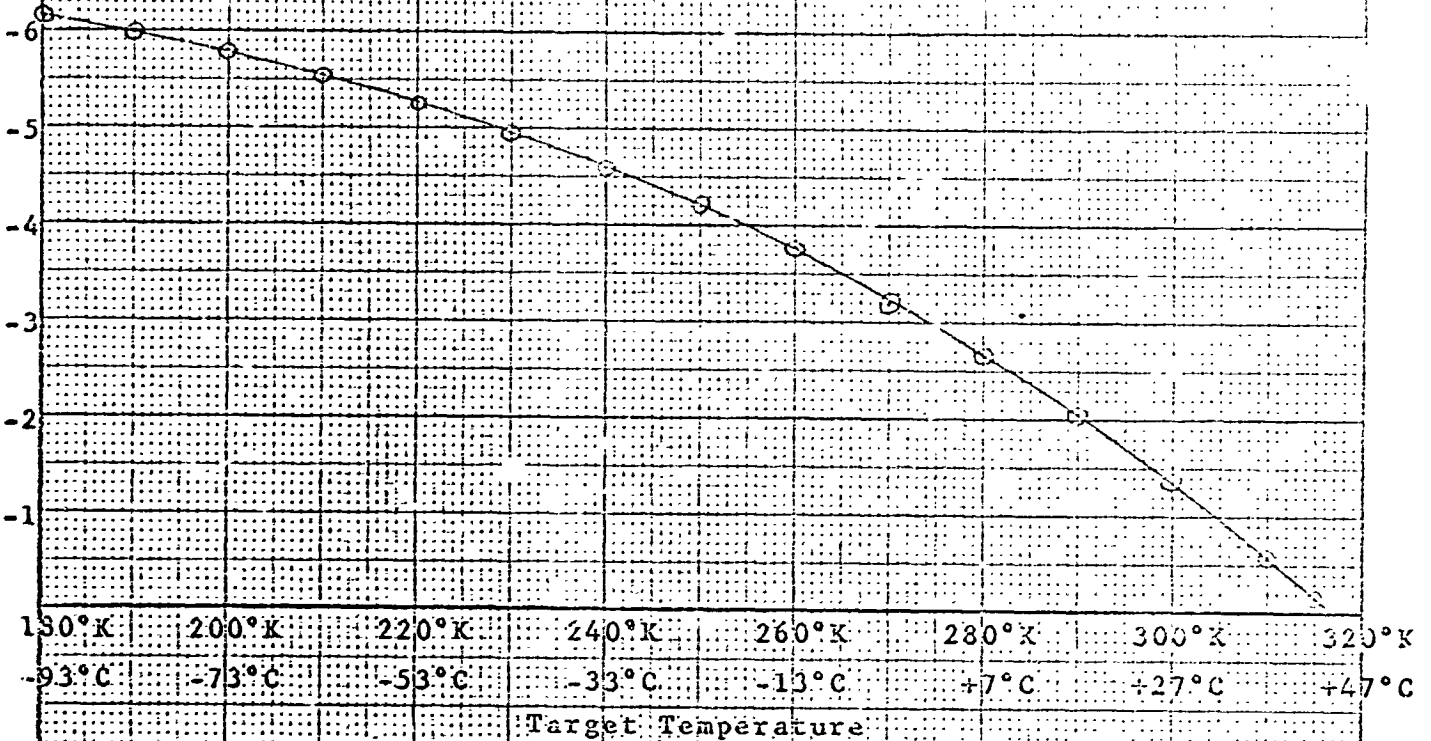
MRIR Calibration Curves

System # *F-2* Scanner Temp *17.5°C* Module Temp *32°C* Date *5/1/67*

5-30 micron channel

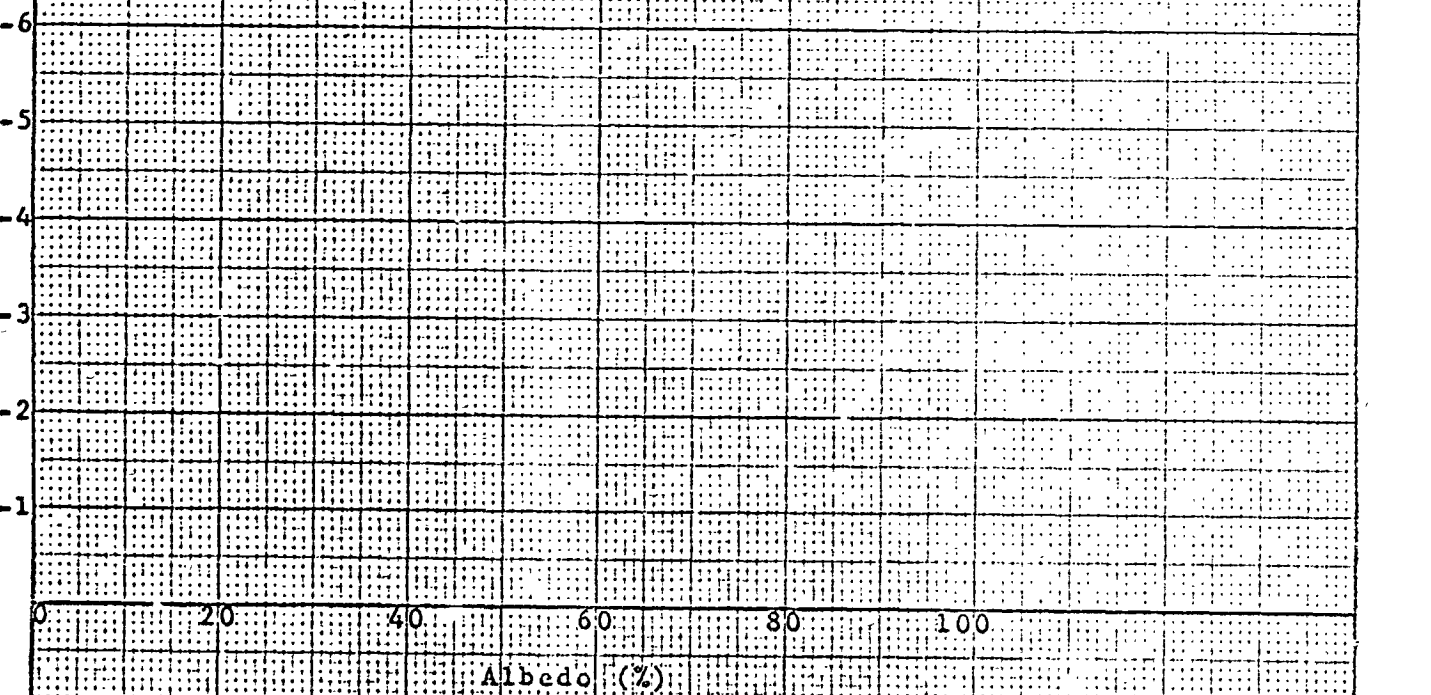
Figure 51

MRIR Channel Output (Volts dc)



0.2-4 micron channel

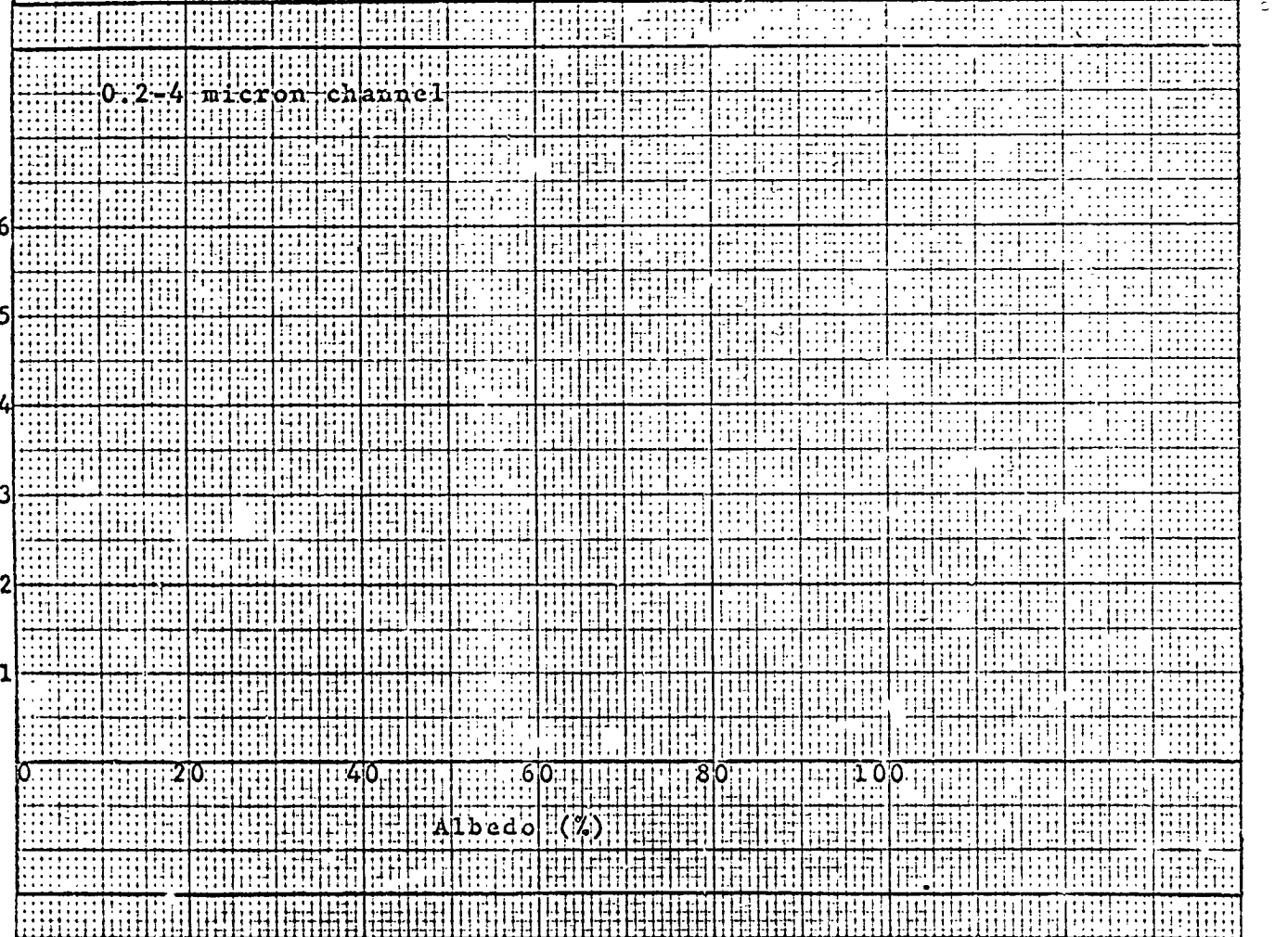
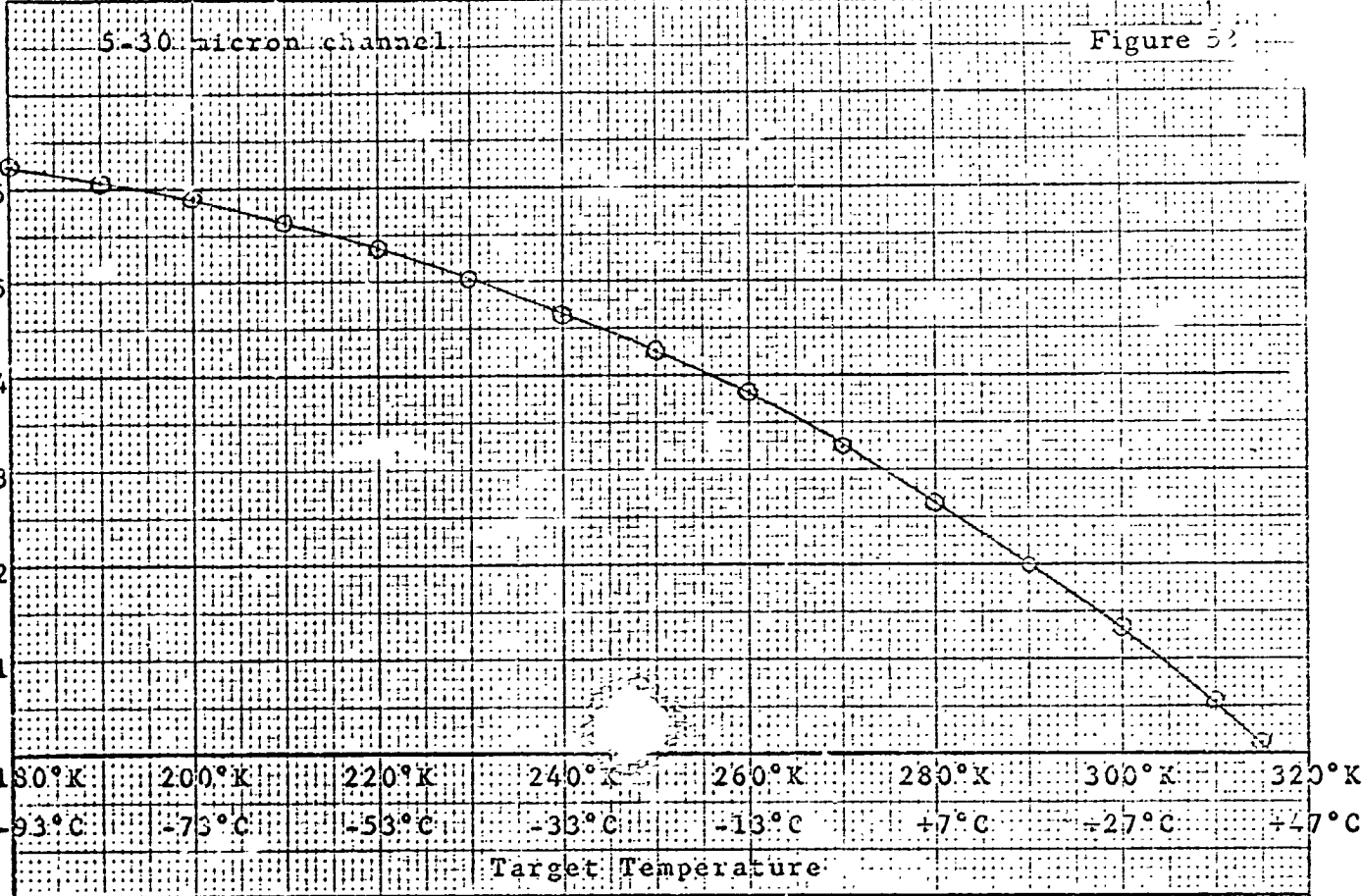
MRIR Channel Output (Volts dc)



MADE IN U. S. A. NCC
 NO. 20 X 20 PER INCH
 MADE IN U. S. A.

MRIR Calibration Curves

System # *F-2* Scanner Temp *27.5°C* Module Temp *50°C* Date *3/21/57*



EUGENE DIETZGEN CO. MADE IN U. S. A.
 NO. 20-R-20 DIETZGEN GRAPH PAPER 20 X 20 PER INCH

Target Emissivity and Radiation Correction

Normally the calibration curves that were obtained (Figures 44 through 52) would be sufficient to evaluate the orbital simulation test data directly to see if the MRIR were producing the correct output voltages when viewing the simulated space target (cryo-walls) and the simulated earth target. However, the space target and the earth target were not good blackbody targets. Therefore, a correction in radiation due to the emissivity being less than 1.0 should be made. This correction should take into account the change in target radiance due both to the decrease in emissivity and the effect of the remaining environment being partially reflected from the target. Unfortunately, this cannot be done directly and indirect correction can only be made for the space target.

This correction is accomplished as follows:

1. It was observed that when the earth temperature was changed from approximately 50°C (as indicated by the MRIR during stage 5 of orbit 8 for the 10°C, 30°C, and 50°C spacecraft runs) to approximately -13°C (stage 8), an apparent change in the cryo-wall (simulated space) radiance occurred.

Care must be taken in evaluating this change to note that the two cryo-walls, as viewed from the MRIR, have different radiance values and that the MRIR was rotated between stage 7 and stage 8. For the analysis performed, the cryo-wall consistently producing the smallest radiation — greatest negative voltage — was chosen. This is the cryo-wall seen by the MRIR after leaving the housing in stage 5 and is the cryo-wall seen just before entering the housing in stage 8.

2. Since the offset voltage (bias off condition) does not show any appreciable change between these two stages, it was assumed that the apparent radiation change was due to the reflection of the earth's radiance from the cryo-walls.

B, noting the change in MRIR output voltage that occurred, when the cryo-wall was being viewed and the earth temperature was changed from 50°C to -13°C temperature, and by comparing this change with the change that would have occurred (in the MRIR voltage outputs for each channel) if the MRIR channels were viewing a blackbody target that was changed from 50°C to -13°C, the percentage of radiation from the earth target that is reflected from the cryo-walls can be determined. The percentage values that were obtained from this analysis are shown in Table 2. Nominal (desirable) MRIR calibration curves (Figures 53 through 55) were used in obtaining the expected voltage change for the three MRIR thermal channels for a 50°C to -13°C blackbody target change.

Table 2. Emissivity Correction Factors

Channel/ Temperature Range (°C)	Spacecraft Temperature					
	10°C		30°C		50°C	
	(%)	(volts)	(%)	(volts)	(%)	(volts)
6.7μ						
50 to -13	3.5		4.0		5.5	
-13 to -196		0.14		0.16		0.22
10-11μ						
50 to -13	8.5		8.5		10.0	
-13 to -196		0.22		0.22		0.26
5-30μ						
50 to -13	7.7		6.4		7.7	
-13 to -196		0.22		0.18		0.22

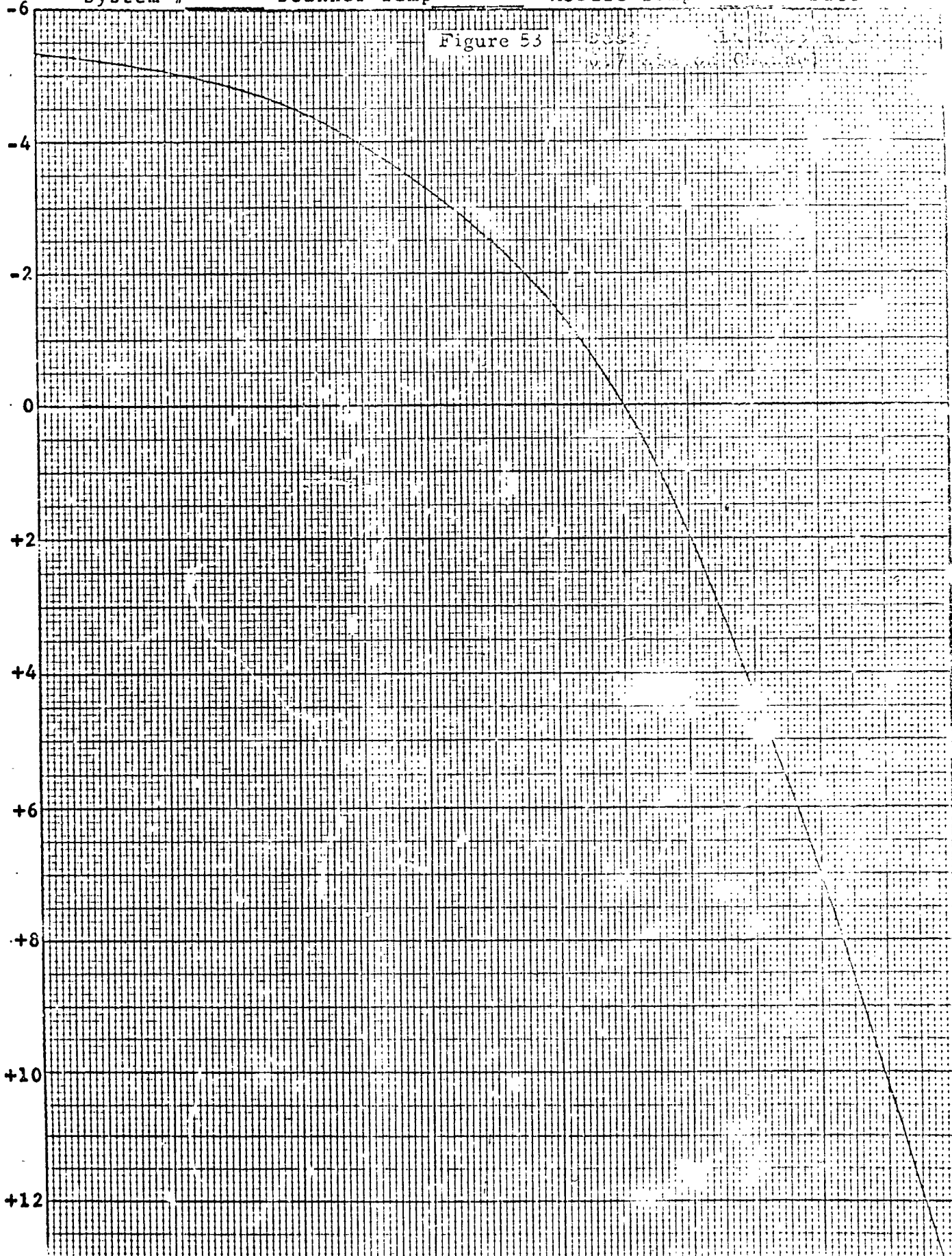
3. Using the percentage values obtained, one can now calculate the change in voltages that would be expected to occur (due to the earth's radiance reflecting off the cryo-walls) if the earth temperature was reduced

MRIR Calibration Curves

System # Scanner Temp Module Temp Date

Figure 53

MRIR Channel Output (Volts dc)



180°K 200°K 220°K 240°K 260°K 280°K 300°K 320°K
 -93°C -73°C -53°C -33°C -13°C 7°C 27°C 47°C

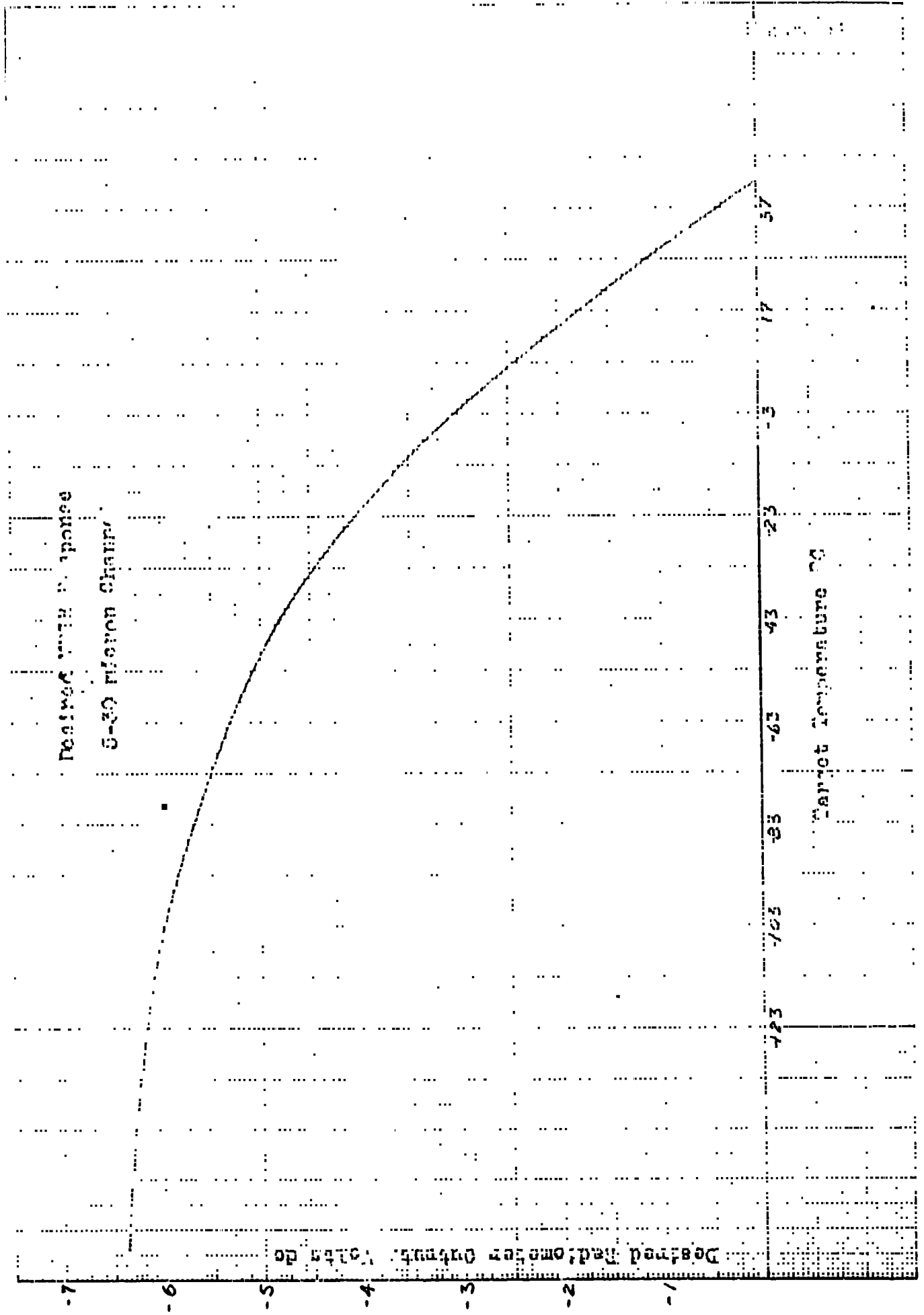
Target Temperature

EUGENE DIETZGEN CO.
MADE IN U. S. A.

NO. 34DR-20 DIETZGEN GRAPH PAPER
20 X 20 PER INCH

NE - JRM - ZDEN - PH - MILLIMETER

E O. N. CC
MADE IN U. S. A.



Desired Rad'ometer Output
5-30 Fusion Chain

Target Temperature °C

Desired Rad'ometer Output: 0.1 to 10

PERKINS ENGINEERING CO.
MADE IN U. S. A.

MODEL NO. 1000
MILLIMETER

NO. 1000

1000

1000

1000

1000

7

6

5

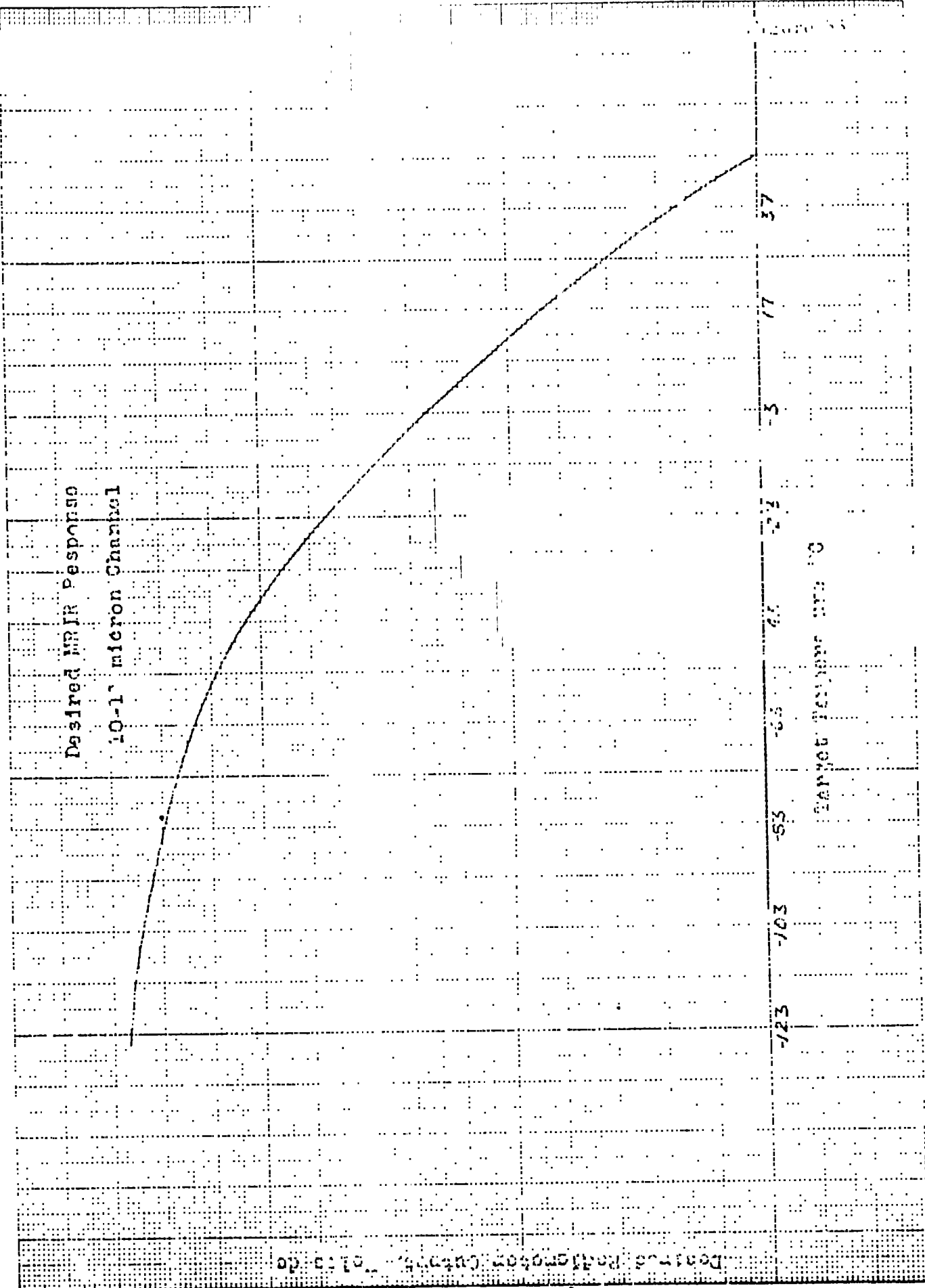
4

3

2

1

Desired IR Response
10-1⁻¹ micron Channel



Desired Response Output

PERKINS ENGINEERING CO.

1000 55

from -13°C to -196°C . These values were calculated and are also shown in Table 2.

These voltage changes calculated represent the error that can be expected to exist in determining the cryo-wall radiance (originally thought to be small enough at liquid nitrogen temperatures so as to be negligible) by the MRIR.

Space Temperature Calibration Point

Although the MRIR thermal channels are only calibrated to -93°C target temperature, the MRIR output voltages expected when viewing space can be obtained by adding the Δ voltage that exists between the voltage representing the -93°C target temperature (for the nominal calibration curves) and -6.4 volts (-5.4 volts for the 6.7-micron channel) to the actual calibrated voltage obtained at -93°C target temperature.*

These Δ voltage values are 0.07, 0.3, and 0.45 volts, respectively, for the 6.7-micron channel, 10- to 11-micron channel, and 5- to 30-micron channel.

When these Δ voltage values are added to the corresponding voltage values for -93°C target temperature shown in Figures 44 through 52, the expected space target values for the 10°C , 30°C , and 50°C spacecraft temperature runs are obtained. These values are shown in Table 3.

The values shown in Table 3 were compared with the actual values recorded (after the emissivity factor, Table 2, had been taken into account) for the 10°C , 30°C , and 50°C spacecraft temperature runs. The results of this comparison are summarized in Table 4.

*The maximum errors that are introduced in determining the MRIR output voltage when viewing space by this method is less than 0.5 percent.

Table 3. Expected MRIR Output Voltages When Viewing Space

Spacecraft Temperature (°C)	Channel		
	6.7 μ (volts)	10-11 μ (volts)	5-30 μ (volts)
10	5.05	6.5	6.4
30	5.17	6.45	6.6
50	5.20	6.45	6.7

It can be seen from Table 4 that relatively good agreement exists between the expected MRIR output voltages and the actual (+ emissivity correction) voltages measured. The average difference is on the order of the test errors that might be expected.

Although no emissivity correction value could be assigned to the simulated earth, it was of interest to compare the temperature values measured by the MRIR (using Figures 44 through 52) to those measured by thermocouples. This was done for stage 8 of orbit 8 for the 10°C, 30°C, and 50°C spacecraft temperature runs. The results are summarized in Table 5. Again, relatively good agreement appears to exist.

Table 4. Comparison of Expected Output Voltage Values to Actual Output Voltage Values for a Space Target; for Orbit 8, Stage 8 of Orbital Simulation Tests of F-2

Channel	Spacecraft Temperature		
	10°C (volts)	30°C (volts)	50°C (volts)
<u>6.7μ</u> Expected Value (Table 3)	= 5.05	= 5.17	= 5.2
Measured Value (+ Emissivity Correction)	4.8 + 0.14 = 4.94	4.95 + 0.16 = 5.11	5.1 + 0.22 = 5.32
<u>10-11μ</u> Expected Value (Table 3)	= 6.5	= 6.45	= 6.45
Measured Value (+ Emissivity Correction)	6.35 + 0.22 = 6.57	6.2 + 0.22 = 6.44	6.35 + 0.26 = 6.61
<u>5-30μ</u> Expected Value (Table 3)	= 6.4	= 6.6	= 6.7
Measured Value (+ Emissivity Correction)	6.15 + 0.22 = 6.37	6.5 + 0.18 = 6.68	6.75 + 0.22 = 6.97

Table 5. Comparison of Earth Temperature Measured by F-2 MRIR and by Thermocouples; for Orbit 8, Stage 8 of Orbital Simulation Tests

Channel	Spacecraft Temperature						
	10°C		30°C		50°C		
	MRIR	TC	MRIR	TC	MRIR	TC	
	Volts	Temp (°C)	Volts	Temp (°C)	Volts	Temp (°C)	
6.7μ	1.4	-13	1.2	-10.5	1.05	-10	-12
10-11μ	4.4	-16	4.1	-12	4.15	-13	-12
5-30μ	3.6	-14	3.75	-13	3.85	-14	-12

Section 5

HIGH-VACUUM, HIGH-TEMPERATURE, UV RADIATION TESTING
OF THE 14- TO 16-MICRON FILTER

A test sample of the 14- to 16-micron filters to be used in the F-4, F-5, and F-6 MRIR's was subjected to a high-vacuum, high-temperature, UV radiation environment for 50 hours. The filters were obtained from OCLI and the tests were conducted at Hughes Aircraft Company.

The 14- to 16-micron filter is composed of three elements: a short wavelength attenuator element on a germanium substrate and a long wavelength blocking element, Irtran 4, with an antireflection coating.

Table 6 summarizes the exposure test environment to which the filter elements were subjected. The UV radiation source was a General Electric BH-6 lamp. It was placed at a distance of 16 inches from the sample to produce a (space) solar radiation magnitude of unity in the 2000\AA to 4000\AA band.

At the completion of the tests, the samples were visually examined and found to be unchanged in appearance. In addition, no signs of material deposits on the chamber windows were observed.

The before and after transmission measurements of the filter elements are shown in Figures 56 through 58. The small differences observed are within the transmission measurement errors in this wavelength band.

Table 6. Experimental Data on Infrared Filter UV Exposure

Date	Time	Sample Temperature (°C)	Pressure (torr)	Comments
Oct 26	2:00 PM	20	5×10^{-9}	LN ₂ started
	3:00	10	2×10^{-9}	Heater started
	3:05	40	2×10^{-7}	Heater outgassing
	3:15	65	1×10^{-8}	
	3:40	60	3×10^{-9}	
	3:45	60	10^{-6}	UV started
	3:50	61	5×10^{-8}	
	4:10	69	2.5×10^{-8}	Heater reduced
	4:20	64	1.8×10^{-8}	
	5:38	62	---	UV lamp burned out
Oct 27	8:40 AM	60	4×10^{-9}	Start LN ₂ + UV
	9:00	60	2×10^{-8}	
	10:45	63	2×10^{-8}	
	11:05	67	2×10^{-8}	
	12:00	65	1.8×10^{-8}	
	3:00 PM	65	1×10^{-8}	
	11:45	65	1×10^{-8}	UV lamp burned out
Oct 28	8:45 AM	65	1.5×10^{-8}	Start LN ₂ + UV
	10:35	64	1×10^{-8}	
	11:30	64	8×10^{-9}	
	12:30	64	8×10^{-9}	
	1:15 PM	64	8×10^{-9}	
	4:05	65	8×10^{-9}	
	11:45	68	8×10^{-9}	
	12:00	67	8×10^{-9}	
Oct 29	7:00 AM	65	5×10^{-9}	
	10:00	65	4×10^{-9}	
	11:45	65	4×10^{-9}	Test ended

EUGENE DIETZGEN CO.
MADE IN U. S. A.

ND. 340P-10 DIETZGEN GRAPH PAPER
10 X 10 PER INCH

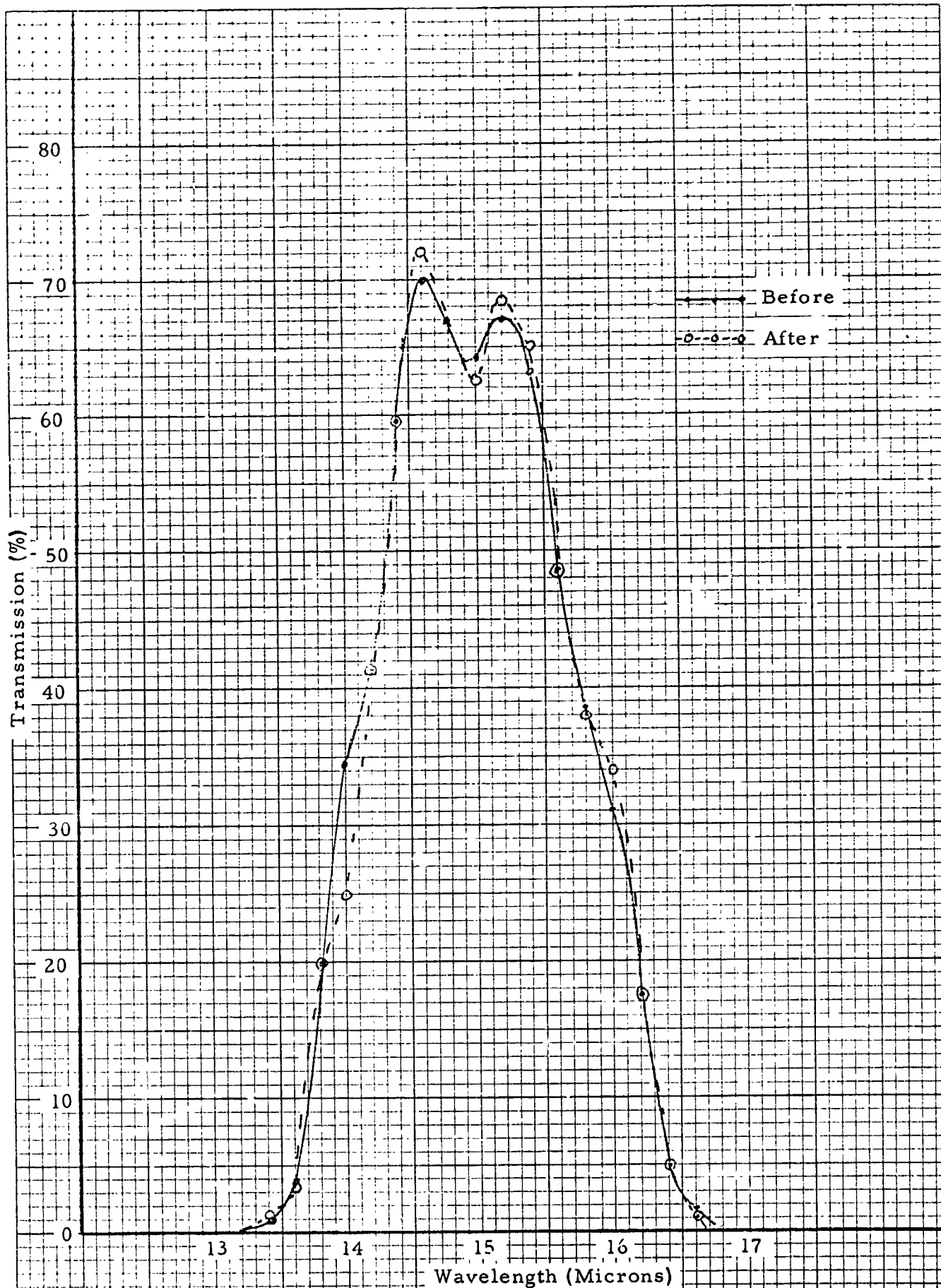


Figure 56. Transmission of Bandpass Element (14-16 μ Filter) Before and After UV Radiation Tests

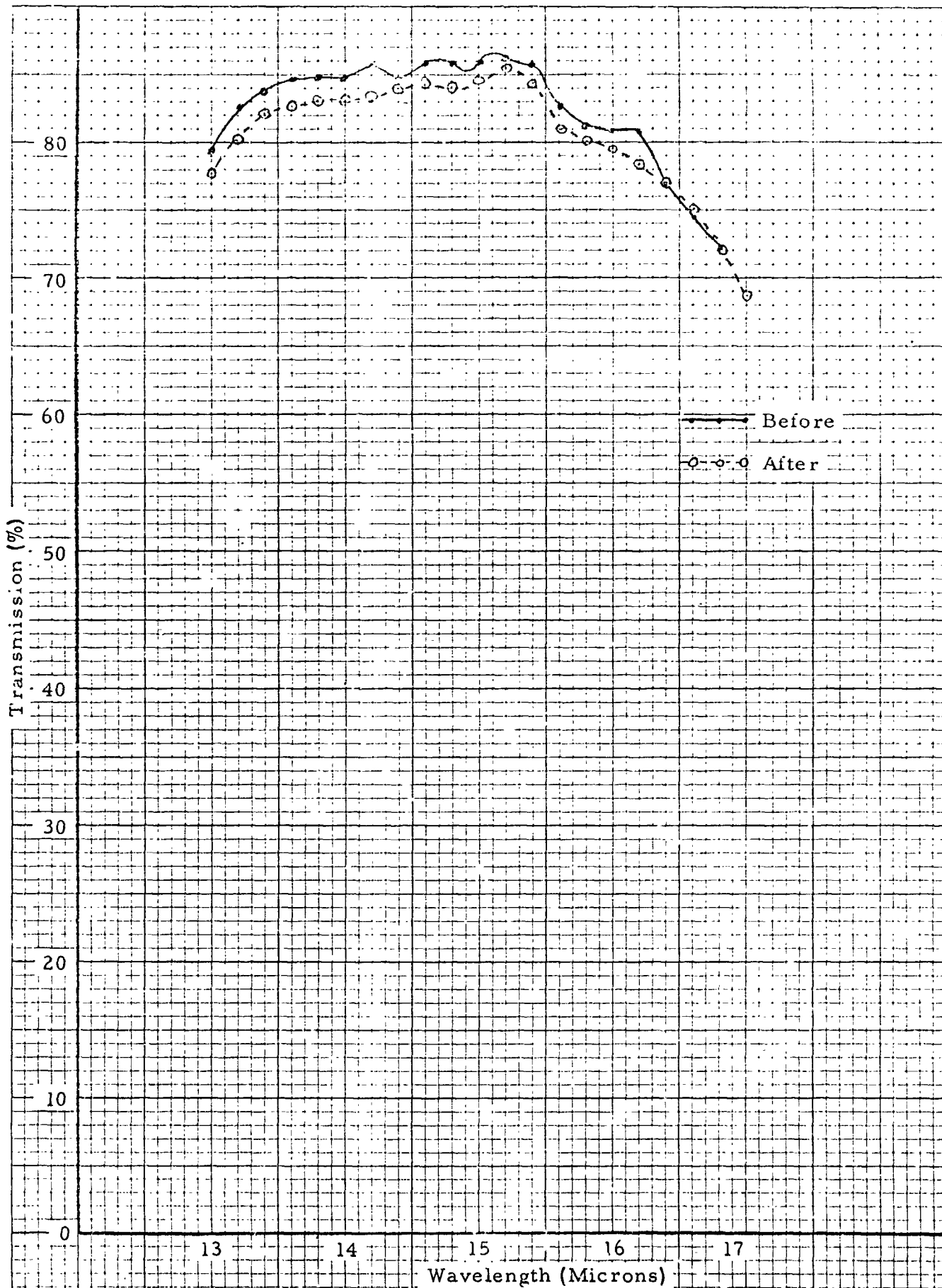


Figure 57. Transmission of Long-Wavelength Blocking Element (14-16 μ Filter) Before and After UV Radiation Tests

EUGENE DIEZELSEN CO.
MADE IN U. S. A.

NO. 543R-10 DIEZELSEN GRAPH PAPER
10 X 10 PER INCH

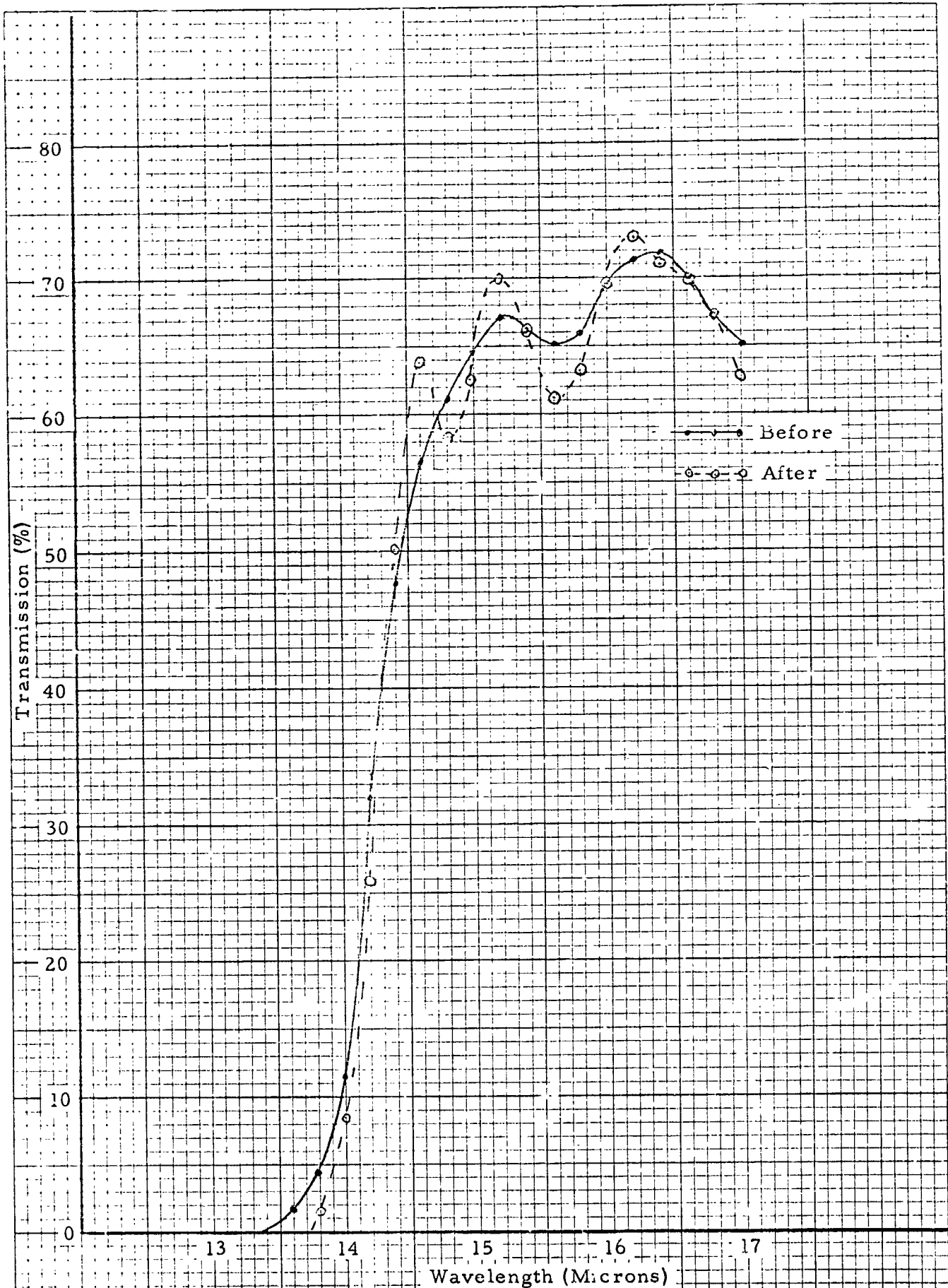


Figure 58. Transmission of Short-Wavelength Blocking Element (14-16 μ Filter) Before and After UV Radiation Tests

Section 6

F-5 MRIR CHECK-OF-CALIBRATION MEASUREMENTS
(BEFORE AND AFTER SCAN MIRROR CLEANING)

Check-of-calibration measurements were performed on the F-5 MRIR when the radiometer was returned to SBRC for scan mirror cleaning.

The MRIR scan mirror was found to be covered with what appeared to be a heavy coating of grease after it had been removed from the orbital simulation chamber at NASA. The coating was believed to have been caused by contaminants outgassing from the orbital simulation chamber walls and targets and redepositing on the scan mirror.

Check-of-calibration measurements were made both before and after the scan mirror was cleaned to determine the magnitude of error that was introduced into the MRIR calibration curves due to the mirror contamination.

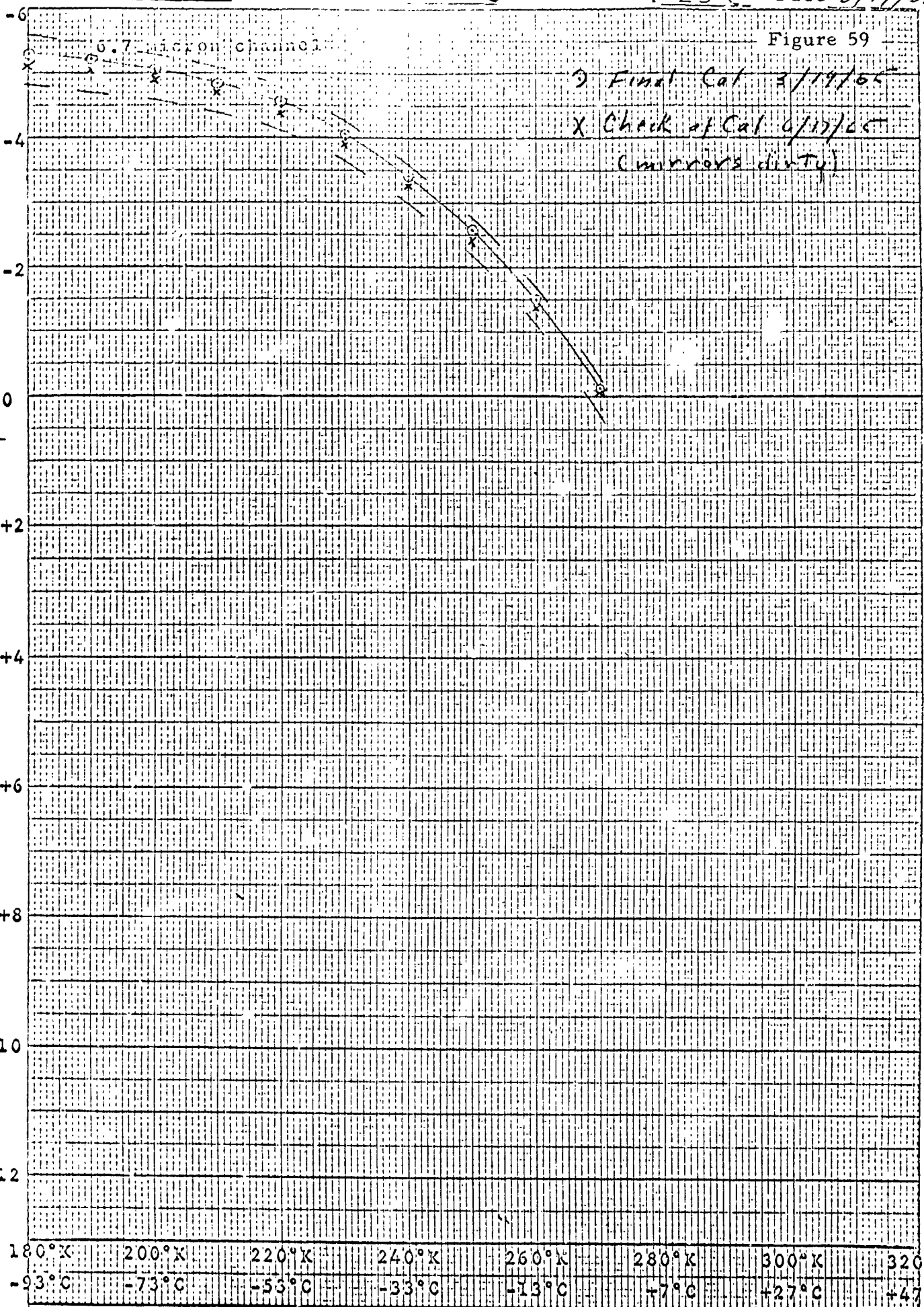
The data obtained from these measurements are plotted in Figures 59 through 65. It can be seen from these figures that the contaminated mirror had very little effect on the calibration of the MRIR thermal channels while calibration of the 0.2- to 4.0-micron channel changed approximately 17 percent.

System # F-5 Scanner Temp 25°C Module Temp 25°C Date 3/14/65

MRIR

0)

Figure 59



MADE IN U.S.A.

DR-2 1761 20 X 20 PER INCH

MRIR Channel output (Volts dc)

Target Temperature

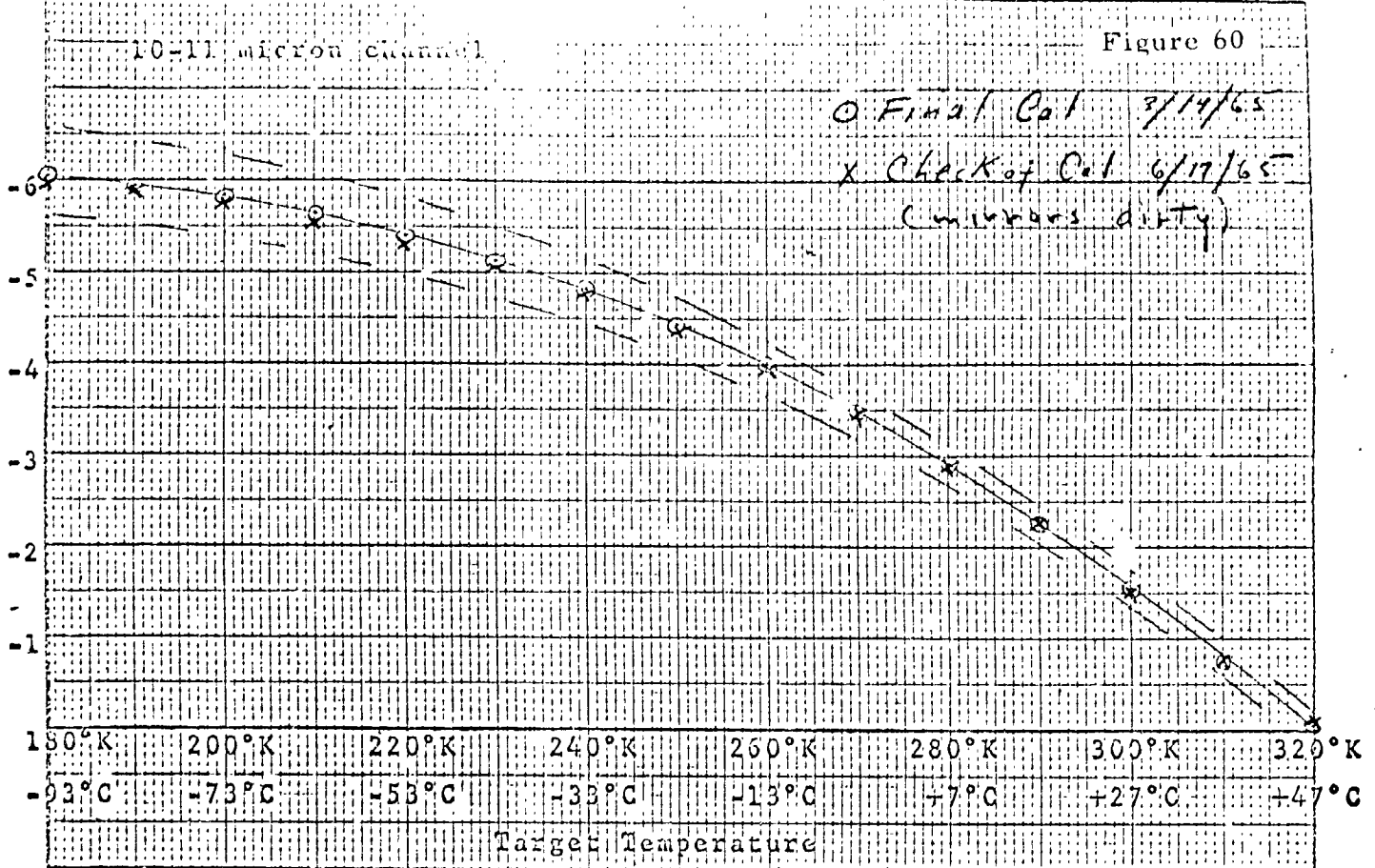
System # F-5 Module Temp 25°C Date 3/19/65

10-11 micron channel

Figure 60

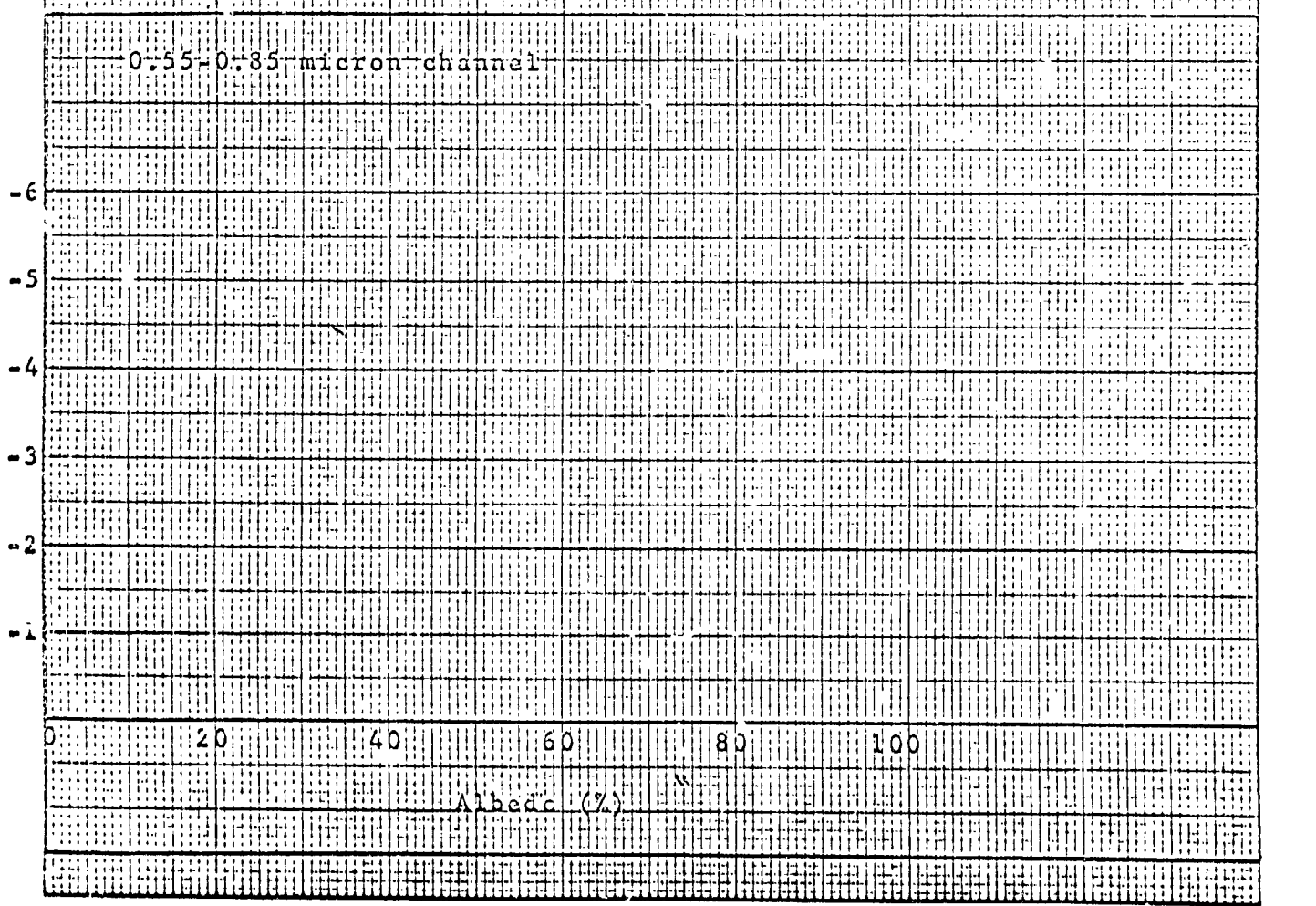
O Final Cal 3/14/65
X Check of Cal 6/17/65
(mirrors dirty)

MRIR Channel Output (Volts dc)



0.55-0.85 micron channel

MRIR Channel Output (- Volts dc)



EGGNE DIVISION CO. MADE IN U.S.A.

MR-20 20 X 20 PER INCH

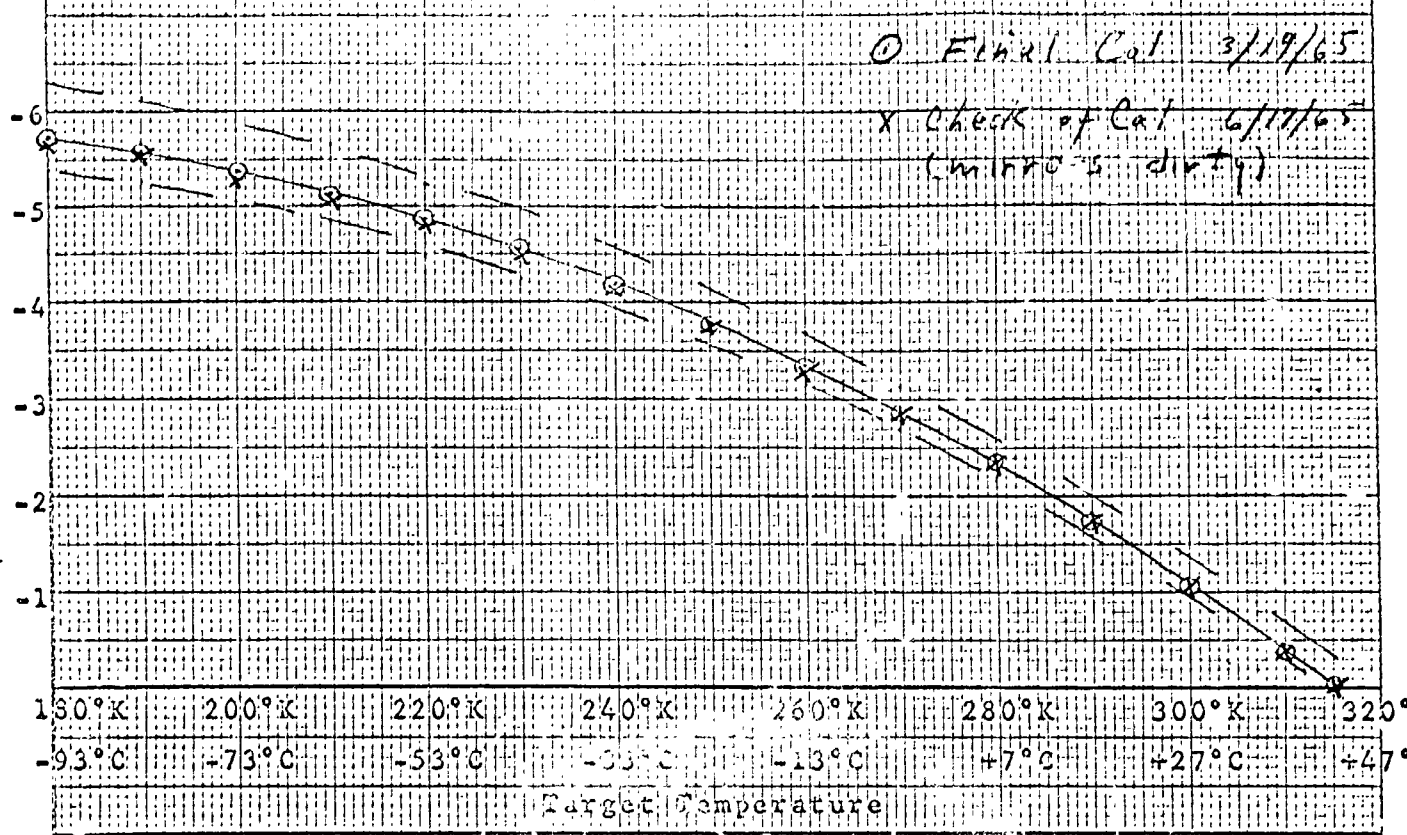
System # F-5 Scanner 12 Module Temp 25°C Date 3/19/65

5-30 micron channel

Figure 61

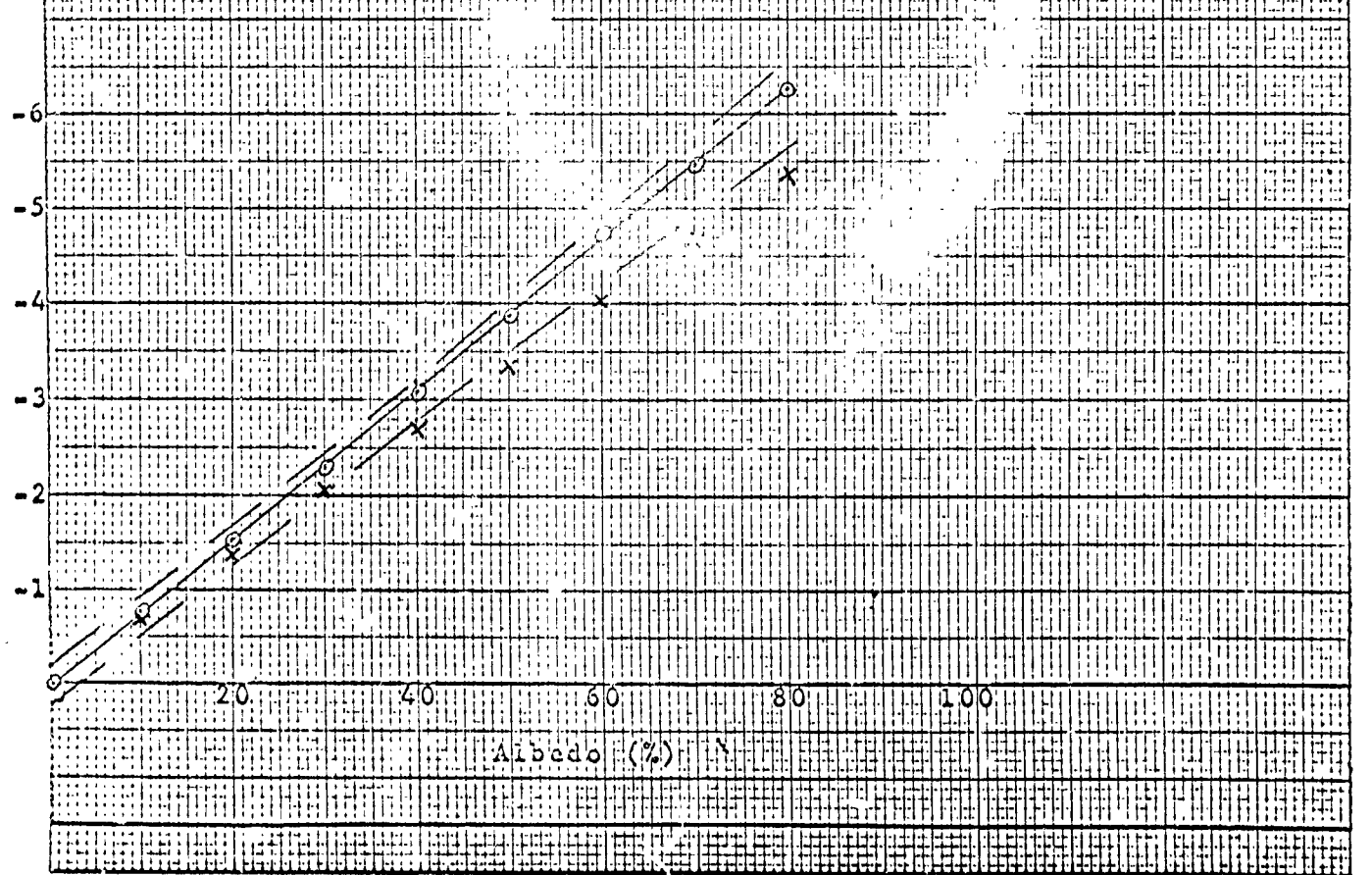
O Final Cal 3/19/65
X Check of Cal 6/11/65
(mirrors dirty)

MRIR Channel Output (Volts dc)



0.2-4 micron channel

MRIR Channel Output (Volts dc)



EUGENE DIETZGEN CO.
MADE IN U. S. A.

NO. 340P-20 DIETZGEN GRAPH PAPER
20 X 20 PER INCH

MRIR Calibration Curves (D)

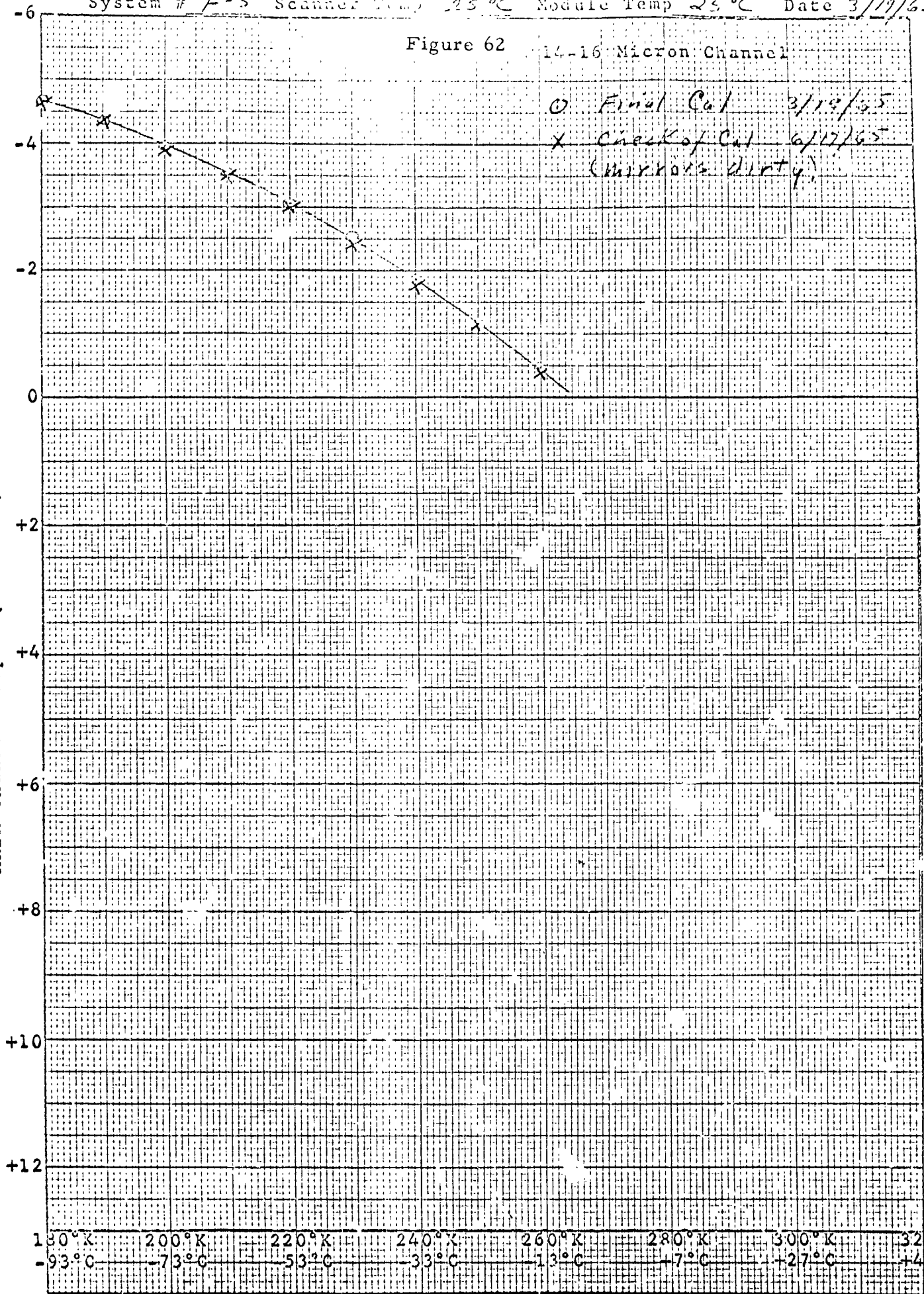
(2)

System # F-5 Scanner Temp 25°C Module Temp 25°C Date 3/19/65

Figure 62 14-16 Micron Channel

O Final Cal 3/19/65
X Check of Cal 6/17/65
(mirrors dirty)

MRIR Channel Output (Volts dc)



PERMITS REGENERATION MADE IN U. S. A.

GRAPH PAPER 20 X 20 PER INCH

Target Temperature

MRIR Calibration Curves (U)

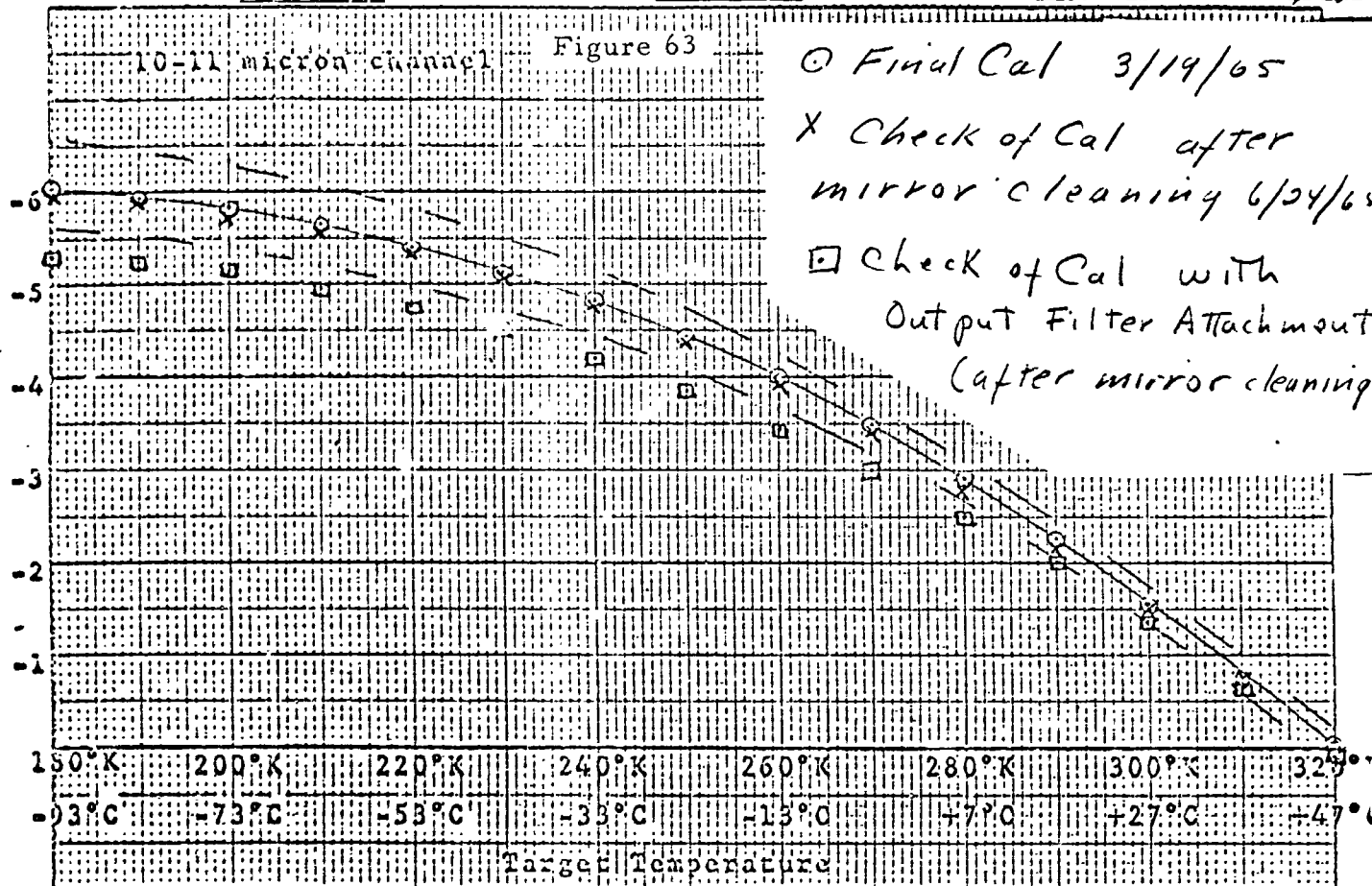
(29)

System # F-5 Scanner Temp 25°C Module Temp 25°C Date 3/19/65

10-11 micron channel Figure 63

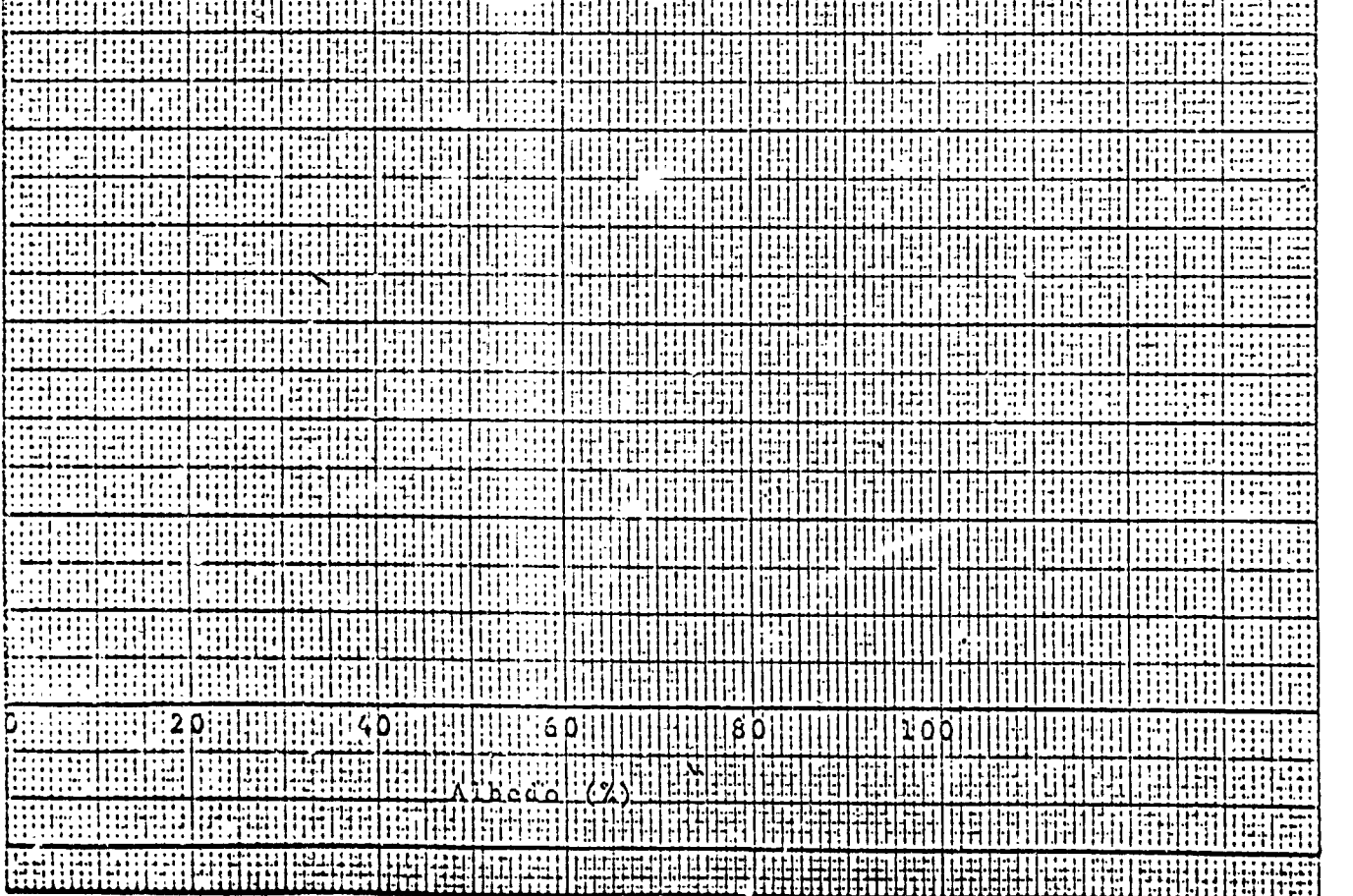
○ Final Cal 3/19/65
 X Check of Cal after mirror cleaning 6/24/65
 □ Check of Cal with Output Filter Attachment (after mirror cleaning)

MRIR Channel Output (Volts dc)



0.55-0.85 micron channel

MRIR Channel Output (- Volts dc)

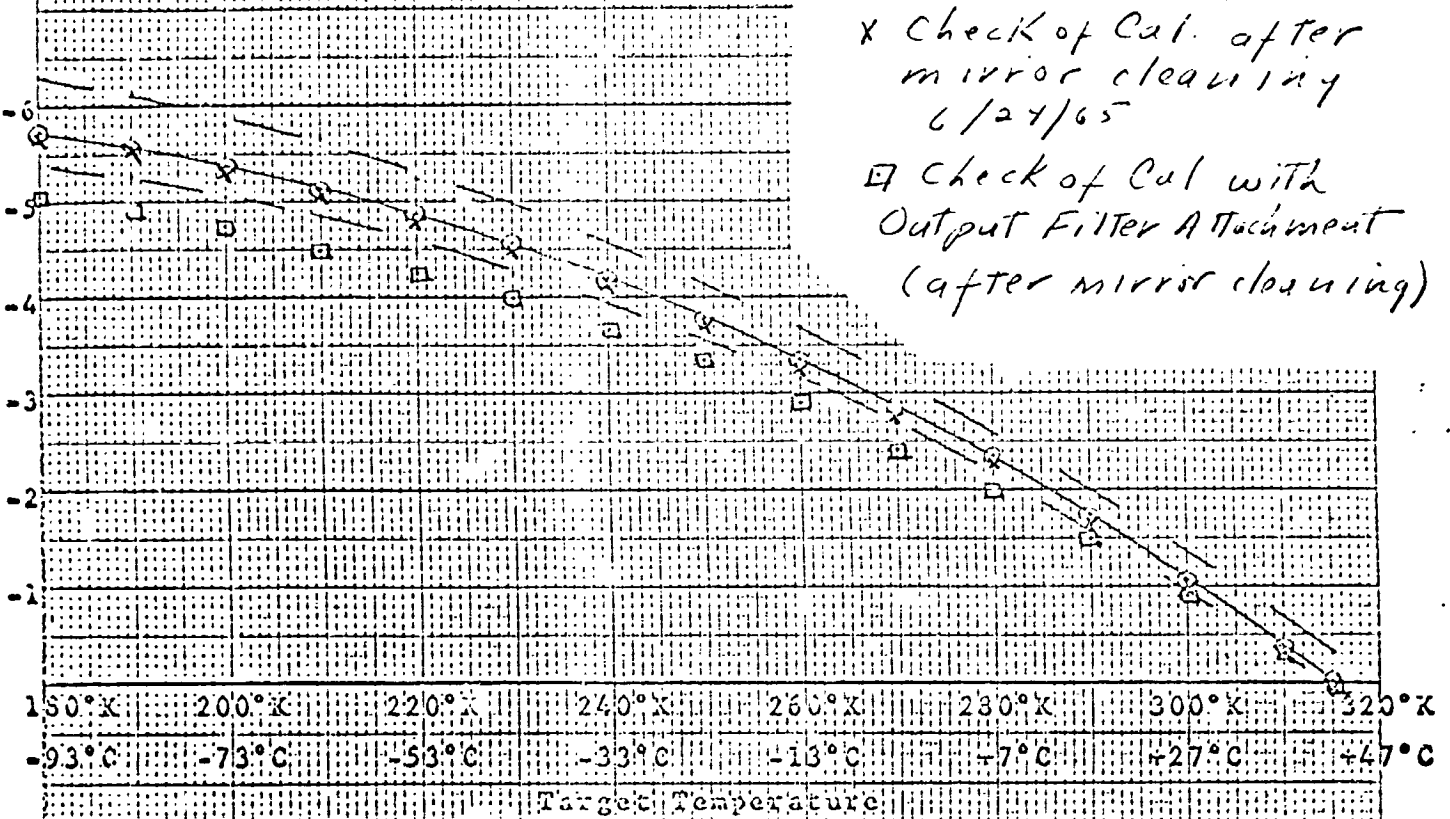


System # E-5 Scanner Temp 25°C Module Temp 25°C Date 3/19/65

5-30 micron channel Figure 64

- Final Cal. 3/19/65
- × Check of Cal. after mirror cleaning 6/24/65
- Check of Cal. with Output Filter Attachment (after mirror cleaning)

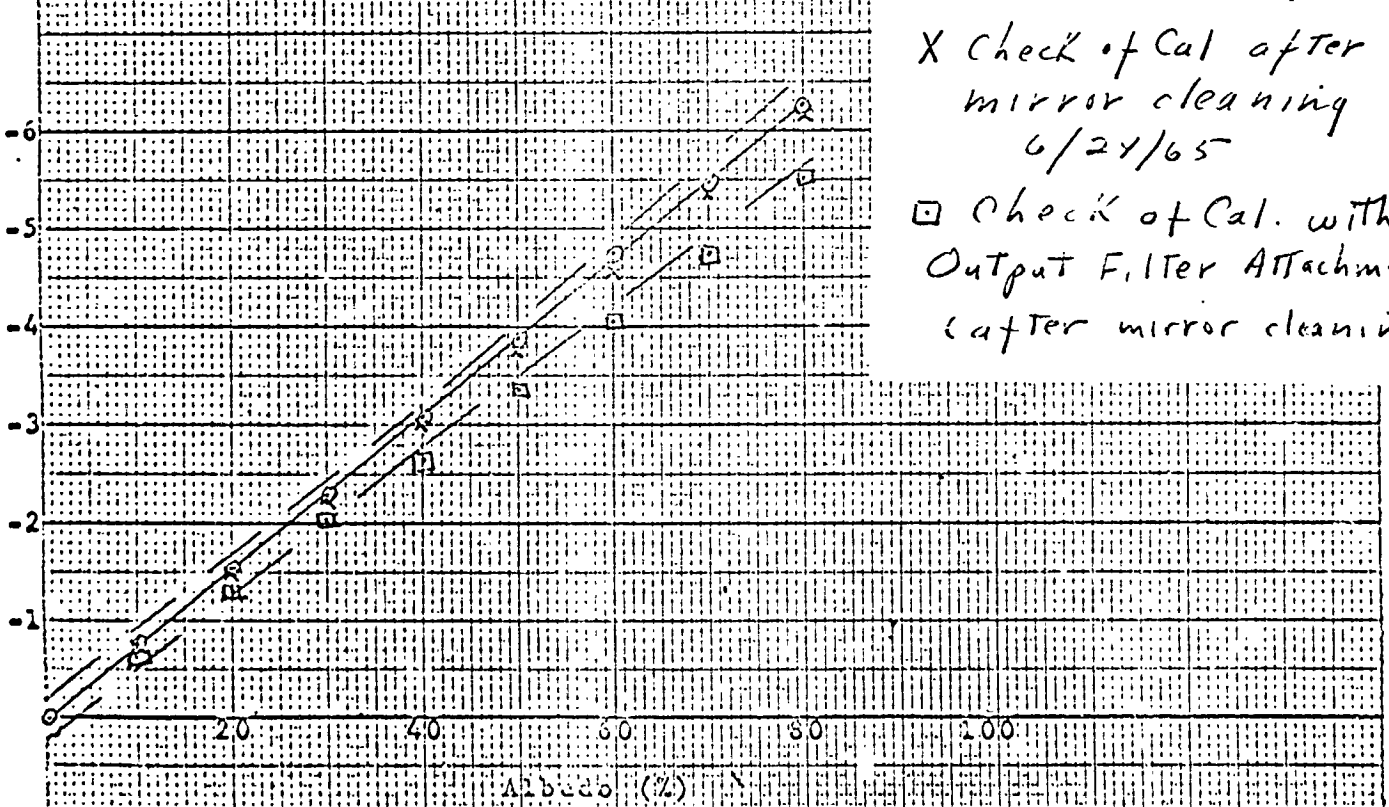
MRIR Channel Output (Volts dc)



0.2-4 micron channel

- Final Cal. 3/19/65
- × Check of Cal. after mirror cleaning 6/24/65
- Check of Cal. with Output Filter Attachment (after mirror cleaning)

MRIR Channel Output (Volts dc)



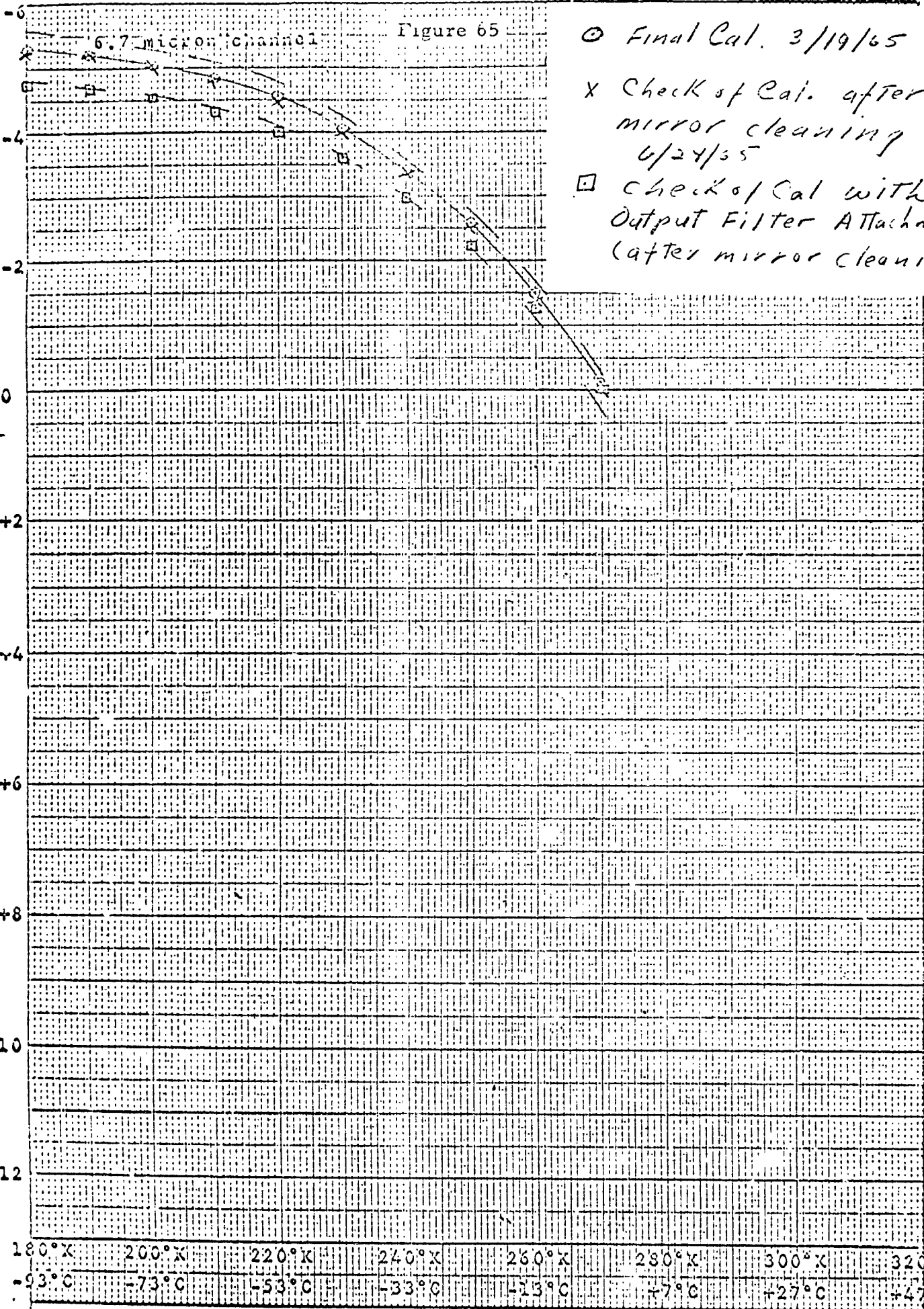
MRIR Calibration Curves (D)

System # F-5 Scanner Temp 25°C Module Temp 25°C Date 3/19/65

EUGENE DIETZEN CO.
PASADENA, CALIF. U.S.A.

NO. J300-20 DIETZEN GRAPH PAPER
2 1/2" x 3 1/2" 1000 VOLT PER INCH

MRIR Channel Output (Volts dc)



- Final Cal. 3/19/65
- x Check of Cal. after mirror cleaning 6/24/65
- Check of Cal. with Output Filter Attachment (after mirror cleaning)

Target Temperature

Section 7
FAILURE REPORTING

During this reporting period four system failures were reported. A summary of these failures is presented in Table 7.

Table 7. Failure Report Summary

Date	Failure Report Number	System	Failure	Fix	Action
12/11/64	50336	F-5	<ol style="list-style-type: none"> 1. Audible noise in chopper shaft bearings increased after vibration. 2. Short in 14- to 16-micron channel offset shift generator developed after vibration. This was traced to marginal clearance associated with additional 14- to 16-micron circuitry incorporated in electronics module. 	<ol style="list-style-type: none"> 1. Replace bearings. 2. Provide additional clearance for 14- to 16-micron channel circuitry and revibrate radiometer. 	<ol style="list-style-type: none"> 1. None. 2. Rework all electronics modules having 14- to 16-micron channel to provide necessary additional clearance.
2/4/65	50140	F-5	10- to 11-micron channel bolometer became excessively noisy during final calibration of radiometer.	Replace bolometer.	None.
3/1/65	50341	F-5	<p>Excessive drag in chopper assembly traced to contaminated chopper shaft bearings. Marginal operation experienced at low radiometer temperatures and low power input voltage.</p>	<p>Replace bearing. Replace chopper motor Zener diode with lower value diode to increase chopper motor output torque. Revibrate radiometer.</p>	None.